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AVAILABILITY STUDY OF THE AN/WLR-16 AND AN/SLQ-32(V)2 ELECTRONIC--ETC(U)  
FEB 79 J VALENZUELA, W EICHELBERGER

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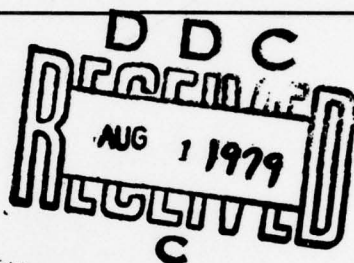
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Technical Report 426

### AVAILABILITY STUDY OF THE AN/WLR-1G AND AN/SLQ-32(V)2 ELECTRONIC SUPPORT MEASURE (ESM) SYSTEMS CDRL A001

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## EXECUTIVE SUMMARY

### Objective

The objective of this study was to analyze the AN/WLR-1G and the AN/SLQ-32(V)2 ESM systems reliability and maintainability characteristics in order to determine their inherent and operational availability and their associated design and logistic support constraints. This report highlights the strengths and weaknesses in the availability of these two systems. From this study it is hoped to establish requirements from which to build the specifications of a third generation ESM system and to foster improvements where appropriate to existing hardware.

### Methodology

Operational and support requirements of the AN/WLR-1G, ESM system were reviewed. The reliability and maintainability of the AN/WLR-1G was then evaluated using both 3-M field data and MIL-HDBK 217B Prediction Techniques. The resulting Mean-Time-Between-Failure (MTBF), Mean-Time-to-Repair (MTTR) and Mean-Down-Time (MDT) numbers were used to calculate inherent and operational availability for the system. The AN/SLQ-32(V)2 was evaluated in the same manner.

### Findings

Tables A-1, A-2a and A-2b provide the Reliability, Maintainability and Availability (RMA) data for the AN/WLR-1G and the AN/SLQ-32(V)2. Table A-2a provides a summary of predictions developed for the suite 2 of the AN/SLQ-32(V). Table A-2b is a summary of data gathered for the ESM portion of the Prototype and equivalent to suite 2 of the production configuration.

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Availability Codes	<input type="checkbox"/>
Avail and/or	<input type="checkbox"/>
special	<input type="checkbox"/>

TABLE A-1

RMA RESULTS FOR THE AN/WLR-1G

MTBF (MIL-HDBK 217B Prediction)	106 hours
MTTR (MIL-HDBK 472 Procedure 2 Prediction)	3.35 hours
MDT (3-M Field Data)	72 hours
Inherent Availability	0.97
Operational (Actual Field) Availability	0.58

Inherent availability ( $\frac{MTBF}{MTBF + MTTR}$ ) provides a measure of the system design constraints. The operational availability ( $\frac{MTBF}{MTBF + MDT}$ ) provides a measure of the available logistics support. The constituent elements of MDT with their respective percent distributions are discussed in section 3.4.1 and are shown below:

<u>Item</u>	<u>Hours</u>	<u>Percent</u>
Repair Time/yr.	171.0	4.7
Logistics Delay Time/yr.	3261.2	90.1
Administrative Time/yr.	51.0	1.4
PMS Time/yr.	<u>137.8</u>	<u>3.8</u>
Total Down Time/yr.	3621.0	100.0

TABLE A-2a

RMA RESULTS FOR THE AN/SLQ-32(V)2

MTBF (MIL-HDBK 217B Prediction)	259 hours
MTTR (MIL-HDBK 472 Procedure 2 Prediction)	1.045 hours
Inherent Availability	0.99
Operational (Projected Field) Availability	See Note 1

1/ This value is discussed and presented in section 4.3.3 in the report.

TABLE A-2b

AN/SLQ-32(V) PROTOTYPE TECHEVAL DATA SUMMARY

ESM Operating Hours	1034 hours
ESM Total Maintenance Actions	8
ESM Maintenance Actions considered major failures	2
ESM Maintenance Actions considered minor failures . . . . .	3 . . . . .
ESM Maintenance Actions considered preventive maint.	3
ESM Total Major Failure <sup>2/</sup> corrective maintenance time	3.96 hours
ESM Total Minor Failure <sup>3/</sup> corrective maintenance time	5.2 hours
ESM Total Preventive maintenance time	.76 hours
*Observed ESM MTBF	517 hours
*Observed ESM Mean corrective maintenance time	1.98 hours
*Observed ESM inherent availability	0.996

Conclusions

Key failures which impact both MTBF and MTTR of the AN/WLR-1G are as follows:

1. One half of repair actions (22 out of 44) over a 30 month period were associated with the IP-480 display. These took 7.1 hours on an average to repair, or 156.2 hours (Table 3-3).
2. Converter CV-742 is the unit showing the longest repair time: The resultant MTTR was 16.4 hours. Three repair actions were involved causing a 49.2 hour experience (Table 3-3).
3. Tubes accounted for 50% of system failures; variable resistors (RV) accounted for 24% of system failures (68 of the 104 variable resistors are in the IP-480).

Further studies which included the AN/SLQ-32(V)2 system provided additional insight into the availability goals for future ESM systems. Inherent availability goals are

<sup>2/</sup> Major Failure - ESM mission accomplishment prevented  
<sup>3/</sup> Minor Failure - ESM mission accomplishment degraded  
 \* Based on 2 major failures



tabulated below along with indications of the difficulty for attainment:

ESM RMA GOALS

<u>MTBF</u> <u>(hours)</u>	<u>MTTR</u> <u>(hours)</u>	<u>A</u>	<u>LIKELIHOOD OF</u> <u>ACHIEVEMENT</u>
250	1.0	0.996	Modestly Difficult
250	0.5	0.998	Difficult
500	1.0	0.998	Difficult
500	0.5	0.999	Very Difficult

Design efforts to obtain these goals must consider the following:

1. Use of self-test features.
2. Use of standard components based on a low failure rate technology.
3. Implementation of redundancy -
  - a. Adoption of techniques (for example: antennas) wherein performance "gracefully" degrades with component failure.
  - b. Separation of performance functions into several modes of operation wherein failure of one mode would still permit mission success in some acceptable degraded capability.
4. Quality Assurance and Quality Control during the procurement and development stages.
5. Mechanical design to facilitate access and to minimize environmental effects.

Recommendations

The following studies are proposed based upon conditions discovered during this availability study of the AN/WLR-1G and the AN/SLQ(V)2 ESM systems:

1. Study of CASREPS to determine if supply line constraints are causing unnecessary down time.
2. Study of the CV-3599 replacement for the CV-741 and CV-742 to determine its effect on AN/WLR-1G MTBF.
3. Study of the feasibility of replacing the IP-480 and Power Supplies (PP 2156D and PP 2157D).

4. Study of the AS-899 Antenna drive train mechanization to determine what may be causing coupling failures.
5. Study of the CV-1162A Tuner regulator to determine what may be causing abnormal high failure rate.

The studies are proposed in the order of priority. This order of studies is recommended as the most effective relative to design and development of ESM. However, it has been indicated that data may be currently available that would minimize the extent of studies 2 and 3.

JL/es

## TABLE OF CONTENTS

<u>SECTION</u>	<u>TITLE</u>	<u>PAGE</u>
1.0	Introduction	1
2.0	Scope	1
3.0	Study of the AN/WLR-1G	1
3.1	AN/WLR-1G System Description	2
3.1.1	Operation Requirements	2
3.2	Reliability Assessment	4
3.2.1	Failure Assessment From 3-M Field Data	4
3.2.2	Failure Assessment by MIL Handbook Prediction	6
3.2.3	Reliability Block Diagrams with Failure Assessments	6
3.3	Maintainability Assessment of the AN/WLR-1G	14
3.3.1	System Construction	14
3.3.2	Repair-Time and Delay Time From 3-M Field Data	14
3.3.3	Repair-Time Evaluation by MIL-Handbook Prediction	18
3.4	Availability Indices for the AN/WLR-1G	21
3.4.1	Discussion of AN/WLR-1G Results	26
3.5	High Failure Components in the AN/WLR-1G	27
4.0	Study of the AN/SLQ-32(V)2	30
4.1	System Description	30
4.1.1	Operational Requirements	33
4.2	Reliability Assessment	34
4.2.1	Failure Assessment From Field Data	34
4.2.2	Failure Assessment by MIL-Handbook Prediction	36
4.2.3	Highest Contributors to SLQ-32(V)2 Failure Rate	46
4.3	Maintainability Assessment of the AN/SLQ-32(V)2	47
4.3.1	Repair Time Evaluation From Field Data	48
4.3.2	Repair Time Evaluation by MIL-Handbook Prediction	52
4.3.3	Estimated Down Time	52
4.4	Availability of the AN/SLQ-32(V)2	52
4.4.1	Discussion of Availability Results	54
5.0	Results and Conclusions	61
5.1	Limitations to Availability of the AN/WLR-1G and AN/SLQ-32(V)2	61



<u>SECTION</u>	<u>TITLE</u>	<u>PAGE</u>
5.2	Availability Guidelines for Future ESM	64
5.3	Recommendations	66
	Glossary of Abbreviations	67
	References	68

<u>FIGURE</u>	<u>TITLE</u>	<u>PAGE</u>
3-1	AN/WLR-1G System Components	3
3-2	AN/WLR-1G Functional Block Diagram - Band 9 Tuning	9
3-3	AN/WLR-1G Reliability Block Diagram - DF Function, Band 9	10
3-4	AN/WLR-1G Reliability Block Diagram - Acquisition Mode, Band 9	11
3-5	AN/WLR-1G Reliability Block Diagram Analysis Mode	12
3-6	AN/WLR-1G Reliability Block Diagram - Band 9, Combined Modes	13
3-7	Repair Incidents vs. Man Hours	19
4-1	Function Block Diagram of SLQ-32(V)2	31
4-2	ESM Functional Operation	32
4-3	AN/SLQ-32(V)2 DF Mode	42
4-4	AN/SLQ-32(V)2 Frequency Measurement (Acquisition) Mode	43
4-5	AN/SLQ-32(V)2 Band 1 Reception Mode	44
4-6	AN/Reliability Block Diagram SLQ-32(V)2 Combined Modes	45

<u>TABLE</u>	<u>TITLE</u>	<u>PAGE</u>
3-1	3-M Failure Data Summary - AN/WLR-1G	5
3-2	AN/WLR-1G System Reliability Prediction Summary	8
3-3	AN/WLR-1G Unit Level Repair-Time	15
3-4	IP-480 Assembly Level Repair-Times	16
3-5	Estimated Delay Times for AN/WLR-1G	18
3-6	MTTR Summary for WLR-1G	20
3-7	AN/WLR-1G DF Mode Availability	22
3-8	AN/WLR-1G Acquisition Mode Availability	23
3-9	AN/WLR-1G Analysis Mode Availability	24
3-10	AN/WLR-1G Combined Mode Availability	25
3-11	AN/WLR-1G Field Data vs. Predicted Failure Rate	28

<u>TABLE</u>	<u>TITLE</u>	<u>PAGE</u>
4-1	AN/SLQ-32(V) Prototype Techeval Data Summary	35
4-2	Reliability Block and Failure Identification Summary	37
4-3	AN/SLQ-32(V) 2 Graceful Degradation Functions	41
4-4	AN/SLQ-32(V) 2 System Construction	49
4-5	AN/SLQ-32(V) Techeval Observed Repair Time	50
4-6	AN/SLQ-32(V) Maintainability Demonstration Data	51
4-7	AN/SLQ-32(V) 2 Prediction Repair-Times	53
4-8	AN/SLQ-32(V) 2 of Mode Availability	55
4-9	AN/SLQ-32(V) 2 Frequency Measurement (Acquisition) Mode Availability	56
4-10	AN/SLQ-32(V) 2 Band 1 Reception Mode Availability	57
4-11	AN/SLQ-32(V) 2 System Mode Availability	58
5-1	Probable Achievable Ultimate ESM Availabilities	65

<u>APPENDIX</u>	<u>TITLE</u>	
A	3-M Field Data Work Sheets	*
B	AN/WLR-1G Reliability Prediction Worksheets	*
C	AN/WLR-1G Maintainability Prediction Worksheets	*
D	Availability Math Models	*

## 1.0 INTRODUCTION

This report has been prepared specifically to analyze the AN/WLR-1G and the AN/SLQ-32(V)2 reliability and maintainability characteristics in order to determine their availability indices along with the associated design and logistic support constraints. By highlighting strong points and weak points in the availability of these two systems it is hoped to establish the requirements from which to build the specifications of a third generation ESM and to foster improvements where appropriate to existing hardware.

## 2.0 SCOPE

The studies performed in this report were limited to suite 2 of the AN/SLQ-32(V)2 and band 9 operation for the AN/WLR-1G. Specific areas addressed were:

- 1) Support requirements (Maintenance requirements)
- 2) Operational Requirements
- 3) Electrical Design Constraints - functional redundancy
- 4) Mechanical Design Constraints - maintainability and degree of modularity
- 5) Fault isolation effectiveness
- 6) Equipment environmental exposure

The study was based on review of operating and support requirements specified in the applicable Technical Manuals, 3-M data on the WLR-1G and technical data gathered on the USS Leahy for the SLQ-32(V) XN-1 prototype model.

## 3.0 STUDY OF THE AN/WLR-1G

For the purposes of this study only Band 9 operation of the AN/WLR-1G was considered. Both reliability and maintainability evaluations were made on Band 9 from which both inherent and operational availabilities were computed for its various operational modes.



### 3.1 AN/WLR-1G SYSTEM DESCRIPTION

The AN/WLR-1G receiving set is comprised of a number of units which contain RF tuners, frequency converters, RF switches, power supplies and a pulse analyzer. When coupled with the AS-899/ SLR and other antennas, the AM-1017B Magnetic Control Amplifier, the C-3118 Control Indicator and the AN/WLA-3B Amplifier, a complete ESM receiver system is formed. This is the surveillance system currently being used in the fleet.

The AN/WLR-1G equipment is physically split into three locations when installed aboard ships. The tuners, power supplies and RF switches are, in most ships, installed in an ESM equipment room. The antennas are mast mounted, either forward or aft, depending on the ship's configuration. The frequency converters, pulse analyzers and various control units are located in the operators' area in the CIC. Figure 3-1 presents a pictorial representation of the system components.

#### 3.1.1 OPERATIONAL REQUIREMENTS

Normal Operation of the AN/WLR-1G is through direct control of the equipment by the operator. A minimum of 2 people are required to stand watch on this equipment and four hours is the maximum time an operator would normally be required to stand watch before being relieved. For extended operational periods, 4 or more persons may be required to man the AN/WLR-1G for a given ESM surveillance function.

Initially, the operator sets the equipment for an acquisition function of operation and begins to look for an indication of a signal (or signals) on the display. Upon detecting a signal the operator sets the equipment for the analysis function and determines signal bearing and signal characteristics via the display.

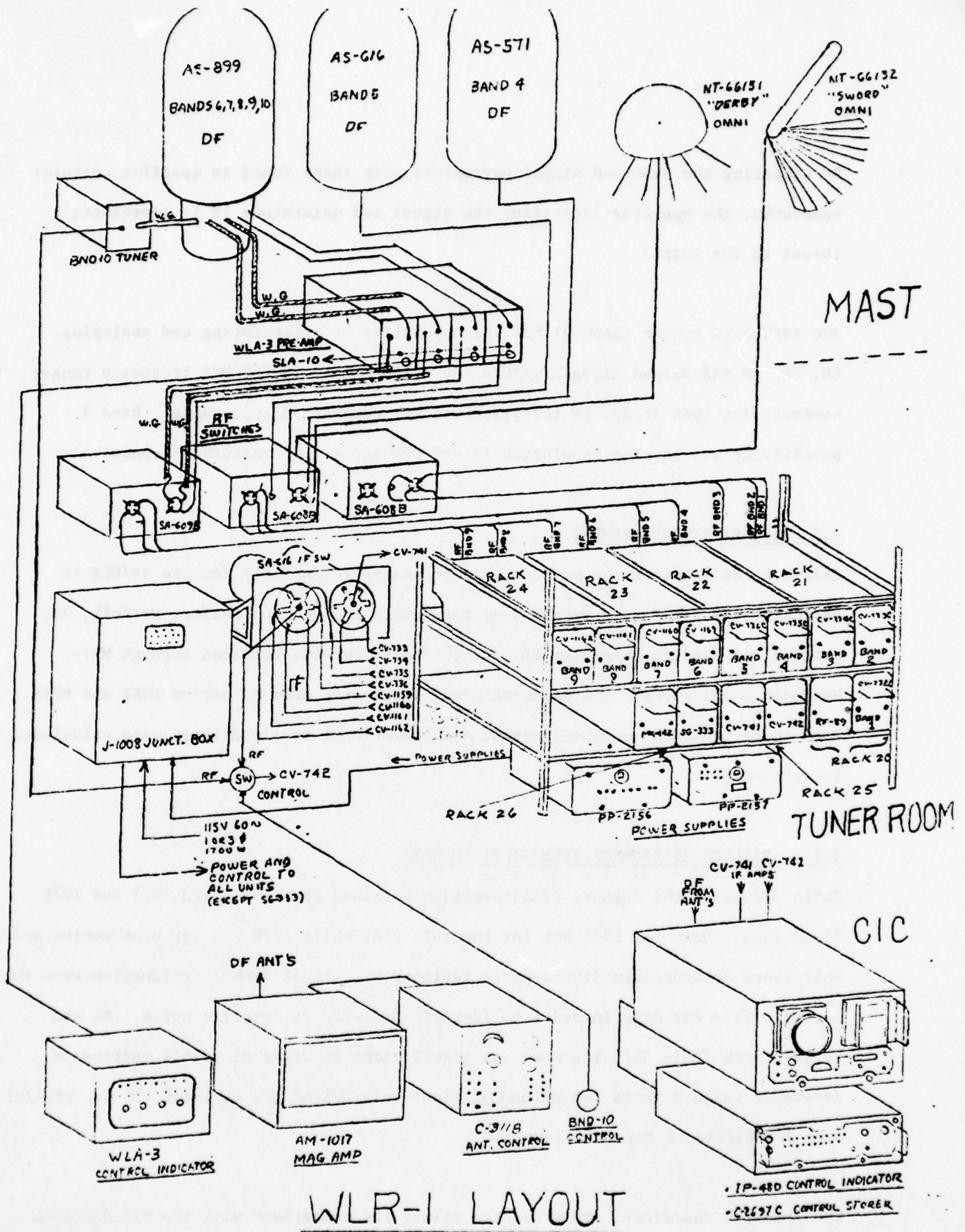


FIGURE 3-1 WLR-1G SYSTEM COMPONENTS

By comparing the observed signal parameters with those found in specific operator handbooks, the operator identifies the signal and determines if it represents a threat to the ship.

The AN/WLR-1G system (Band 9) has the capability of intercepting and analyzing CW, FM, AM and pulsed signals within the 7,300 MHZ to 10,750 MHZ frequency range; however, for this study, FM reception was not considered applicable. Band 9 sensitivity and bearing resolution is -80 DBM and  $\pm 2.5^\circ$  azimuth, respectively.

### 3.2 RELIABILITY ASSESSMENT

This section examines the methods used to assess reliability for the AN/WLR-1G. Basically, 3M field data supplied by Naval Ship Engineering Center, Norfolk, was studied and used to determine MDT and to verify results obtained through Mil-Handbook predictions. Mil-handbook predictions were used to derive MTBF and MTTR. From these combined results inherent and operational availabilities were calculated in section 3.4.

#### 3.2.1 FAILURE ASSESSMENT FROM 3-M FIELD DATA

Table 3-1 gives the summary of information obtained from analyzing 1975 and 1976 field data. Data for 1975 was for the full year while 1976 was for nine months only. Only those actions identifying parts replaced by circuit symbol designation were tabulated. This was done in order to identify failures to specific units. As can be seen from Table 3-1, there was an insufficient quantity of usable entries to determine failure rates for all units since only 20% of the listings (98 out of 470) were identified to the unit level.

The results, therefore, are presented mainly for comparison with the Mil-Handbook predictions of Table 3-2. Appendix A provides a listing of the 3-M data which was used.



TABLE 3-1

3-M FAILURE DATA SUMMARY - AN/WLR-1G

<u>UNIT</u>	<u>DESCRIPTION</u>	<u>1975 FAILURES</u>	<u>1976 FAILURES</u>	<u>TOTAL FAILURES</u>	<u>PERCENT OF TOTAL FAILURES</u>
* CV-732D	Band 1 Tuner	1	4	5	5.10
* CV-733D	Band 2 Tuner			2	2.04
* CV-734D	Band 3 Tuner	4	1	5	5.10
* CV-735D	Band 4 Tuner	2	0	2	2.04
* CV-736D	Band 5 Tuner	1	1	2	2.04
*CV-1159A	Band 6 Tuner	4	0	4	4.08
*CV-1160A	Band 7 Tuner	3	3	6	6.12
*CV-1161A	Band 8 Tuner	0	2	2	2.04
CV-1162A	Band 9 Tuner	1	5	6	6.12
CV-741D	Freq. converter	6	3	9	9.18
CV-742D	Freq. converter	5	1	6	6.12
IP-480	Pulse Analyzer	13	11	24	24.49
C-2697G	Control Storer	2	4	6	6.12
RF-89D	Freq. Discriminator		No Data		
PP-2156D	Power Supply	0	3	3	3.06
PP-2157D	Power Supply	6	2	8	8.16
J-1008C	Interconnect Box	1	1	2	2.04
SA-608C	Antenna Switch		No Data		
SG-333D	Pulse Test Equip.	0	3	3	3.06
SA-609C	Antenna Switch		No Data		
SA-616B	R.F. Switch	2	0	2	2.04
SA-608C	Antenna Switch	<u>0</u>	<u>2</u>	<u>2</u>	<u>2.04</u>
		50	48	98	100%

\*Results were not included in band 9 study

### 3.2.2 FAILURE ASSESSMENT BY MIL HANDBOOK PREDICTION

A reliability prediction was performed according to the procedures of MIL-HDBK-217B. The generic method of Section 3 in 217B was used on the AN/WLR-1G to obtain a preliminary estimate for this study. Mechanical part failure rates were assigned from data found in the RAC document "Nonelectronic Parts Reliability Data" and the "Mechanical Design and Systems Handbook".\* Appendix B lists the generic failure data for all electronic and dynamic mechanical parts by units for the AN/WLR-1G and for peripheral equipment. Table 3-2 shows a summary of the total failure rate and MTBF by unit and peripheral equipment designation. These data were used in the availability indices derived in section 3.4.

### 3.2.3 RELIABILITY BLOCK DIAGRAMS WITH FAILURE ASSESSMENTS

Reliability block diagrams were developed for the three functional modes (DF, acquisition and analysis for band 9 operation) from the functional block diagram in figure 3-2. The reliability block diagrams indicate what is contained in each block and whether equipment operation is in a series or parallel (redundant) function. Figure 3-6 shows the overall combined operation reliability block diagram. Figures 3-3, 3-4 and 3-5 provide the apportioned failure rate reliability block diagrams for the DF mode, acquisition mode and analysis mode, respectively.

Once failure rates are assigned to the blocks shown in the reliability block diagram, the overall mode failure rate and hence, MTBF can be found for a particular mode, by the equation:

---

\* See references 5, 6 and 7

$$MTBF_{sys} = \int_0^{\infty} R(t)dt = \int_0^{\infty} R_{\Sigma}(t)dt \cdot R_{5,6}(t)dt \quad [3-1]$$

$$\text{where: } R_{\Sigma}(t) = e^{-\sum_{i=1}^n (\lambda_i)t} = e^{-\lambda_{\Sigma}t} \quad \text{for } i = 1, 2, 3, 4, 7 - 14$$

$$R_{5,6}(t) = e^{-\lambda_5 t} + e^{-\lambda_6 t} - e^{-(\lambda_5 + \lambda_6)t}$$

But, for the series blocks,

$$\int_0^{\infty} R_{\Sigma}(t)dt = \int_0^{\infty} e^{-\lambda_{\Sigma}t} dt = MTBF_{\Sigma} = \frac{1}{\lambda_{\Sigma}} \quad [3-2]$$

and, the redundant blocks,

$$\int_0^{\infty} R_{5,6}(t)dt = \int_0^{\infty} [e^{-\lambda_5 t} + e^{-\lambda_6 t} - e^{-(\lambda_5 + \lambda_6)t}]dt \quad [3-3]$$

$$MTBF_{5,6} = \frac{1}{\lambda_5} + \frac{1}{\lambda_6} - \frac{1}{\lambda_5 + \lambda_6} \quad [3-4]$$

Then substituting,

$$MTBF_{sys} = \left(\frac{1}{\lambda_{\Sigma}}\right) \left(\frac{1}{\lambda_5} + \frac{1}{\lambda_6} + \frac{1}{\lambda_5 + \lambda_6}\right) \quad [3-5]$$

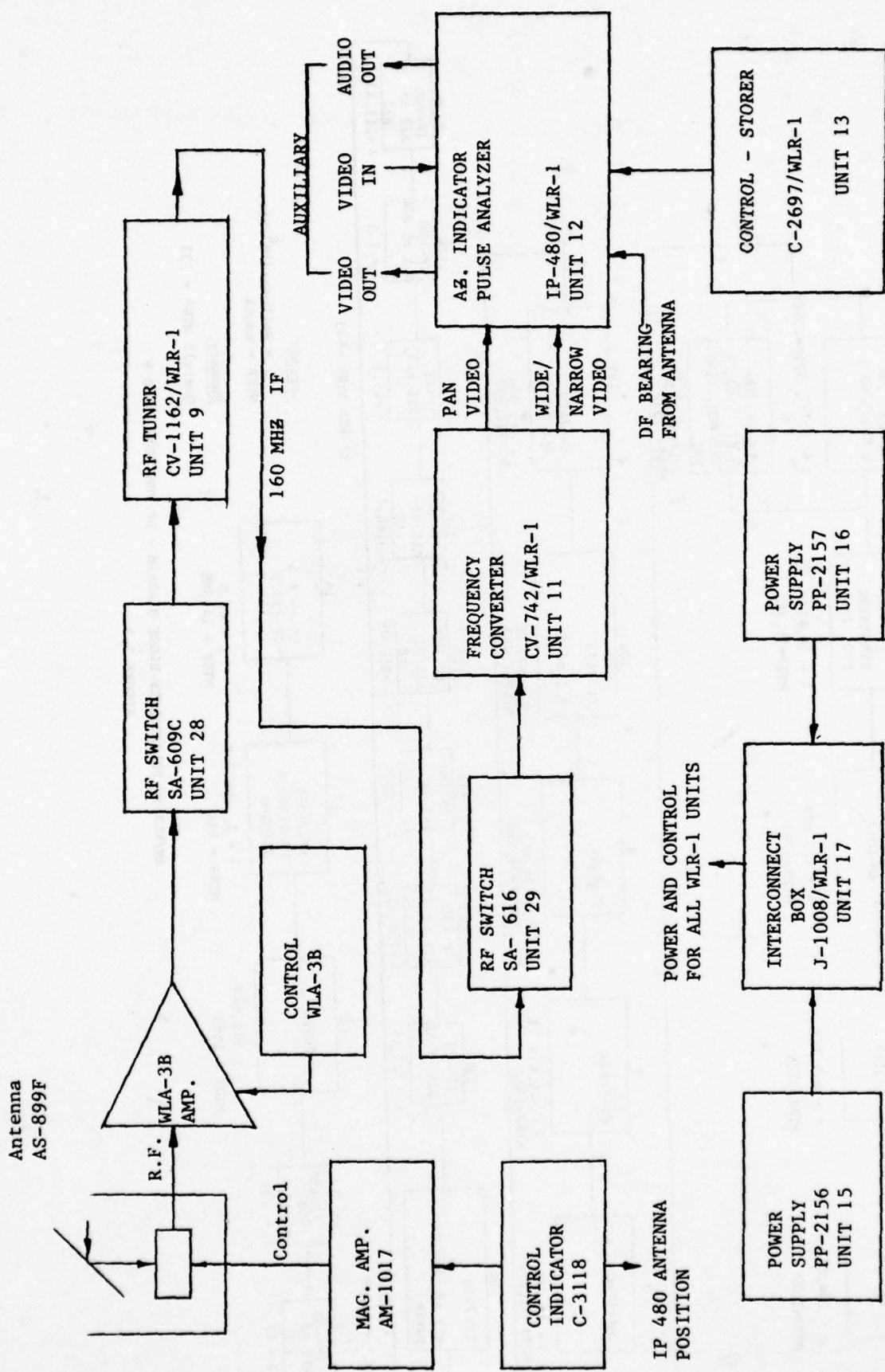
Shown below are the resultant MTBF's for the different modes of operation

<u>MODE</u>	<u>MTBF (HOURS)</u>
Acquisition	136
Analysis	118
DF	133
Combined	106



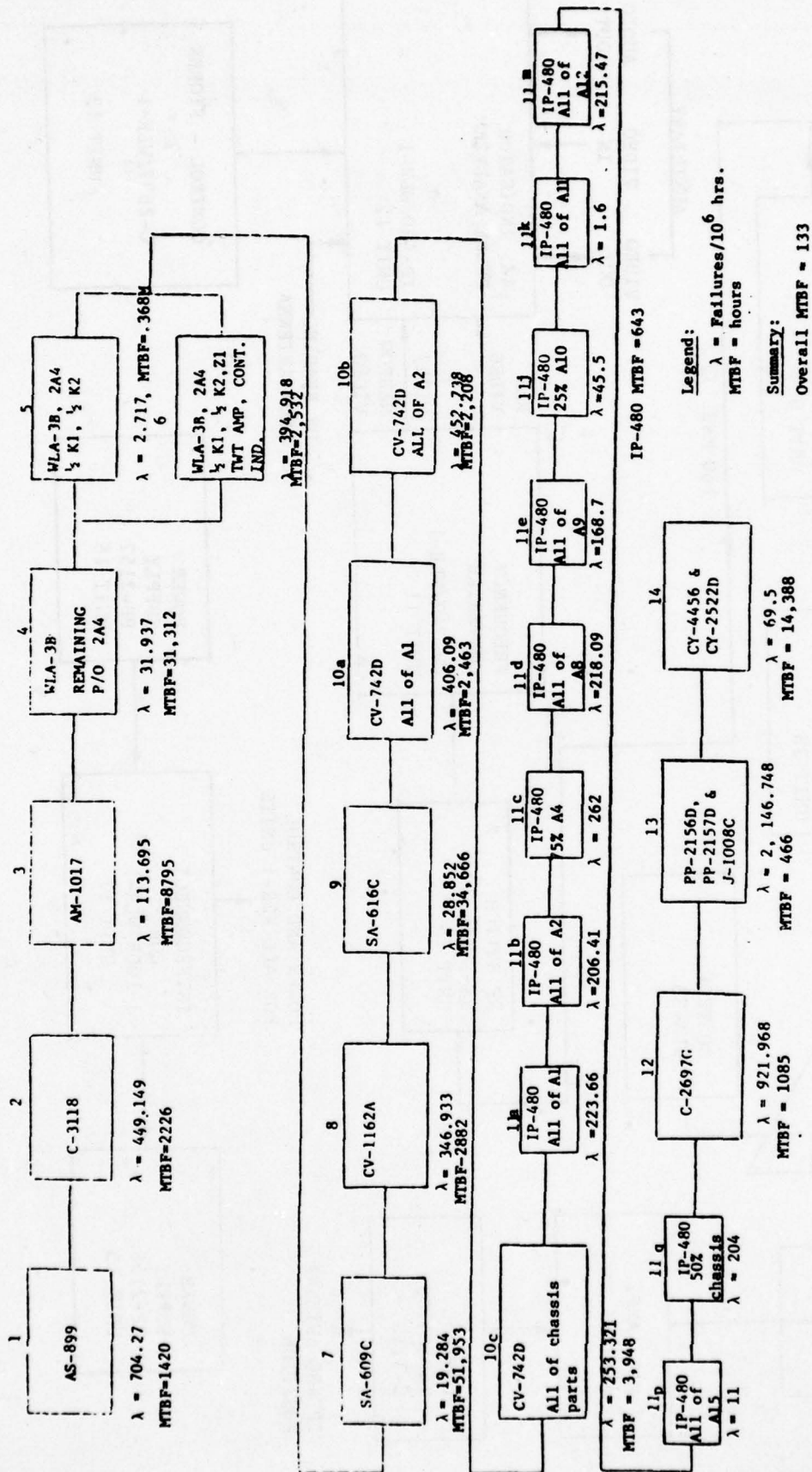
TABLE 3-2  
AN/WLR-1G SYSTEM  
RELIABILITY PREDICTION SUMMARY

UNIT	DESCRIPTION	F/10 <sup>6</sup> Hrs.	MTBF (Hrs.)	UNIT	DESCRIPTION	F/10 <sup>6</sup> Hrs.	MTBF (Hrs.)
CV-732D	Band 1 Tuner	315.544	3,169	SA-616B	R.F. Switch	7.200	138,889
CV-73D	Band 2 Tuner	312.395	3,210	SA-608C	Antenna Switch	23.730	42,141
CV-734D	Band 3 Tuner	314.895	3,176	--	Rack 20	26.640	37,537
CV-735D	Band 4 Tuner	131.429	3,191	--	Rack 21	22.240	44,964
CV-736D	Band 5 Tuner	708.209	1,412	--	Rack 22	24,880	40,193
CV-1159A	Band 6 Tuner	366.540	2,728	--	Rack 23	24.372	41,031
CV-1160A	Band 7 Tuner	370.540	2,699	--	Rack 24	25.252	39,601
CV-1161A	Band 8 Tuner	346.133	2,889	--	Rack 25	44.276	22,586
CV-1162A	Band 9 Tuner	346.933	2,882	AS-899F	Antenna	704.27	1,420
CV-741D	Freq. converter	988.927	1,011	AM-1017B	Mag. Amp.	113.695	8,795
CV-742D	Freq. converter	1,112,149	899	C-3118	Ant. Control	449.149	2,226
IP-480	Pulse Analyzer	3,490.58	286	AN/WLA-3B	Amplifier	454.950	2,198
C-2697G	Control Storer	921.968	1,085				
RF-89D	Freq. Discriminator	993.823	1,006				
PP-2156D	Power Supply	794.339	1,259				
PP-2157D	Power Supply	1,343.355	744				
J-1008C	Interconnect Box	54.054	18,500				
SA-608C	Antenna Switch	22.230	44,984				
SA-609C	Antenna Switch	19.284	51,856				



AN/WLR-1G FUNCTIONAL BLOCK DIAGRAM - BAND 9 TUNING

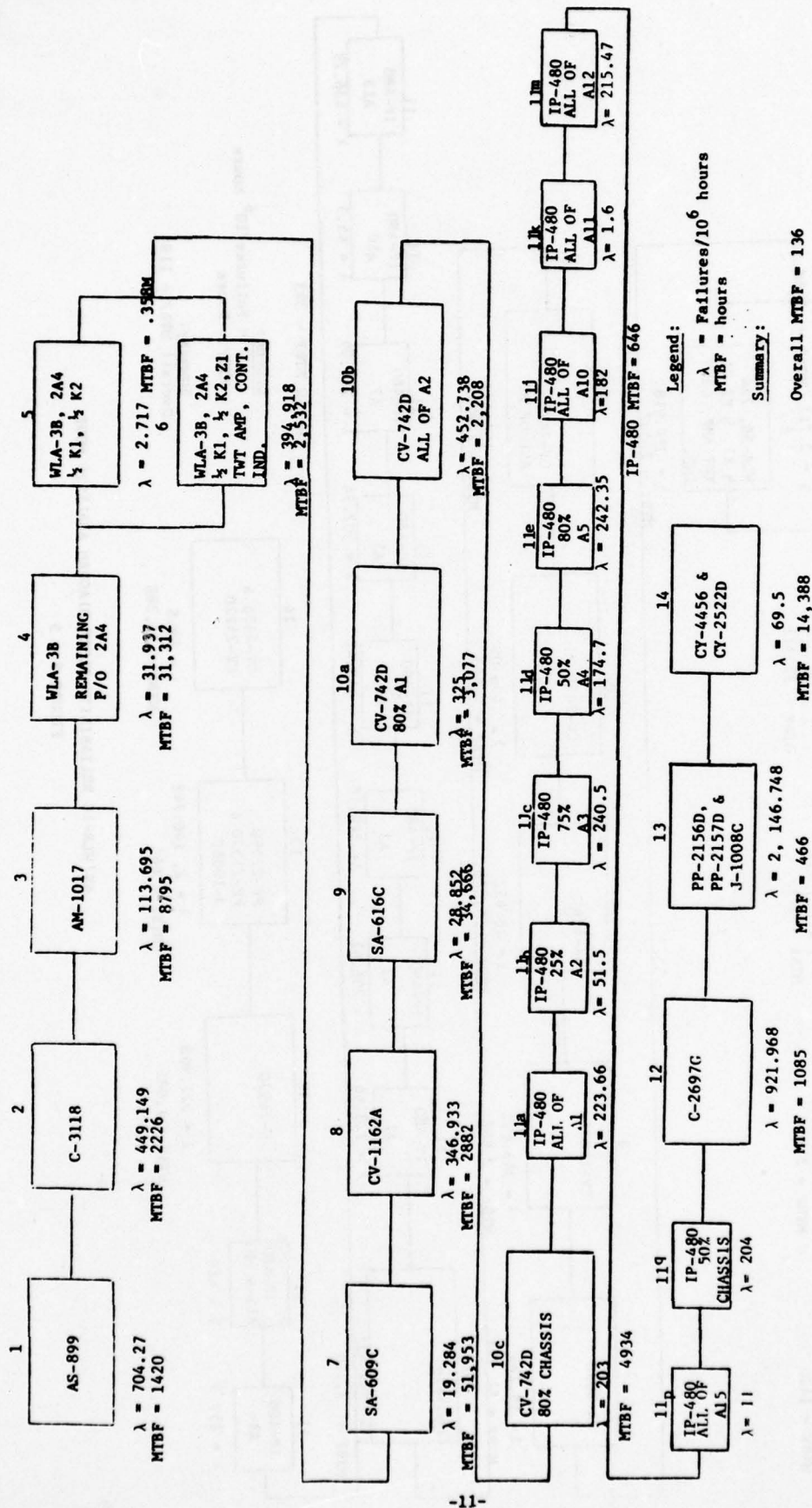
FIGURE 3-2



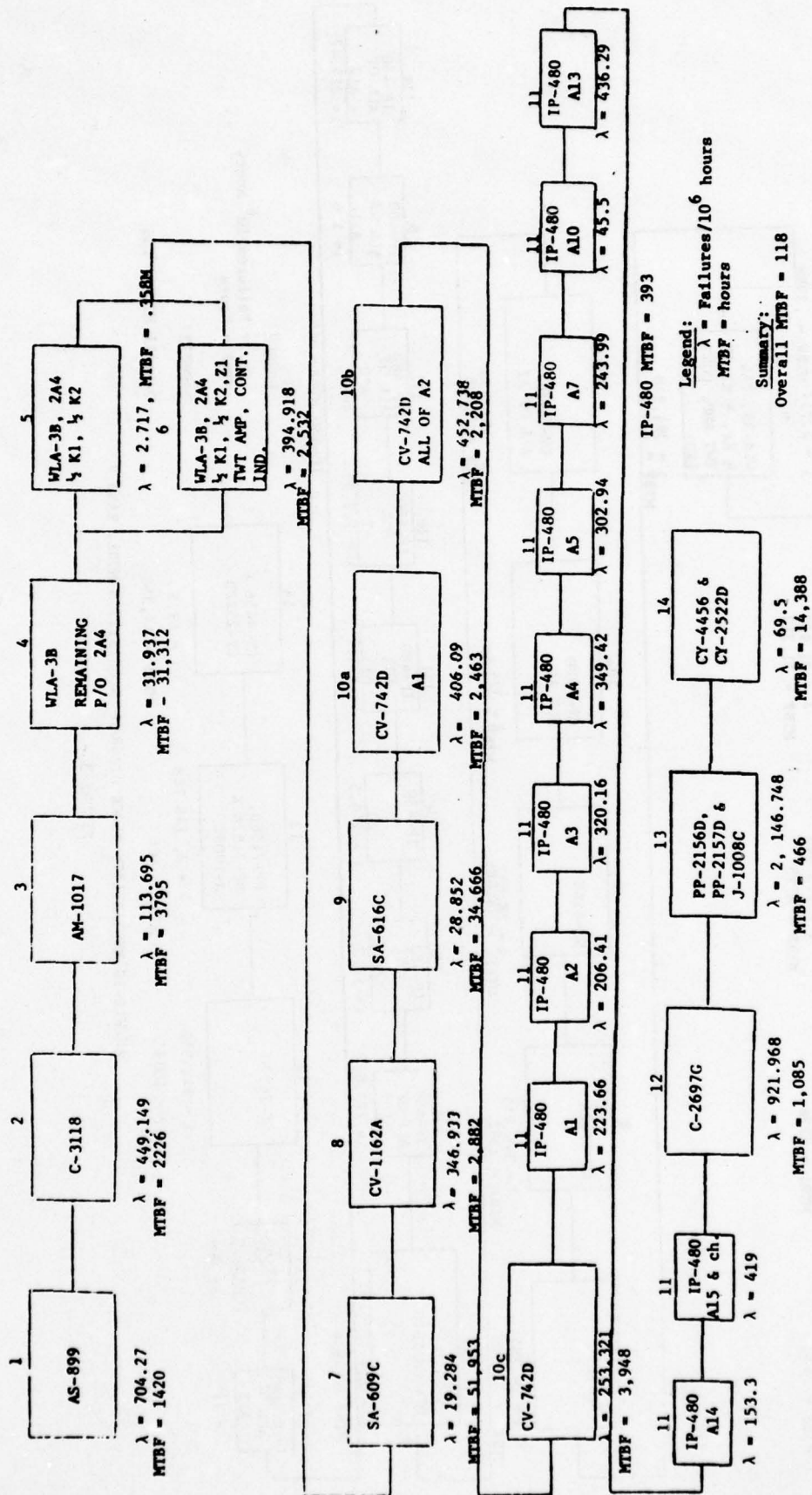
AN/WLR-1G RELIABILITY BLOCK DIAGRAM - DF FUNCTION, BAND 9

FIGURE 3-3





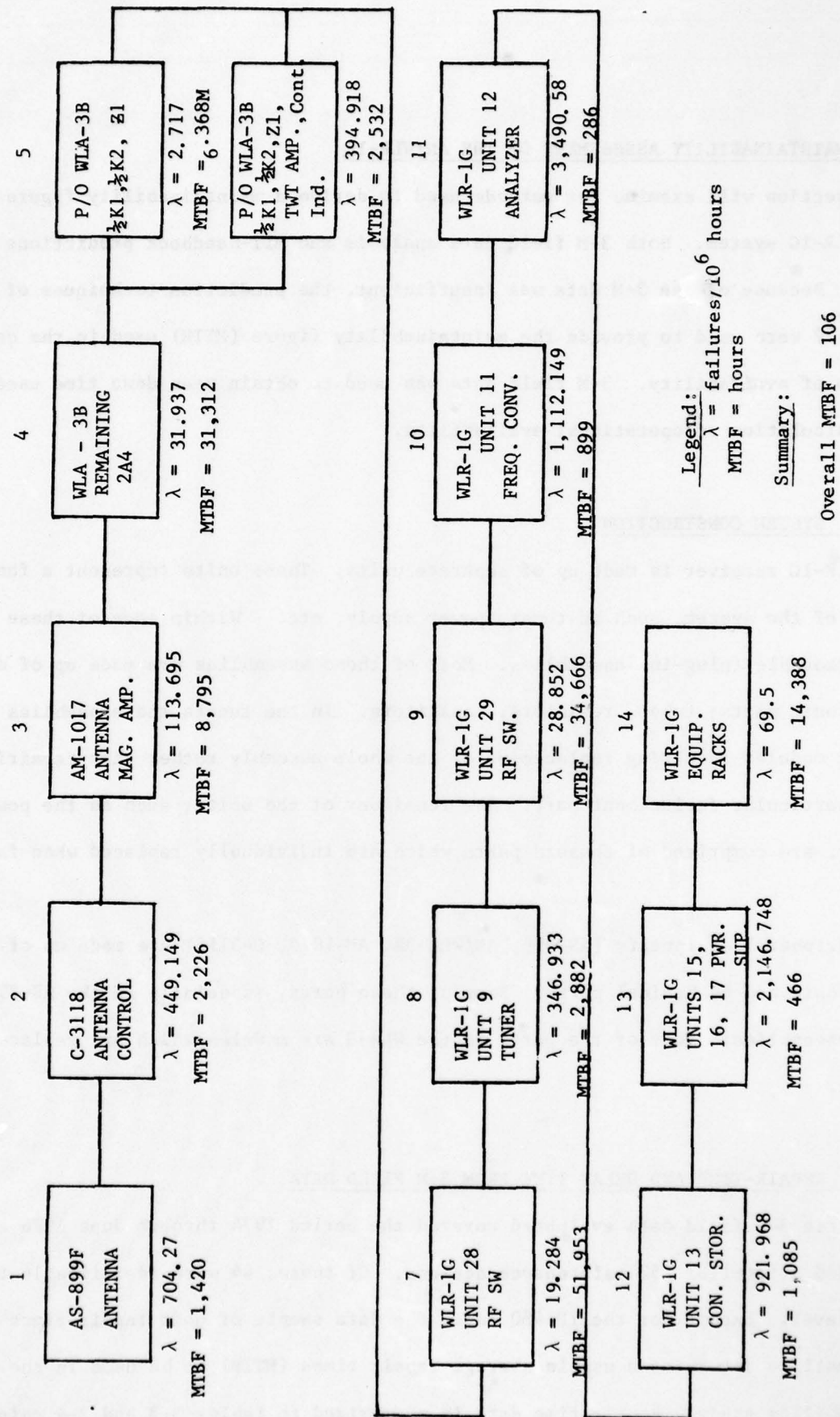
AN/WLR-IG RELIABILITY BLOCK DIAGRAM- ACQUISITION MODE, BAND 9



Legend:  
 $\lambda$  = Failures/ $10^6$  hours  
 MTBF = hours  
 Summary:  
 Overall MTBF = 118

AN/WLR-1G RELIABILITY BLOCK DIAGRAM ANALYSIS MODE

FIGURE 3 - 5



AN/WLR-1G RELIABILITY BLOCK DIAGRAM - BAND 9, COMBINED MODES

FIGURE 3 - 6



### 3.3 MAINTAINABILITY ASSESSMENT OF THE AN/WLR-1G

This section will examine the methods used to derive a maintainability figure for the WLR-1G system. Both 3-M field data analysis and Mil-Handbook predictions were used. Because of the 3-M data was insufficient, the prediction techniques of MIL-HDBK-472 were used to provide the maintainability figure (MTTR) used in the calculation of availability. 3-M field data was used to obtain mean down time used in the calculation of operational availability.

#### 3.3.1 SYSTEM CONSTRUCTION

The WLR-1G receiver is made up of separate units. These units represent a functional block of the system, such as tuner, power supply, etc. Within some of these units are removable (plug-in) assemblies. Most of these assemblies are made up of discrete electronic parts; tubes, resistors, capacitors. In the tuners the assemblies are sealed modules requiring replacement of the whole assembly rather than repairing it by a particular replacement part. The remainder of the units, such as the power supply, are comprised of chassis parts which are individually replaced when faulty.

The peripheral equipments (AS-899, AN/WLA-3B, AM-1017, C-3118) are made up of electronic and mechanical parts. Some of these parts, especially in the AS-899, form assemblies. Most of the parts in the WLA-3 are modules which are replaced intact.

#### 3.3.2 REPAIR-TIME AND DELAY TIME FROM 3-M FIELD DATA

The first 3-M field data evaluated covered the period 1974 through June 1976 and included a total of 352 maintenance actions. Of these, 44 were identifiable to the unit level. Except for the IP-480 unit, the data sample of unit repair-times was too small to determine a usable average repair times (MTTR) to be used in the band 9 availability study. Repair-time data is summarized in tables 3-3 and 3-4 mainly for



TABLE 3-3

AN/WLR-1G UNIT LEVEL REPAIR TIME  
3-M DATA 1974 THROUGH JUNE 1976

UNIT NAME	NUMBER OF REPAIR ACTIONS	AVERAGE REPAIR TIME*
		(Man-Hrs) (No. Repair Actions x 1.5)
RF Tuner, CV1162	5	5.3
RF Switch, SA-609C	1	2.7
RF Switch, SA-b16C	1	13.3
Converter, CV-742	3	16.4
Azimuth Ind., IP 480	22	7.1
Control Storer	4	5.5
Power Supply, PP2156	3	10.2
Power Supply, PP2157	4	13.5
Interconnect, J-1008	1	2

\*The Naval Ship Engineering Center, Norfolk determined that on the average, 1.5 men are used for each repair task. Therefore, man-hours are divided by 1.5 to determine repair time.

TABLE 3-4

IP 480 ASSEMBLY LEVEL REPAIR TIMES  
3-M DATA 1974 THROUGH JUNE 1976

Assembly Name	Number of Repair Actions	Avg. Repair Time* Man-Hrs
		No. Actions x 1.5
A1 Video AMP	4	2.3
A2 Panoramic AMP	1	1.3
A3 0-5 M Sec Sweep	1	1.3
A4 Pulse Stretcher	1	40
A5 5-500 Msec Sweep	none listed	-
A6 Not Used	none listed	-
A7 .5-50k M Sec Sweep	none listed	-
A8 Horiz-Vert AMP	none listed	-
A9 DF PRE-AMP	none listed	-
A10 Scan Video	none listed	-
A11 DF/Scan Selector	none listed	-
A12 Scan Deflection	3	2
A13 Freq. Ind.	6	10.8
A14 Ind. Servo AMP	none listed	-
A15 Equipment Cabinet	1	20
Chassis	4	2.6
Not Identifiable	<u>1</u>	4.0
Total	22	

\*The Naval Ship Engineering Center has determined that on the average, 1.5 men are used for each repair task.

study and comparison with Mil-Handbook predictions in section 3.3.3. Appendix C contains the 3-M Field Data analysis sheets.

A second set of 3-M field data covering the period January through June 1978 was also evaluated. It included the 185 maintenance actions plotted in figure 3-7. The plot shows an exponential distribution of repair times. An exponential distribution of repair-time is typically found for equipments which have relatively low repair-times i.e. most repairs are accomplished within a short time. For the AN/WLR-1G receiver, a low repair-time would be expected considering that plug-in tubes are the most frequent repair time. (These results correlate with the results obtained in the next section from Mil-Handbook predictions.)

Examination of the field data showed that the AN/WLR-1G receiver inherently requires a high number of relatively short repairs. In addition, the IP-480, which requires the most frequent repairs, was usually repaired within the .6 to 3 hour time span. The less frequent repair-times had long durations indicating that repair-times reported may include administrative or logistics delay time. (Sample size for the AS-899 and AN/WLA-3B was too small for individual analysis)

Delay time was tabulated from the above sets of 3-M field data and shown in Table 3-5.



TABLE 3 - 5

## ESTIMATED DELAY TIMES FOR AN/WLR-1G

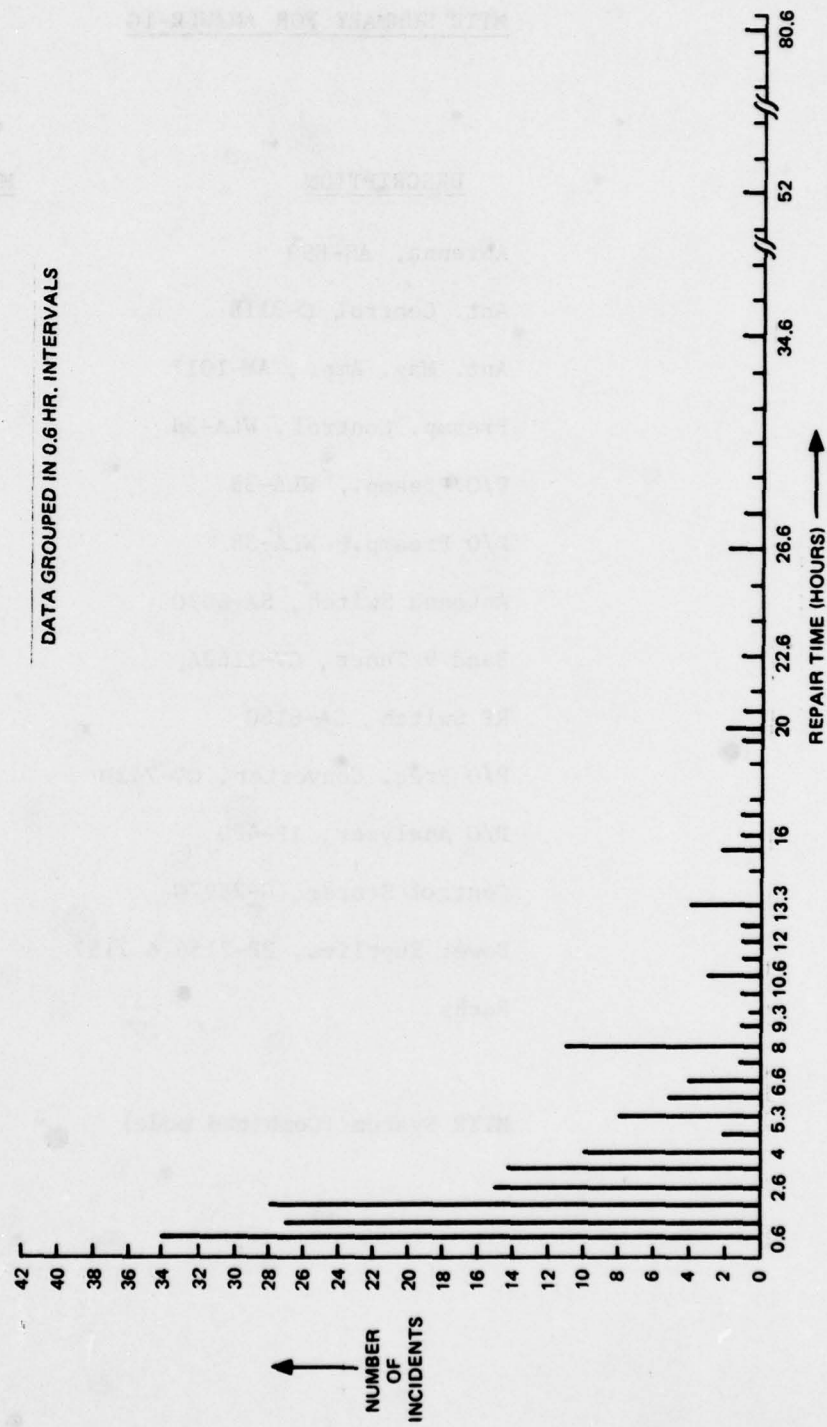
EQUIPMENT	ESTIMATED DELAY TIME (hours)
WLR-1G Receiver	49
899 Antenna	79
WLA-3B Amplifier	89
C-3118 Control	79
AM 1017B Mag Amp	95

These data were used to obtain mean down time for the operational availability calculations in Tables 3-7 through 3-10 by adding the respective equipment delay time to the associated MTTR ( $MDT = MTTR + \text{Delay Time}$ ).

### 3.3.3 REPAIR-TIME EVALUATION BY MIL-HANDBOOK PREDICTION

Since repair-times could not be adequately determined from the 3-M field data, a maintainability prediction using procedure II of MIL-HDBK-472 was performed to assess an MTTR figure (see Table 3-6). Detailed time estimates and procedures are summarized in Appendix C.

Examination of Table 3-6 shows relatively long repair times associated with the antenna, the antenna control and the Preamp. Both the antenna and the WLA-3B Preamp are mast mounted and, therefore, difficult to access for maintenance.



WLR-1G REPAIR INCIDENTS VS. REPAIR TIME (LINEAR SCALE)

FIGURE 3-7

TABLE 3 - 6

MTR SUMMARY FOR AN/WLR-1G

<u>BLOCK</u>	<u>DESCRIPTION</u>	<u>MTR (HRS.)</u>
1	Antenna, AS-899	6.0
2	Ant. Control, C-3118	5.1
3	Ant. Mag. Amp., AM-1017	5.1
4	Preamp. Control, WLA-3B	5.0
5	P/O Preamp., WLA-3B	5.0
6	P/O Preamp., WLA-3B	5.0
7	Antenna Switch, SA-609C	2.2
8	Band 9 Tuner, CV-1162A	2.35
9	RF Switch, SA-616C	2.48
10	P/O Freq. Converter, CV-742D	4.79
11	P/O Analyzer, IP-480	3.16
12	Control Storer, C-2697C	3.2
13	Power Supplies, PP-2156 & 2157	2.3
14	Racks	2.3
MTR System (Combined mode) =		3.35 hours



The Control Indicator C-3118 has micro switches, synchros and resolver which have long interchange and alignment times. These components contribute heavily to the C-3118 overall high repair time - in the order of 1.5 to 2 hours of the 5.1 hour MTTR.

The Mag Amp AM 1017 has a high repair-time primarily because of difficulty in isolating faults and performing alignment. Coordination effort is required to ensure proper antenna rotation. In addition, by nature the magnetic amplifier, circuits are difficult to troubleshoot because proper understanding of its operation is difficult for most technicians. Some of its components are also difficult to access because of equipment construction.

The CV-742D Converter has a high repair-time because of lengthy alignment procedures. Alignment alone contributes about 3 hours of the 4.79 MTTR.

#### 3.4 AVAILABILITY INDICES FOR THE AN/WLR-1G

Both Inherent and Operational Availability indices were determined for the AN/WLR-1. The results are presented in tables 3-7 through 3-10 for the several operational modes of the system. Inherent availability is defined as the probability that at any point in time the system will perform the specified function(s) for a successful mission. All support requirements are fully available. Redundancy is considered applicable and delay times are not existent. Operational Availability is defined as the probability that at any point in time the system is fully operational to perform in the particular mode of interest. Redundancy, therefore, would not be considered and all delay times are considered as part of total down time. The Inherent and Operational Availability math models used in these calculations are given in Appendix D.

TABLE 3 - 7  
AN/WLR-1G DF MODE AVAILABILITY

REL BLOCK	DESCRIPTION	(F/10 <sup>6</sup> HRS.)	REPAIR TIME (HRS.)	DOWNTIME (HRS.)
1	AS-899 ANTENNA	704.27	6.0	85.0
2	C-3118 ANT. CONTROL	449.149	5.1	84.1
3	AM-1017 ANT. MAG. AMP.	113.695	5.1	100.1
4	WLA-3B PRE AMP. CONT.	31.937	5.7	94.7
5	WLA-3B RELAYS	2.717*	5.0	94.0
6	WLA-3B TWT	394.918*	5.0	94.0
7	SA-609C ANT. SW.	19.284	2.2	51.2
8	CV-1162A TUNER	346.933	2.35	51.35
9	SA-616C RF SW.	28.852	2.48	51.48
10	CV-742D FREQ. CONV.	1112.149	4.79	53.79
11	IP-480 ANALYZER	1554.43	3.16	52.16
12	C-2697G CONT. STORER	921.968	3.2	52.2
13	PWR. SUPPLIES & J-BOX	2146.748	2.3	51.3
14	RACKS	69.5	2.3	51.3

PARAMETER	TIME PERIOD			
	7 DAYS	30 DAYS	90 DAYS	365 DAYS
INHERENT AVAILABILITY	0.97390604	0.97390361	0.97389930	0.97389407
OPERATIONAL AVAILABILITY	---	---	---	0.63970306

\*Redundant Path

TABLE 3 - 8

## AN/WLR-1G ACQUISITION MODE AVAILABILITY

REL BLOCK	DESCRIPTION	(F/10 <sup>6</sup> HRS.)	REPAIR TIME (HRS.)	DOWNTIME (HRS.)
1	AS-899 ANTENNA	704.27	6.0	85.0
2	C-3118 ANT. CONTROL	449.149	5.1	84.1
3	AM-1017 ANT. MAG. AMP.	113.695	5.1	100.1
4	WLA-3B PRE AMP. CONT.	31.937	5.7	94.7
5	WLA-3B RELAYS	2.717*	5.0	94.0
6	WLA-3B TWT	394.918*	5.0	94.0
7	SA-609C ANT. SW.	19.284	2.2	51.2
8	CV-1162A TUNER	346.933	2.35	51.35
9	SA-616C RF SW.	28.852	2.48	51.48
10	CV-742D FREQ. CONV.	980.738	4.79	53.79
11	IP-480 ANALYZER	1546.0	3.16	52.16
12	C-2697G CONT. STORER	921.968	3.2	52.2
13	PWR. SUPPLIES & J-BOX	2146.748	2.3	51.3
14	RACKS	69.5	2.3	51.3

PARAMETER	TIME PERIOD			
	7 DAYS	30 DAYS	90 DAYS	365 DAYS
INHERENT AVAILABILITY	0.97454204	0.9745396	0.97453530	0.97453206
OPERATIONAL AVAILABILITY	---	---	---	---
				0.64426031

\*Redundant Path



TABLE 3 - 9

## AN/WLR-1G ANALYSIS MODE AVAILABILITY

REL BLOCK	DESCRIPTION	(F/10 <sup>6</sup> HRS.)	REPAIR TIME (HRS.)	DOWNTIME (HRS.)
1	AS-899 ANTENNA	704.27	6.0	85.0
2	C-3118 ANT. CONTROL	449.149	5.1	84.1
3	AM-1017 ANT. MAG. AMP.	113.695	5.1	100.1
4	WLA-3B PRE AMP. CONT.	31.937	5.7	94.7
5	WLA-3B RELAYS	2.717*	5.0	94.0
6	WLA-3B TWT	394.918*	5.0	94.0
7	SA-609C ANT. SW.	19.284	2.2	51.2
8	CV-1162A TUNER	346.933	2.35	51.35
9	SA-616C RF SW.	28.852	2.48	51.48
10	CV-742D FREQ. CONV.	1112.149	4.79	53.79
11	IP-480 ANALYZER	2546.67	3.16	52.16
12	C-2697G CONT. STORER	921.968	3.2	52.2
13	PWR. SUPPLIES & J-BOX	2146.748	2.3	51.3
14	RACKS	69.5	2.3	51.3

PARAMETER	TIME PERIOD			
	7 DAYS	30 DAYS	90 DAYS	365 DAYS
INHERENT AVAILABILITY	0.97087675	0.970874334	0.97087004	0.97086682
OPERATIONAL AVAILABILITY	---	---	---	0.61047726

\*Redundant Path

TABLE 3 - 10  
AN/WLR-1G COMBINED MODE AVAILABILITY

REL BLOCK	DESCRIPTION	(F/10 <sup>6</sup> HRS.)	REPAIR TIME (HRS.)	DOWNTIME (HRS.)
1	AS-899 ANTENNA	704.27	6.0	85.0
2	C-3118 ANT. CONTROL	449.149	5.1	84.1
3	AM-1017 ANT. MAG. AMP.	113.695	5.1	100.1
4	WLA-3B PRE AMP. CONT.	31.937	5.7	94.7
5	WLA-3B RELAYS	2.717*	5.0	94.0
6	WLA-3B TWT	394.918*	5.0	94.0
7	SA-609C ANT. SW.	19.284	2.2	51.2
8	CV-1162A TUNER	346.933	2.35	51.35
9	SA-616C RF SW.	28.852	2.48	51.48
10	CV-742D FREQ. CONV.	1112.149	4.79	53.79
11	IP-480 ANALYZER	3490.58	3.16	52.16
12	C-2697G CONT. STORER	921.968	3.2	52.2
13	PWR. SUPPLIES & J-BOX	2146.748	2.3	51.3
14	RACKS	69.5	2.3	51.3

PARAMETER	TIME PERIOD			
	7 DAYS	30 DAYS	90 DAYS	365 DAYS
INHERENT AVAILABILITY	0.96801246	0.96801005	0.96800576	0.96800255
OPERATIONAL AVAILABILITY	---	---	---	0.58505027

\*Redundant Path

#### 3.4.1 DISCUSSION OF AN/WLR-1G RESULTS

As seen from the Tables, the inherent availability remains nearly constant over the selected time periods. The slight change that occurs in the numerical value of availability is due to the slightly increasing probability of failure of the redundant path as the time period increases. The small change in availability indicates that the redundant path failures have a small effect on overall inherent availability.

The operational availability figures shown in the tables are probably representative of day to day activity over the 1 year period -- that is, the time expended in keeping the equipment at optimum conditions. To assess the impact of down time on operational availability, the contribution of the several elements of down time may be evaluated. Administrative time may be mathematically estimated from known distribution of repair time\*. Such an estimate for this system would range from 0.5 to 1 hour. PMS time is found to be 137.8 hours from the PMS Table in Appendix C by adding the appropriate maintenance times over a 1 year period. The MTBF for the system is found to be 101.7 hours by summing all failure rates shown in Table 3-10. The MDT is found to be 72 hours by finding the average of the failure-rate-weighted Delay Times in Table 3-10. The resultant one year down time is:

MDT = 72 hours.

Number of failures per year =  $(24 \text{ hours})(365)/(\text{MTBF} + \text{MDT}) = 51$

Down Time<sub>yr.</sub> = Repair Time<sub>yr.</sub> + Logistics Delay<sub>yr.</sub> +  $(1.0)(51) + 137.8$

From the above equation, Logistics Delay<sub>yr.</sub> is derived to be 3261.2 hours. The constituent elements of MDT with their respective percent distributions were

\*Administrative time may be estimated by assuming a Weibull distribution function and proportional to repair time. Reference: Reliability Engineering, Arinc Research Corp., New Jersey, Prentice-Hall, 1968.



determined and are tabulated below:

<u>ITEM</u>	<u>HOURS</u>	<u>PERCENT</u>
Repair Time/yr.	171	4.7
Logistics Delay Time/yr.	3261.2	90
Administrative Time/yr.	51	1.4
PMS 1 yr.	137.8	3.8
Total Down Time	3621	100

### 3.5 HIGH FAILURE COMPONENTS IN THE AN/WLR-1G

Key failures which impact both MTTR and MTBF are as follows:

1. One half of repair actions (22 out of 44) over a 30 month period were associated with the IP-480 display. These took 7.1 hours on average to repair, or 156.2 hours (Table 3-3)
2. Converter CV-742 is the unit showing the longest repair time. This is 16.4 hours MTTR. Three repair actions were involved causing a 49.2 hour experience (Table 3-3).
3. Tubes account for 50% of system failures RV resistors account for 24% of system failures (Of 104 variable resistors, 68 are in the IP-480)

These data are derived from both the 3-M field data and predictions based on Mil-Handbook 217B. Table 3-11 provides a comparison of the distribution of failures based on field data and Mil-Handbook analysis. Although the actual numerical values differ, the proportions seem to track quite well for most of the units. The greatest disparity is found in the failures for the band 9 tuner. The field failures found were mostly in the regulator subassembly. A more in-depth study of the regulator problem is currently under study by Naval Ship Engineering Center, Norfolk - the cognizant field activity for the AN/WLR-1G.

TABLE 3- 11

## AN/WLR-1G FIELD DATA vs PREDICTED FAILURE RATE

<u>UNIT</u>	<u>DESCRIPTION</u>	<u>% OF TOTAL SYSTEM FAILURE RATE</u>	
		<u>FIELD DATA</u>	<u>ANALYTICAL</u>
* CV-732D	Tuner	5.10	2.37
* CV-733D	Tuner	2.04	2.35
* CV-734D	Tuner	5.10	2.37
* CV-735D	Tuner	2.04	2.36
* CV-736D	Tuner	2.04	5.32
* CV-1159A	Tuner	4.08	2.76
* CV-1160A	Tuner	6.12	2.79
* CV-1161A	Tuner	2.04	2.60
CV-1162A	Tuner	6.12	2.61
CV-741D	Freq. Converter	9.18	7.43
CV-742D	Freq. Converter	6.12	8.36
IP-480	Pulse Analyzer	24.49	26.24
C-2697G	Control Storer	6.12	6.93
RF-89D	Freq. Discriminator	0	7.47
PP-2156D	Power Supply	3.06	5.97
PP-2157D	Power Supply	8.16	10.10
J-1008C	InterconnectBox	2.04	0.41
SA-608C	Ant. Switch	0	0.17
* SG-333D	Pulse Generator	3.06 (test equip.)	-
Rack 20	Elect. Cabinet	0	0.20
Rack 21	Elect. Cabinet	0	0.17
Rack 22	Elect. Cabinet	0	0.19
Rack 23	Elect. Cabinet	0	0.18
Rack 24	Elect. Cabinet	0	0.19
Rack 25	Elect. Cabinet	0	0.33
Rack 26	Elect. Cabinet	0	-
SA-609C	Ant. Switch	0	0.14
SA-616C	R.F. Switch	2.04	0.05
SA-608C	Ant. Switch	2.04	0.18
		100.0	100.0

\*Not pertinent to the current study.

A review of the 3-M Reports for the AS-899 antenna showed an MTBF of 704 hours versus 1420 derived by the handbook prediction method. The 3-M Reports used, covered a 2 1/2 year period from 1976 through June 1978 and was applicable only to the AS-899 E and F configuration.

The data on the antenna were investigated to attempt to determine if the fiber/metal gears used in the drive train experienced a higher failure rate than estimated. The data did not show the gears to be a troublesome area but rather the couplings. Further investigation revealed that this indication is supported by opinion of personnel involved in maintenance of this equipment,\* and coupling failure was attributed to erroneous installation during repair. The metal couplings are used to connect the removable sections of the drive train such as synchro and motor shafts to the main drive. Here again a more in-depth study of the coupling mechanization may be required to determine the nature of the problem.

\*Personnel at Navelex Supply, San Diego, were asked about gear failure experience and revealed instead that couplings failed often due to erroneous installation.



#### 4.0 STUDY OF THE AN/SLQ-32(V)2

The SLQ-32(V)2 at this time is in the early operational evaluation phase.

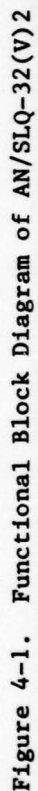
Evaluation of the first article production model of each suite will be starting very shortly, therefore, its evaluation for purposes of this report relies very heavily on information gained from other engineering analyses and the Technical Manuals.

#### 4.1 SYSTEM DESCRIPTION

The SLQ-32(V)2 is a passive ESM system providing automatic threat acquisition identification and display. Figure 4-1 provides a functional block diagram of the system. Figure 4-2 provides an overall functional descriptive block diagram. A thorough and detailed functional description is found in reference 1; however, for background purposes of this report, some description significant to this report is reiterated here.

Signals are received via a fixed antenna array system. The antenna system is divided into four multibeam antenna arrays and two semi-omnidirectional antennas to cover bands 2 and 3. Four spiral antennas are used for band 1. The multi-beam arrays provide direction finding redundancy and graceful degradation as discussed in Section 4.2.2. Frequency information is processed through omni antennas and the IFM sections (1A1 and 1A2) and fed to the computer for digital processing. Amplitude and angle information is correlated in the Angle Encoder and fed into the computer for digital processing. The digital subsystem, consisting of 1A4, 1A5, 1A6 and 2A5 provides the automatic threat identification processing for storage and display to the operator.

Although the Technical Manual does not describe separate modes of operation for the AN/SLQ-32(V)2, it may be separated into three functional schematic loops. The three



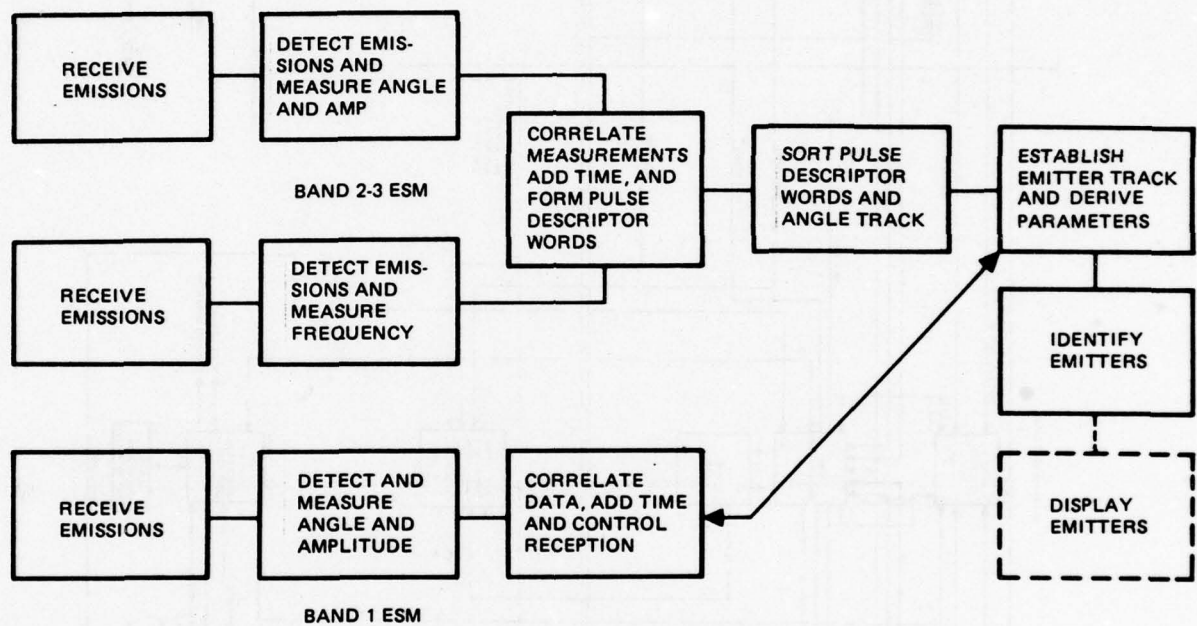


Figure 4-2. ESM Functional Operation



loops are DF, Frequency Measurement and Band 1 Reception. In this report, the loops will be designated as the DF Mode, Frequency Measurement (Acquisition) Mode and Band 1 Reception Mode. DF Mode results in the determination of threat bearing of emitters in bands 2 and 3. The Frequency Measurement (Acquisition) Mode results in the determination of the frequency and pulse parameters of band 2 and 3 emitters. Band 1 Reception Mode detects, determines bearing and provides analysis of emitters in band 1.

#### 4.1.1 OPERATIONAL REQUIREMENTS

Operation of the system requires a three shift watch by operators trained to perform unscheduled maintenance. Much of the system operation is conducted automatically using the software program stored in the computer. The operator's function is to start or stop operation, load the computer program when needed, evaluate the tactical situation and to enter data into or give commands to the system via the computer. The computer provides "prompting" when data is needed from the operator. The operator may enter direct commands into the computer to override certain automatic functions when required. The system controls, indicators, and monitor are located on the Display Console (5A2, figure 4-1). The detailed function of each control and indicator is provided in reference 1 (Technical Manual).

System design is based on a modularity concept. It is intended to have organizational support by replacement of Ship Replaceable Assemblies (SRA) such as printed circuit cards, RF modules and power supply assemblies. Repairable SRA's will be returned to the depot for repair. A minimum of intermediate repair will be performed on-board ship and limited to replacement of connectors, repairing broken wires, solder connections and similar corrective maintenance. Although support is currently being handled by the contractor, the deployment stage support is to be determined by the Navy at a later date. This study assumes the Navy will support the deployment

stage. Appendix B of reference 2 includes a listing of units, assemblies and piece parts. Suite 2 includes approximately 430 SRA's.

#### 4.2 RELIABILITY ASSESSMENT

The AN/SLQ-32(V) is currently going into evaluation of the first-article production model. Field data of the production configuration is non-existent and a limited amount of data is available on the prototype model. This reliability evaluation, therefore, is heavily dependent upon earlier engineering analyses.

##### 4.2.1 FAILURE ASSESSMENT FROM FIELD DATA

The prototype AN/SLQ-32(V) equivalent to suite 3, compiled 1034 operating hours of TECHEVAL operation (reference 3) on board the USS Leahy. Some additional operation was gained on board the USS Virginia, however, results of that evaluation were not available in time for this report. Operation on board the Leahy reported eight maintenance actions against the ESM portion of the system. Of these 8, two were reported as failures which would have resulted in loss of mission performance capability yielding an observed MTBF of 517 hours. Table 4-1 provides a summary of the results. Because of the short duration of evaluation and only two failures, the observed MTBF was not considered applicable for this study. Moreover, the failures are probably representative of early life failures rather than random failures.

One significant observation resulting from Techeval is that there were no reported incidents of computer memory alteration. Memory retention capability provides added confidence to overall computer reliability (including computer power control logic) since memory alteration would be one of the most probable failure modes of the computer or its power source.

TABLE 4-1

## AN/SLQ-32(V) PROTOTYPE TECHEVAL DATA SUMMARY

ESM Operating Hours	1034 hours
ESM Total Maintenance Actions	8
ESM Maintenance Actions considered major failures	2
ESM Maintenance Actions considered minor failures	3
ESM Maintenance Actions considered preventive maint.	3
ESM Total Major Failure corrective maintenance time	3.96 hours
ESM Total Minor Failure corrective maintenance time	5.2 hours
ESM Total Preventive Maintenance time	.76 hours
*Observed ESM MTBF	517 hours
*Observed ESM Mean corrective maintenance time	1.98 hours
*Observed ESM inherent availability	0.996

\*Based on 2 major failures which prevented ESM mission accomplishment.



#### 4.2.2 FAILURE ASSESSMENT BY MIL HANDBOOK PREDICTION

A reliability prediction has already been prepared by the contractor for the AN/SLQ-32(V). Because of its voluminous size, the complete prediction is not included in this report, but is summarized for ease of reference. The complete prediction is contained in Appendix C of reference 4. The method used to determine part failure rates was according to section 2 of MIL-HDBK-217B, Part Stress Analysis Prediction. Table 4-2 provides the summary of failure rates applicable to each functional block of the AN/SLQ-32(V)2. The portion of the system comprising each block is also identified. All blocks have a duty cycle of 1.0 except for the tape transport unit in block K. It has been assessed that this unit is used 10% of the time.

The assumptions and conditions used in determining reliability for this study were:

- (a) The ESM system is required to operate 100% of the mission time.
- (b) Mission success is defined to be threat location and identification within the system specifications given in Specification ELEX-C-243C, paragraph 3.2.1 and Table III.
- (c) The system is capable of performing a successful mission under the graceful degradation specified in ELEX-C-243C, paragraph 4.5.3.1 and listed here in Table 4-3.

Figures 4-3, 4-4, 4-5 and 4-6 are the reliability block diagrams for the AN/SLQ-32(V)2 ESM system. As seen in figure 4-3, system redundancy is provided in blocks A through D for the DF Mode of Operation. (Redundant elements are indicated by the lower case letters). The numbers in the brackets at the bottom of the blocks indicate the degree of graceful degradation. For block A there are a total of 38  $A_1$  elements and any combination of 35 or more elements operating (with three or less in a failed state) will provide operation with some degradation. Thus, 35 out of 38 are required for mission success even though some degradation of performance occurs, reference table 4-3.

Table 4-2 Reliability Model Block Identification and Failure Rate Summary

BLOCK	CONTENTS OF BLOCK	ITEM PART NUMBER	$\lambda$ (FAILURES/ $10^6$ HOURS)
A	BAND 2 BEAM FORMING ELEMENT		
	(1) Antenna array element	Part of 927418-1	0.595
	(2) Input port of beam forming lens	Part of 927419-1	0.588
B	BAND 2 BEAM SELECTION ELEMENT		
	(1) Output port of beam forming lens	Part of 927419-1	0.588
	(2) RF module	928307-1	14.358
C	BAND 3 BEAM FORMING ELEMENT		
	(1) Antenna array element	Part of 928414-1	0.595
	(2) Input port of beam forming lens	Part of 927415-1	0.588
D	BAND 3 BEAM SELECTION ELEMENT		
	(1) Output port of beam forming lens	Part of 927415-1	0.588
	(2) RF module	928308-1	10.243

Table 4-2 Reliability Model Block Identification and Failure Rate Summary

BLOCK	CONTENTS OF BLOCK	ITEM PART NUMBER	$\lambda$ (FAILURES/10 <sup>6</sup> HOURS)
E	NON-REDUNDANT PORTION OF QUADRANT		
	(1) Band 2 DF Receiver excluding items covered in $a_i$ and $b_i$ above	926989-1	18.209
	(2) Band 3 DF Receiver excluding items covered in $c_i$ and $d_i$ above	926988-1	23.368
	$\lambda_E$		41.577
F	EXTERIOR ESM EXCEPT ITEMS COVERED BY $a_i$ THRU E ABOVE		
	(1) Antenna-radome assembly, semi-omni	845676-2	0.501
	(1) Antenna-radome assembly, semi-omni	845676-1	0.501
	(2) Antenna assembly - band 1	849218-1	1.002
	(3) Amplifier, radio frequency		
		926484-2	227.050
	(4) Processor, signal data (angle encoder)		
	(5) Enclosure	926996-1	191.877
		926975-1	34.854
	$\lambda_F$		455.785



Table 4-2: Reliability Model Block Identification and Failure Rate Summary

BLOCK	CONTENTS OF BLOCK	ITEM PART NUMBER	$\lambda$ (FAILURES/ $10^6$ HOURS)
G	INTERIOR ESM		
	(1) IFM, Preamp MUX	926997-2	436.464
	(2) CFR (Coarse frequency receiver)		268.811
	Receiver, countermeasures (Band 1 receiver/DCU)	926990-1	449.180
	$\lambda_G$		1154.455
H	PROCESSOR, SIGNAL DATA AND CORRELATOR	926994-2	209.957
	$\lambda_H$		209.957
J	COMPUTER AND COMPUTER INTERFACE		
	Computer, digital	929010	473.220
	Interface, computer	928399-1	12.111
	Cabinet, rack 1	926488-1,-2,-3	20.103
	$\lambda_J$		505.434

Table 4-2: Reliability Model Block Identification and Failure Rate Summary

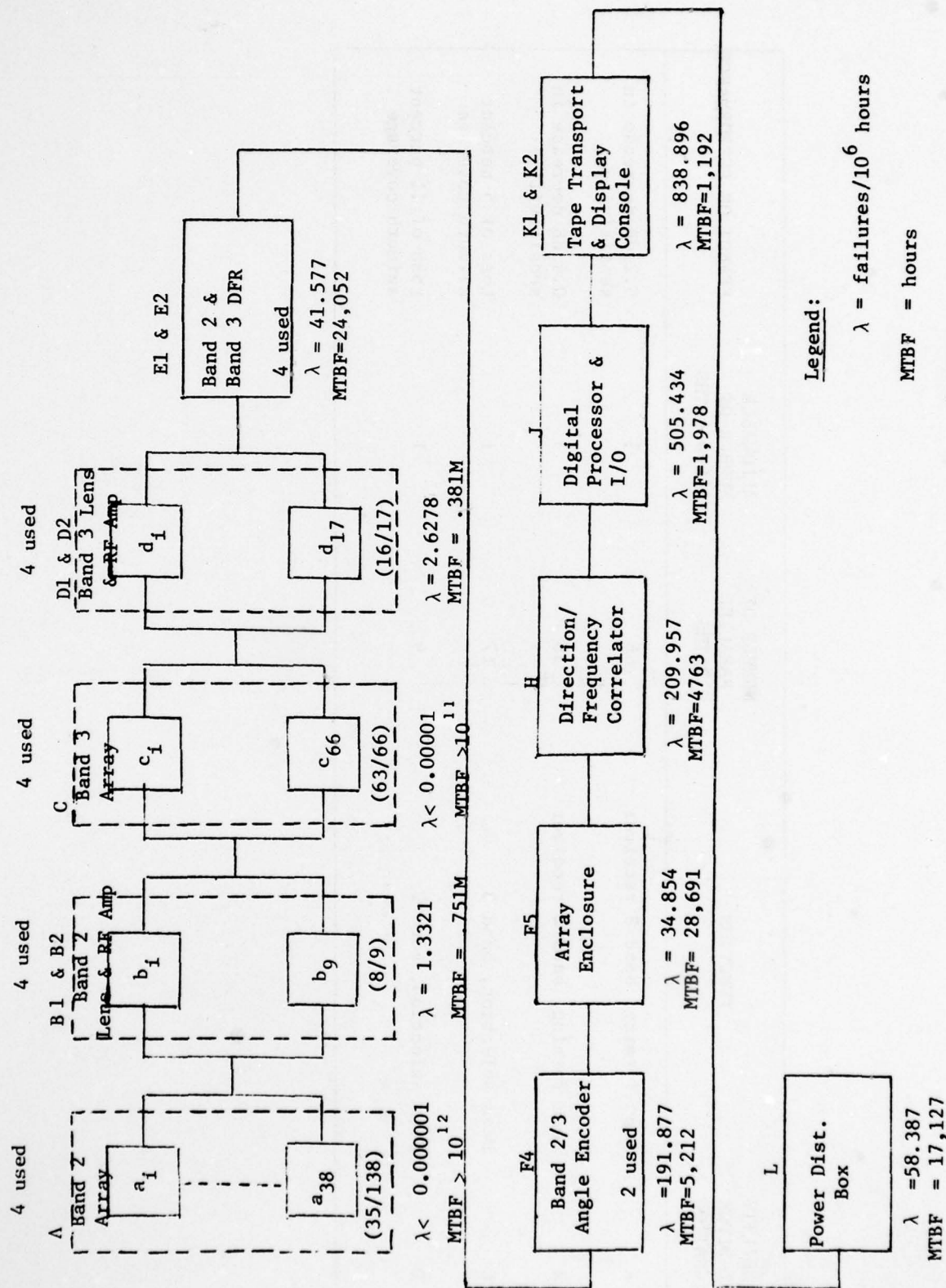
BLOCK	CONTENTS OF BLOCK	ITEM PART NUMBER	$\lambda$ (FAILURES/ $10^6$ HOURS)
K	CONSOLE		
	(1) Console - display	848066-1	819.650
	(2) Tape transport	926910-1	19.110*
	Footswitch	929171-1	0.145
L	DISTRIBUTION BOX, POWER		
		926966-1	58.387
			$\lambda_L$
			58.387

\*10% duty cycle factor included

Table 4-3 AN/SLO-32(V)2 Graceful Degradation Functions

RELIABILITY MODEL BLOCK DESIGNATION	FUNCTION	NUMBER OF PARALLEL PATHS	ALLOWABLE NUMBER OF FAILED PATHS	EFFECT ON PERFORMANCE
A	Beam forming, band 3 receiver	66	3	0.2 dB decrease in sensitivity
B	Beam forming, band 2 receiver	38	3	0.4 dB decrease in sensitivity
C	Beam selection, band 3	17	1	Loss of 5 percent azimuth coverage
D	Beam selection, band 2	9	1	Loss of 11 percent azimuth coverage





Legend:

$\lambda$  = failures/ $10^6$  hours

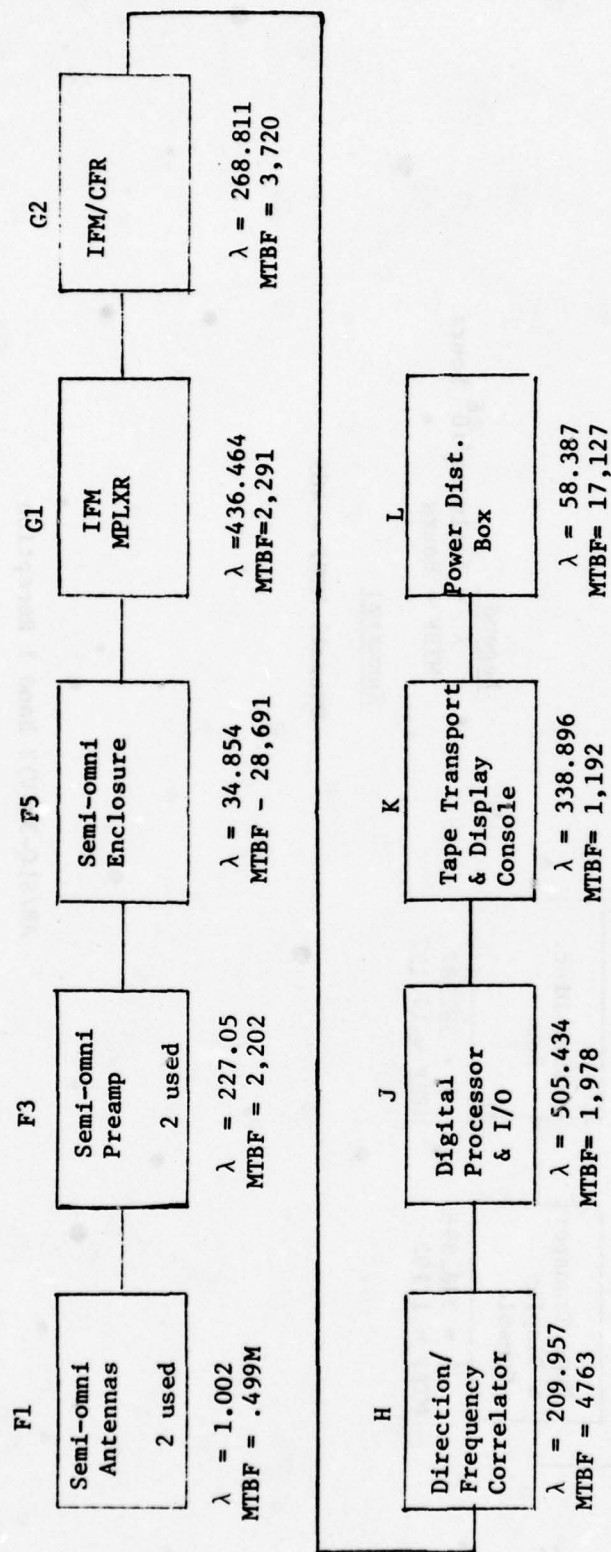
MTBF = hours

Summary:

Overall MTBF = 4.52

AN/SLQ-32(V)2 DF MODE

FIGURE 4-3



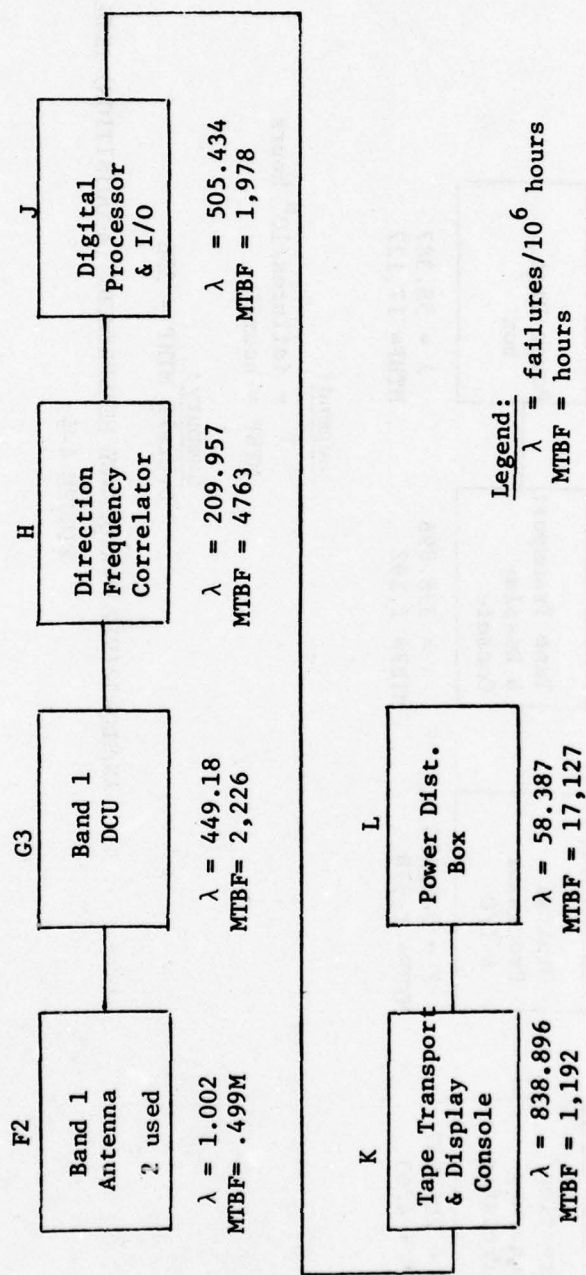
Legend:

$\lambda$  = failures/ $10^6$  hours  
MTBF = hours

Summary:  
Overall MTBF = 356

AN/SLQ-32(V)2 FREQUENCY MEASUREMENT (ACQUISITION) MODE

FIGURE 4-4



Legend:  
 $\lambda$  = failures/ $10^6$  hours  
 MTBF = hours

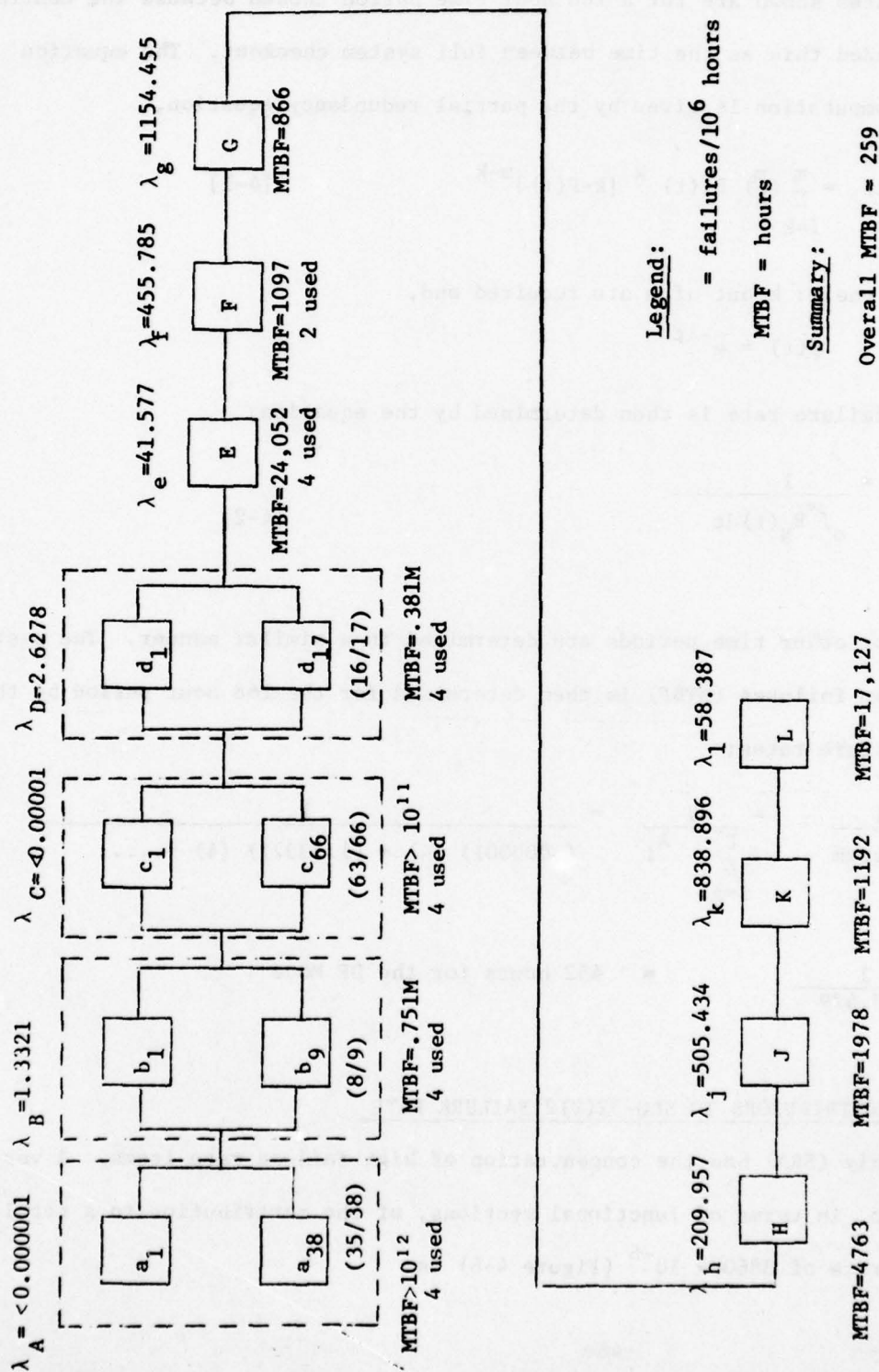
Summary:

Overall MTBF = 485

AN/SLQ-32(V)2 Band 1 Reception

Figure 4-5





Reliability Block Diagram SLO-32(V)2 Combined Modes  
Figure 4-6

The failure rates given in figure 4-3 and 4-6 for blocks A, B, C and D are determined by the combined parallel path probability computation as a function of time. The rates shown are for a 168 hour time period chosen because the contractor has recommended this as the time between full system checkout. The equation used for this computation is given by the partial redundancy equation,

$$R_N(t) = \sum_{i=k}^m \binom{m}{k} P(t)^k [k-P(t)]^{m-k} \quad [4-1]$$

where: k out of m are required and,

$$p(t) = e^{-\lambda t}$$

The equivalent failure rate is then determined by the equation;

$$\lambda_N = \frac{1}{\int_0^{\infty} R_N(t) dt} \quad [4-2]$$

Failure rates for other time periods are determined in a similar manner. The system mean-time-between failures (MTBF) is then determined for the 168 hour period by the summation of failure rates;

$$\begin{aligned} \text{MTBF} &= \frac{1}{\lambda_{\text{system}}} = \frac{1}{\sum_{i=A}^L \lambda_i} = \frac{1}{(.000001) (4) + (1.33321) (4) + \dots} \\ &= \frac{1}{2213.429} = 452 \text{ hours for the DF Mode} \end{aligned}$$

#### 4.2.3 HIGHEST CONTRIBUTORS TO SLQ-32(V)2 FAILURE RATE

No single assembly (SRA) has the concentration of high failure rate items. A very coarse breakdown, in terms of functional sections, of the contribution to a total system failure rate of  $3860 \times 10^{-6}$  (Figure 4-6) is:

RF	43%
Power Supplies	24%
Display	21%
Computer	12%

The power supplies consist of 18 AC to DC power supplies and 17 regulator assemblies. In the display the CRT appears to be the only single part type with a high contribution to failure rate (After semiconductors and integrated circuits). The computer is composed primarily of ICs and the core memory which contributes about 33% of the 485.3 failures/ $10^6$  hour failure rate.

In the RF section, some of the portions showing a high contribution to failure rate are the IFM-Preamp-Multiplexer, CFR, DCU and Angle Encoder. Except for Integrated Circuits (IC's) none of those units appear to have a high concentration of high failure rate components. Among RF oscillators, directional couplers, attenuators and filters, the failure rates are well distributed. Overall, there are approximately 5000 IC's used in suite 2 with an assigned failure rate of 0.1034 failures/ $10^6$  hours. This amounts to approximately 13% of the total system failure rate. However, these 5000 IC's are well distributed among units of the system.

#### 4.3 MAINTAINABILITY ASSESSMENT OF THE AN/SLQ-32(V)2

The maintainability assessment of the AN/SLQ-32(V)2 relied heavily on the technical analysis already performed by the contractor. The maintainability assessment was directed mainly toward identifying the associated repair times of the functional blocks making up the suite 2 model. Within the functional blocks, there are a total



of 432 ship replaceable assemblies (SRA's) Table 4-4 provides a breakdown of the locations of the units and SRA's. The SLQ-32(V) maintenance design concept is to repair by replacement of modules (SRA's) on board ship. The units range from 3/4 to 1 1/2 ATR size units. Access to SRA's in Rack 1 is by loosening swing bolt nuts, sliding out unit, removing unit covers held with quick removal Dzus fasteners and SRA removal. Access to SRA's in the Console is by removal of 8 front panel quick disconnect type screws and sliding out console unit. Access to exterior SRA's is by opening hinged antenna enclosure panels, disconnecting and tagging cables, loosening swing bolts and removing entire assembly. Assembly covers, cables and SRA holding screw are then removed.

#### 4.3.1 REPAIR-TIME EVALUATION FROM FIELD DATA

At the time of this study, the only field data available on equipment repair-time was from Techeval (reference paragraph 4.2.1). In addition, the repair-time data measured for 39 maintenance actions and 24 tasks performed during maintainability demonstration testing was also available. Of these, it was determined that 8 maintenance actions and 16 demonstration tasks were for equivalent suite 2 ESM hardware. The data was tabulated and is shown in Tables 4-5 and 4-6.

Table 4-5 is a summary of the observed repair time for correction of the faults that occurred during the Techeval program aboard the USS Leahy. Table 4-5 also compares the observed repair time to the repair time shown derived by Mil-Handbook prediction. Table 4-6 is a summary of the observed repair times (corrective maintenance times) from the specified maintenance tasks performed during the Maintainability Demonstration Test, reference 3. Table 4-6 also provides the predicted repair time for comparison. Demonstration data shows observed MTTR better than predicted values. Maintenance tasks during Techeval (Table 4-5)

TABLE 4-4

## AN/SLQ-32(V)2 SYSTEM CONSTRUCTION

<u>PORT</u>	EXTERIOR EQUIPMENT DESCRIPTION	<u>STARBOARD</u>
UNIT 22 No SRA	Band 1 Antennas (mast)	Unit 32 No SRA
UNIT 20 A1 8 SRA's	Array Antenna Assemblies Array Antenna Enclosures Chassis Parts	Unit 30 8 SRA's
A3 1 SRA	Semi-omni Antenna	1 SRA A3
A4 1 SRA	Semi-omni Antenna	1 SRA A4
A5 22 SRA's	Band 3 DFR	22 SRA's A5
A6 22 SRA's	Band 3 DFR	22 SRA's A6
A7 14 SRA's	Band 2 DFR	14 SRA's A7
A8 14 SRA's	Band 2 DFR	14 SRA's A8
A11 10 SRA's	Semi-omni Preamp	10 SRA's A11
A12 29 SRA's	Angle Encoder	29 SRA's

## INTERIOR EQUIPMENT - EW ROOM

<u>UNIT 1</u>	<u>RACK 1</u>
A1 15 SRA's	IFM Multiplexer
A2 15 SRA's	IFM CFR
A3 22 SRA's	Band 1 Receiver, DCU
A4 48 SRA's	Direction/Frequency Corelator
A5 38 SRA's	Digital Computer, CP-1374
A7 7 SRA's	Rack 1 Power Distribution Box
UNIT 4	Heat Exchanger (optional)
UNIT 11	Power Distribution Box
7 SRA's	Chassis parts

## INTERIOR EQUIPMENT - CIC ROOM

UNIT 5	Operator Display Console
A1 4 SRA's	Tape Transport Assembly
A2 34 SRA's	Console

TABLE 4 - 5

AN/SLO-32(V) TECHEVAL OBSERVED REPAIR TIME

MAINTENANCE ACTION		XN-1 OBSERVED REPAIR TIME (HR)	(V)2 PREDICTED REPAIR TIME (HR)
XN-1 MINOR FAILURES			
Display Console	4k x 16 Mem. Module 7A5A17	0.5	0.52
Unit 20	Band 2 DFR, CVR 20A12A10	1.5	1.13
Unit 30	Band 2 DFR, MPLXR 30A10A6	3.2*	1.28
XN-1 MAJOR FAILURES			
Unit 1	Memory Card 1A1A2A8	1.75	0.77
Unit 2	IFM Pre Amp 2A1A3V2	2.21	No equiv. found
XN-1 PREVENTIVE ACTION			
Display Console	Trace Alignment	0.16	-
Unit 2	IFM Sensitivity Adjust.	0.5	-
Display Console	Filter	0.1	
*Added 17.3 hour delay time recorded			



TABLE 4-6

AN/SLQ-32(V) MAINTAINABILITY DEMONSTRATION DATA  
DEMONSTRATED REPAIR TIMES

UNIT	FAILURE SYMPTOM	DEMONSTRATED MAINTENANCE TIME (Hrs)	AN/SLQ-32-(V) 2 PREDICTION 30 JULY 78 (Hrs)
IFM MUX 1A1A3	SOT + 28V Power Supply	.61	.93
Display 5A2	Bright/Dim Characters (CARD)	.16	.52
SIOC 1A4	SDT-Serial Message (CARD)	.3	0.7
BD 3 DFR 20/ 30A5/6	+5V Power Supply (Outside)	.64	.13
BD 3 DFR 20/30A5/6	+5V Power Supply (Outside)	.97	.13
IFM MUX 1A1A3	SOT + 15V Power Supply	.93	0.93
Display 5A2	No Circle Format (CARD)	.16	.52
SIOC 1A4	SDT Serial Message (CARD)	.45	.7
(V)3 TGU	SOT IND + 15V Power Supply		-
SIOC 1A4	SDT Serial Message (A-15) CARD)	.37	.7
(V)3 TGU	SDT SSW (A-20 CARD)		
DFC/DTU 1A4	Process Control (A-6 CARD)	.25	.7
SIOC 1A4	SDT Serial Message (A-15 CARD)	.23	.7
(V)3 TGU	SOT-HDT (A-4 CARD)		-
DFC/DTU 1A4	Frequency TOL (A-15 CARD)	.2	.7
IFM/CFR 1A2	SOT-12V Regulator (A-13 CARD)	1.2	1.16
BD 2 DFR 20/ 30A7/8	-12V Regulator (Outside)	.65	.13
IFM MUX 1A1	SOT (CARD)	.21	.93
IFM PREAMP	SOT +28V Power Supply	.48	-
SIOC 1A4	Loose Cable Connector J-8	.18	-
(V)3 TGU	SDT SSW (CARD)	-	-
Display 5A2	A/N MEMORY (CARD)	.27	.52
(V)3 XMTR	TWT (BOTTOM)	-	-
(V)3 XMTR	TWT (BOTTOM)	-	-

show repair-times about equivalent to predicted values.

#### 4.3.2 REPAIR-TIME EVALUATION BY MIL HANDBOOK PREDICTION

The maintainability prediction is provided in reference 2, Maintainability Prediction Report, CDRL A00V. The technique was based on MIL-HDBK 472. Assigned elemental task times (such as assembly/disassembly interchange times) were either taken from MIL-HDBK 472 or based on knowledge and experience with the equipment. The resultant overall MTTR from this prediction is 1.045 hours. For purposes of this study, repair-times for the corresponding blocks of Table 4-2 were extracted from the prediction and are listed in Table 4-7. The Band 1 Antenna and the Console Footswitch were assigned a repair time of 720 hours because they are not designated ship replaceable items and it was estimated the ship would return to port after 30 days.

#### 4.3.3 ESTIMATED DOWN TIME

Although support for the evaluation stage is currently being handled by the contractor, support of the deployment stage has not been defined. As a result, the current Navy support conditions applicable to the AN/WLR-1G are assumed for this study. The delay time of 49 hours estimated for the WLR-1G Receiver (Table 3-5 and section 3.3.2) was incorporated into Operational Availability calculations for the AN/SLQ-32(V)2. By adding this delay time of 49 hours to the MTTRs given in Table 4-7, the resultant MDT used in the projected field operational availability calculations is determined by ( $MDT = MTTR + \text{Delay Time}$ ).

#### 4.4 AVAILABILITY OF THE AN/SLQ-32(V)2

The same approach used for determining availability indices for the AN/WLR-1G was used for AN/SLQ-32(V)2. Predicted repair-times (MTTR) were used to calculate

TABLE 4-7

## AN/SLQ-32(V)2 PREDICTED REPAIR TIMES

<u>BLOCK</u>	<u>UNIT/SRA</u>	<u>REPAIR TIME(Hrs.)</u>
A	P/O 20A7, Band 2 Array	2.44
B	P/O 20A7, Band 2 Lenses	2.44
B	20A7,11,12 Band 2 CVR	.56
C	P/O 20A5, Band 2 Array	2.84
D	P/O 20A5, Band 2 Lenses	2.84
D	20A5 A2, Band 3 CVR	.56
E 1	P/O 20A7, 8, Band 2 DFR	1.35
E 2	P/O 20A5, 6, BAnd 3 DFR	1.51
F 1	20A3, Semi-omni	2.73
F 1	20A4, Semi-omni	2.73
F 2	Unit 22, Band 1 Antenna	720*
F 3	20A11, Band 2, 3 RF Amp	1.36
F 4	20A12, Angle Encoder	1.04
F 5	20A1, Exterior Enclosures	0.58
G 1	1A1, IFM-MPLXR	1.3
G 2	1A2, CFR	1.04
G 3	1A3, Band 1 DCU	1.01
H	1A4, Correlator	0.73
J	1A5, 7 Comp., I/O	0.89
K1	5A1, 2 Tape Trans & Console	0.69
K2	Footswitch	720*
L	Unit 11, Power Dist.	0.36

\*not repairable aboard ship

System MTTR=1.045 Hrs.



inherent availability and operational support logistics delay reflected in the WLR-1G field data (Table 3-5) was used to calculate AN/SLQ-32(V)2 operational availability. For the AN/SLQ-32(V)2 ESM, the following statement of conditions are given:

- Models used for availability for the AN/WLR-1G are also applicable to the AN/SLQ-32
- A successful mission may be achieved for the duration of the mission even though graceful degradation has occurred.
- Spares availability is such that on the average 49 hours of logistics delay occur for each failure over a 1 year period\*.

Finally, the availability calculations for the separate modes (Tables 4-8 through 4-11) were computed by means of the math models presented in Appendix D.

#### 4.4.1 DISCUSSION OF AVAILABILITY RESULTS

The resultant calculations of availability are shown in Tables 4-8 through 4-11. The change in inherent availability over the 7 to 365 days is seen to occur only for the DF mode and combined mode operation. This effect is due to the fact that the failure rate for blocks A, B, C and D are the only significant parameter changes with time. A steady state inherent availability has been reached at 7 days and only the small increase in failure rate for blocks A through D are reflected in the calculations. Because of this effect, steady state inherent availability ( $A_{I \text{ steady state}}$ ) may be approximated by the steady state equation,

$$A_{I \text{ steady state}} = \frac{MTBF}{MTBF + MTTR}$$

\*Because delay time was only known for a one year period, Operational Availability was not calculated for other periods.

TABLE 4 - 8

AN/SLQ-32(V) 2 DF Mode Availability

REL. BLOCK	DESCRIPTION	F/10 <sup>6</sup> HRS.	No. of PARALLEL PATHS	QTY USED	REPAIR TIME (HRS.)	DOWN TIME (HRS)
A	BAND 2 ANTENNA ARRAY & LENS INPUT	1.183	35/38	4	2.44	51.44
B 1	BAND 2 LENS OUTPUT	0.588	8/9	4	2.44	51.44
B 2	BAND 2 CVR	14.358	8/9	4	.56	49.56
C	BAND 3 ANTENNA ARRAY & LENS INPUT	1.183	63/66	4	2.84	51.84
D 1	BAND 3 LENS OUTPUT	0.588	16/17	4	2.84	51.84
D 2	BAND 3 CVR	10.243	16/17	4	.56	49.56
E 1	BAND 2 DFR Not in blocks A-D	18.209	0	4	1.35	50.35
E 2	BAND 3 DFR Not in blocks A-D	23.368	0	4	1.51	50.51
F 4	ANGLE ENCODER	191.877	0	2	1.04	50.04
F 5	ARRAY ENCLOSURE	34.854	0	1	.58	49.58
H	DIRECTION/FREQUENCY COORELATOR	209.957	0	1	.73	49.73
J	DIGITAL PROCESSOR & I/O	505.434	0	1	.89	49.89
K 1	TAPE TRANSPORT & DISPLAY CONSOLE	838.751	0	1	.69	49.69
K 2	FOOT SWITCH	0.145	0	1	720	720
L	POWER DISTRIBUTION BOX	58.387	0	1	.36	49.36
PARAMETER	7 DAYS	30 DAYS	90 DAYS	180 DAYS	365 DAYS	
INHERENT AVAILABILITY	.99811606	.99809068	.99809068	.99807102	.99804375	
OPERATIONAL AVAILABILITY	—	—	—	—	.82210941	

TABLE 4 - 9

## AN/SLQ-32(V)2 Frequency Measurement (Acquisition) Mode Availability

REL BLOCK	DESCRIPTION	F/10 <sup>6</sup> HRS.	No. of PARALLEL PATHS	QTY USED	REPAIR TIME (HRS.)	DOWN TIME (HRS)
F1	SEMI-OMNI ANTENNAS	1.002	0	2	2.73	51.73
F3	SEMI-OMNI PREAMPS	227.05	0	2	1.36	50.36
F5	SEMI-OMNI ENCLOSURE	34.854	0	1	.58	49.58
G1	IFM MPLXR	436.464	0	1	1.3	50.3
G2	IFM/CFR	268.811	0	1	1.04	50.04
H	DIRECTION/FREQUENCY CORRELATOR	209.957	0	1	.73	49.73
J	DIGITAL PROCESSOR & I/O	505.434	0	1	.89	49.89
K1	TAPE TRANSPORT & DISPLAY CONSOLE	838.751	0	1	.69	49.69
K2	FOOT SWITCH	0.145	0	1	720	720
L	POWER DISTRIBUTION BOX	58.387	0	1	.36	49.36

PARAMETER	7 DAYS	30 DAYS	90 DAYS	180 DAYS	365 DAYS
INHERENT AVAILABILITY	.99706320	.99706320	.99706320	.99706320	.99706320
OPERATIONAL AVAILABILITY					.87055485



TABLE 4- 10  
AN/SLQ-32(V)2 Band 1 Reception Availability

REL. BLOCK	DESCRIPTION	F/10 <sup>6</sup> HRS.	No. of PARALLEL PATHS	QTY USED	REPAIR TIME (HRS.)	DOWN TIME (HRS)
F2	BAND 1 ANTENNA	1.002	0	2	720	720
G3	BAND 1 DCU	449.18	0	1	1.01	50.01
H	DIRECTION/FREQUENCY COORELATOR	209.957	0	1	.73	49.73
J	DIGITAL PROCESSOR & I/O	505.434	0	1	.89	49.89
K1	TAPE TRANSPORT & DISPLAY CONSOLE	838.751	0	1	.69	49.69
K2	FOOT SWITCH	0.145	0	1	720	720
L	POWER DISTRIBUTION BOX	58.387	0	1	.36	49.36
PARAMETER	7 DAYS	30 DAYS	90 DAYS	180 DAYS	365 DAYS	
INHERENT AVAILABILITY	.99802220	.99802220	.99802220	.99802220	.99802220	
OPERATIONAL AVAILABILITY	—	—	—	—	.90234184	

TABLE 4 - 11

## AN/SLQ-32(V)2 System Availability

REL. BLOCK	DESCRIPTION	F/10 <sup>6</sup> HRS.	No. of PARALLEL PATHS	QTY USED	REPAIR TIME (HRS.)	DOWN TIME (HRS.)
A	BAND 2 ANTENNA ARRAY & LENS INPUT	1.183	35/38	4	2.44	51.44
B	BAND 2 LENS OUTPUT	0.588	8/9	4	2.44	51.44
B	BAND 2 CVR	14.358	8/9	4	.56	49.56
C	BAND 3 ANTENNA ARRAY & LENS INPUT	1.183	63/66	4	2.84	51.84
D	BAND 3 LENS OUTPUT	0.588	16/17	4	2.84	51.84
D	BAND 3 CVR	10.243	16/17	4	.56	49.56
E1	BAND 2 DFR Not in blocks A-D	18.209	0	4	1.35	50.35
E2	BAND 3 DFR Not in blocks A-D	23.368	0	4	1.51	50.51
F1	SEMI-OMNI ANTENNA	1.002	0	2	2.73	51.73
F2	BAND 1 ANTENNA	1.002	0	2	720	720.
F3	SEMI-OMNI PREAMP	227.05	0	2	1.36	50.36
F4	ANGLE ENCODER	191.877	0	2	1.004	50.004
F5	EXTERIOR ENCLOSURE	34.854	0	2	.58	49.58
G1	IFM MPLXR	436.464	0	1	1.3	50.3
G2	CFR	268.811	0	1	1.04	50.04
G3	BAND 1 DCU	449.18	0	1	1.01	50.01
H	DIRECTION/FREQUENCY CORRELATOR	209.957	0	1	.73	49.73
J	DIGITAL PROCESSOR & I/O	505.434	0	1	.89	49.89
K1	TAPE TRANSPORT & DISPLAY CONSOLE	838.751	0	1	.69	49.69
K2	FOOT SWITCH	0.145	0	1	720	720
L	POWER DISTRIBUTION BOX	58.387	0	1	.36	49.36
PARAMETER	7 DAYS	30 DAYS	90 DAYS	180 DAYS	365 DAYS	
INHERENT AVAILABILITY	.99565141	.99564342	.99562609	.99560648	.99557928	
OPERATIONAL AVAILABILITY	---	---	---	---	.75280336	

where values for MTBF are taken directly from the reliability block diagrams (figures 4-3 through 4-6) and the system MTTR in Table 4-7. The steady state operational availability ( $A_{o \text{ steady state}}$ ) may be approximated by,

$$A_{o \text{ steady state}} = \frac{MTBF^1}{MTBF^1 + MDT}$$

where values for  $MTBF^1$  and MDT must be derived from the parameters listed in Tables 4-8 through 4-11. The derivation is shown below and the results given for only the combined mode (Table 4-11).

The DF Mode (bands 2 and 3) has the highest inherent availability figure due to the antenna array redundancy. The redundancy results in a failure rate that is lower than for the Frequency Measurement Mode or Band 1 Reception Mode.

The Operational Availability for Band 1 Reception is seen to be the highest of the three modes of operation for the AN/SLQ-32(V)2. It is interesting to note that although inherent availability is highest for the DF Mode (bands 2 and 3), operational availability is not. The reason for this effect is due to the assumptions made for operational availability, i.e., operational availability requires total system (or mode) fully up. Thus, all the blocks become series paths. To have the entire system, for example, in a fully operational condition, all block failure rates in Table 4-11 are summed and found to be 5783 failures/ $10^6$  hours, or, 173 hour MTBF. The associated MDT is found to be 50 hours by taking the average of the failure-rate-weighted down times in Table 4-11, and, the approximate steady state operational availability is;

$$A_{o \text{ steady state}} = \frac{MTBF^1}{MTBF^1 + MDT} = \frac{173}{173 + 50} = 0.776$$



The added effect of using non-ship-repairable items (band 1 antenna and the foot switch) may be assessed by comparing the inherent availability for Band 1 Reception (Table 4-10) with the availability computation excluding the two items. Band 1 Reception availability for a 7 day period and excluding blocks F2 and K2 in Table 4-10 is 0.99834522 compared to 0.9980222 for the complete Band 1 availability in Table 4-10. The effect would be even less for the other modes considered.

## 5.0 RESULTS AND CONCLUSIONS

The objective of this study was an attempt to form the most representative availability models of the AN/WLR-1G and the AN/SLQ-32(V)2 in order to obtain insight into the areas that significantly affect availability of an ESM equipment. By concentrating on these areas, future improvements to ESM availability may be pursued in an effective manner. In this regard, the current study will serve as a "baseline" for the ESM Availability Improvement Program.

### 5.1 LIMITATIONS TO AVAILABILITY OF THE AN/WLR-1G and AN/SLQ-32

#### A. Inherent Availability

Inherent availability is a function of both failure rate and MTTR. Thus, improvements in inherent availability must necessarily start with these factors while insuring that the stated ESM performance goals are not degraded.

In the AN/WLR-1G any improvements to inherent availability is related mainly to replacing the IP-480 by a state-of-the art IF processor and display unit. No significant improvement in inherent availability could be achieved by merely making internal modifications to the IP-480; a complete technology shift from vacuum tubes and RV resistors and CRT displays is required. In addition, circuit redundancy and self-test features throughout the AN/WLR-1G is lacking. These features should be added for additional improvement in inherent availability. A course estimate of the boundry of improvement to be expected by a new IP-480 design would be about a maximum of 144 hour MTBF for the Combined Mode (from 106 hours), assuming that the new IP-480 would have a failure rate of 1000 failures/ $10^6$  hours rather than 3490 f/ $10^6$  hours shown in figure 3-6. The power supplies and Frequency Converter (CV-742) could be improved similarly (to failure rates of 1000 and 500 failures/ $10^6$  hours for power supplies and

CV-742 respectively). Assuming replacement (collective improvement) of these items, the overall maximum expected system MTBF would be approximately 193 hours.

If an overall maximum MTBF of 193 hours is obtained this would (using an MTTR of 3.35 hours from Table 3-6), enhance availability as follows:

$$A_{\text{steady state}} = \frac{\text{MTBF}}{\text{MTBF} + \text{MTTR}} = \frac{193}{193 + 3.35} = 0.983^*$$

The study of the AN/SLQ-32(V)2 has shown that although the complexity is high, the predicted reliability is also reasonably high. This is not meant to imply that it could not be significantly improved. The primary reason for its higher reliability is the application of digitized circuitry with its low power, low failure rate IC circuitry.

As the SLQ-32(V)2 now exists, an inherent availability of approximately 0.996 is realized. This value may be approximated by the equation,

$$A_{\text{steady state}} = \frac{\text{MTBF}}{\text{MTBF} + \text{MTTR}} \quad (5-1)$$

For an MTBF of 259 hours and an MTTR of 1 hour,

$$A_{\text{steady state}} = \frac{259}{260} = 0.996$$

In order to realize an inherent availability of 0.998, the reliability must be doubled;

$$\text{MTBF} = \text{MTTR} \left( \frac{A}{1-A} \right)_{\text{steady state}} = 1.0 \left( \frac{.998}{.002} \right) = 499 \text{ hours}$$

It is very unlikely that the SLQ-32(V)2 reliability could be doubled merely by a design change, lowering stress levels or effecting parts quality improvement. Added redundancy would probably be the most feasible method of design change to improve the MTBF.

\*Compared to results of 0.968 from Table 3-10.



Improving availability in either the AN/SLQ-32(V)2 or the AN/WLR-1G by improving maintainability may be seen as being less practical, even for the AN/SLQ-32(V)2.

For example:

$$MTTR = MTBF \left( \frac{1-A}{A} \right) \text{ steady state} = 259 \left( \frac{.002}{.998} \right) = 0.52 \text{ hours}$$

An MTTR of 0.5 hours is probably not feasible without a considerable amount of added built-in self test and re-packaging exterior equipment.

#### B. Operation Availability

Operational availability is a function of support and logistics in addition to failure rate and MTTR. Thus it relates to equipment design and established logistics support.

Study of the field data for the WLR-1G system showed logistics delay time (Table 3-5) accounting for most of the operational down time. This observed delay time so overwhelms the inherent repair time that it would seem futile to attempt improving the design. This conclusion, however, may not necessarily be the correct conclusion. Logistics delay may be the time spent awaiting parts, time spent awaiting technical assistance or time spent awaiting test equipment. Most often delay time is the time spent awaiting parts. The 3-M data showed that nearly 50% of the parts demanded were not on-board when required -- tubes being the highest in demand for that time period. This condition is indicative of supply constraints. No matter what is done to the design, short of making it self-healing, no significant improvement would be realized in availability with such a high delay time.

Finally, the 3-M data indicated that some parts designed into the equipment are not readily available. That is, parts are either non-standard or require unique manufacturing processes such as the gearing in the antenna or the RF modules in the tuners.

Although the parts may be obtained, often long lead times are required because a manufacturer discontinues production or is not always in production. Design of equipment with many unique or non-standard parts, therefore, may result in promoting long delays in logistics.

No reason could be found in the research of the 3-M data as to why supply line conditions exhibit the relatively long delays. It is the writer's opinion that this delay time is more representative of day to day activities where little or no priority is assigned to obtain replenishments. For those failures where mission operation was critical, a normal system of priority in the naval supply system would expedite the required material at a faster rate than normal. An in-depth study of CASREP data would be required to determine if, in fact, a problem of long delay time does exist in the supply system when priority requisitions are involved.

Nevertheless, it is clear that operational availability for both the AN/WLR-1G and the AN/SLQ-32(V)2 is impacted most by delay time. Clearly replenishment support must be improved and a philosophy implemented to ensure that standard parts are used as much as possible in ESM design.

## 5.2 AVAILABILITY GUIDELINES FOR FUTURE ESM

The results in section 5.1 based on a review of the AN/WLR-1G and the AN/SLQ-32(V)2 indicate that achieving an MTBF of 500 hours and an MTTR of 0.5 hours may represent upper limits. These data are tabulated in Table 5-1 to show the effects upon availability.

TABLE 5 - 1

Probable Achievable Ultimate ESM Availabilities

<u>MTBF</u> <u>(hours)</u>	<u>MTTR</u> <u>(hours)</u>	<u>Availability</u>	<u>Difficulty</u>
250	1.0	0.996	modest
250	0.5	0.998	hard
500	1.0	0.998	hard
500	0.5	0.999	very hard



Design efforts to obtain these goals must consider the following:

1. Use of self-test features
2. Use of standard components based on a low failure rate technology
3. Implementation of redundancy -
  - a. Adoption of techniques (for example: antennas) wherein performance "gracefully" degrades with component failure.
  - b. Separation of performance functions into several modes of operation wherein failure of one mode would still permit mission success in some acceptable degraded capability
4. Quality Assurance and Quality Control during the procurement and development stages
5. Mechanical design to facilitate access and to minimize environmental effects

### 5.3 RECOMMENDATIONS

The following studies are proposed based upon conditions discovered during reliability analysis of the AN/WLR-1G and the AN/SLQ-32(V)2:

1. Study of CASREPS to determine if supply line constraints are causing unnecessary down time.
2. Study of the CV-3599 replacement for the CV-741 and CV-742 to determine its effect on AN/WLR-1G MTBF.
3. Study of the feasibility of replacing the IP-480 and Power Supplies (PP 21560 and PP 2157D).
4. Study of the AS-899 Antenna drive train mechanization to determine what may be causing coupling failures.
5. Study of the CV-1162A Tuner regulator to determine what may be causing abnormal high failure rate.

The studies are proposed in the order of priority. However, it has been indicated that data may be currently available that would minimize the extent of studies 2 and 3.

## GLOSSARY OF ABBREVIATIONS

CASREP	Casualty Report
CDRL	Contract Data Requirements List
CFR	Coarse Frequency Receiver
CIC	Combat Information Center
DCU	Digital Control Unit
IFM	Instantaneous Frequency Measuring (Receiver)
MDT	Mean Down Time
MTBF	Mean Time Before Failure
MTTR	Mean Time To Repair
Mux	Multiplexer
PMS	Planned Maintenance Sub-system
RAC	Reliability Analysis Center (Ref 6)
RMA	Reliability, Maintainability and Availability
SRA	Ship Repairable Assemblies
MIL-HDBK	Military Standardization Handbook
Mag Amp	Magnetic Control Amplifier (AM-1017)
RF SW	Radio Frequency Switch
RV	Resistor, Variable
P/O-WLA-3B	Part of AN/WLA-3B

#### REFERENCES

1. Technical Manual, Organizational and Intermediate Maintenance With Parts List, AN/SLQ-32(V) Countermeasures Set, Document No. 061290633, 1 September 1978.
2. Maintainability Analysis And Prediction Report, CDRL NO. A00V, Raytheon Document No. 0612900626, 30 July 1978.
3. DTPEW System Techeval RMEA Final Report, prepared by Columbia Research Corporation for NAVELEX PME 107 under Contract N00189-77-C-0207, 7 March 1977.
4. Reliability Prediction Report, CDRL A00N, Raytheon Document No. 061290625, 15 July 1978.
5. Handbook, MIL-HDBK-217B, Reliability Prediction of Electronic Equipment
6. Nonelectronic Parts Reliability Data, Published by Reliability Analysis Center, Order Number NPRD-1.
7. Mechanical Design and Systems Handbook , Harold Rothbart, McGraw Hill, 1965.



—APPENDICES TO REPORT  
ON AVAILABILITY STUDY OF  
THE WLR-1G AND SLQ-32(V)2 ESM SYSTEMS

CDRL A001

CONTRACT NO. N66001-78-C-0318

## CONTENTS

	Page
APPENDIX A: 3-M FIELD DATA WORKSHEETS . . . . .	1
APPENDIX B: AN/WLR-1G RELIABILITY PREDICTION WORKSHEETS .	17
APPENDIX C: AN/WLR-1G MAINTAINABILITY PRODUCTION WORKSHEETS . . . . .	190
APPENDIX D: AVAILABILITY MATH MODELS. . . . .	235

Appendix A is a collection of the new 3-M data to indicate relationships between the various assemblies and their parts. The data is for 3-M-10 receivers only and is arranged by year and assembly unit number. Assembly (\*) by the one-hour indicator line. The data is arranged with the top receiver number. The "3-M" column indicates the relationship between the receiver number and the assembly unit number. The receiver number will be the same.

# APPENDIX A

## 3-M FIELD DATA WORKSHEETS



Appendix A is a reduction of the raw 3-M data to identify maintenance actions to units, assemblies and repair-time. The data is for WLR-1G receiver only and is arranged by year and ascending unit number. An asterisk (\*) by the man-hours indicates time spent on several actions with that job sequence number. The "REF" column references the maintenance action. For actions taken where more than one replacement occurs, the reference number will be the same.

# SW DATA ANALYSIS

UNIT	CIRCUIT SYMBOL	MAN HOURS	A	PROBLEM	COPIES				REMARKS
					300	400	500	300	
1	A2245	9*	CV64		2	1	2	7	7
4	A3VI	6	DO948		2	1	-	7	13
5	A1521	-	CV64		-	-	-	-	5

10-1-10

DATE	EVENT	WIND HOURS	SHIP	REMARKS	300	400	500	600	700	800	900	TOTAL
12	A13 R10	9*	CV64		2	1	2	7	1			7
..	A1V3	4	DDG 13		2	1	-	7	1			18
16	V4, V6, V12, T1	4*	FRG 2		2	1	2	5	2			21
17	H19	9*	DDG 51		2	1	-	7	2			16
19	A1X Y2, Y2	4*	DDG 51		2	1	-	7	2			16



# SEM BIN ANALYSIS

WILSON

W	CONCUT CYCLES	WAS HOURS	SWT	PROBLEM	300	40	DOES	JUL	3AS	REF.
1A1	CR1	5	DD 951	POURING INSPECTION, NORMAL WORK, REWORK CAPABILITY	4	1	-	7	3	31
3A1	CR1 RICR1 ABV1 RICR1	1 1 - -	DD 951 CG 18 DD 845 CG 21		6 2 - -	1 1 - -	- - - -	7 7 - -	1 3 - -	33 141 131 167
4A1	CR1 VI	5 8	DG 12 DG 12		3 3	1 1	2 -	7 7	3 1	64 65
5A1	ALV2 - USE	1 *	CG 27		2	3	-	7	2	173

WAVE 15

WAVE 15

WAVE	TEST POINT	WAVE HOURS	UNIT	PROBLEM	300	400	500	300	300	REF
106	A4V1	2	SSN 578		2	1	1	7	3	95
	CR. 1 OSC	12	CG 19	BAU CAVITY IN BAND 6	2	1	2	0	3	157
	A4V1 TUBEL	1 *	CG 27		2	3	1	7	2	173
	A5A1V1	20	CG 27		2	1	1	7	3	181
107	R2	4	DD951		2	2	1	7	3	35
	A8 R1	4	DC 7	VOLT METER SHORTED	6	1	1	7	1	52
	A3C21	2	SSN 578		2	1	1	7	3	97
110	A2Y6, Y10	50 *	DD 948		1	1	1	1	2	25
	IF STRIP	8 *	DS 12	WAVE 15 STRIPS	3	3	1	7	2	58
	A1V3V10	2	CG 18		2	1	1	7	1	148
	A1V3	1	DD 951		1	1	1	1	1	32

112

DATE	ACCOUNT	VAR. HOURS	EST.	DESCRIPTION	300	400	500	600	700	800	900	1000	1100	1200	1300	1400	1500	1600	1700	1800	1900	2000	TOTAL
A9	A5 VR2	-	2001																				38
A10		-	2607 CG21																				54 164
A13	G1 R35	-																					183 165





PERIOD: 1975

WLN 11

S	CIRCUIT SYMBOL	WASD HOURS	SLIP	PROBLEM	3AD	40	3AD	3AD	REF
A11	V11, TUBE 572	50 *	DD 948		1	1	1	2	35
	P216, L15 L14	- *	DS 07		-	-	-	-	54
	A101	8	DS 12		1	-	7	3	5960
	IF STRIP	8 *	DS 12	ALIGN IF STRIP	3	3	7	3	68
	A113	10	CS 28		2	1	7	3	187
A12	1351	43	DD 951	SHORTED RELAY	2	1	2	3	37
	A1501	30	DS 6		1	1	7	1	40
	A13 27	3	DS 12		2	1	7	3	59
	3UR	1	DS 12		2	1	2	3	58
	A13 R10	10	DS 12		1	1	7	3	62
	A13 31	-	DS 14		-	-	-	-	70
	SHIELD, A15P1, A15P2, J1, A15P3, BAND 7	2			3	-	0	2	73
	A4V1	60	CS 18		2	1	7	1	150
	A12B1	1	CS 19		2	-	0	3	156
	12A1	2	CS 28		2	1	7	3	183
	12A13B1	10	CS 28		2	1	7	3	186

WLT 10

U -	CIRCUIT SYMBOL	MAN HOURS	SH. A	PROBLEM	300	300-0	300-1	300-2	300-3	REF
12 (cont)	A13B1	-	DDG 7		1	1	1	1	1	52
..	A2CR1	-	DD845		1	1	1	1	1	132



# 5 MIN. TYPING ANALYSIS

UNIT	CIRCUIT SYMBOL	MAN. HOURS	SHIFT	PROBLEM	303	CODES A I PER	303	REF.
1	1A1L26	30	DDG 6		6	2	6	62
1	1A1A	18	DDG 18		6	2	2	137
1		2*	DDG 18	REPAIR CV732	2	1	7	184
1		13*	FF1045	BAND 1 INOP.	4	2	6	268
2		35	CG 28	PROSELYTOR BAND 2	4	1	7	253
2		2*	DDG 18	REPAIR CV733	2	1	7	184
3	CV734	12	CG 17	3A2 DEFECTIVE	6	2	7	215
5	SVI	26	DDG 6		2	1	7	65
7	7A4	11	DDG 7		6	1	7	73
7		1	CG 19	WAVEGUIDE BAND 7 WLR-18	4	6	1	222
7		13*	FF 1045	BAND 7 INOP.	4	1	6	268

UNIT	CIRCUIT SYMBOL	MAN HOURS	SHIFT	PROBLEM	300	GOODS	400	500	300	REF.
8		2.1	7:00-9	MIXER BLOCK BAD	1	1	2	7	3	79
8	2A5A1VR2	7	7:00-13		2	1		7	3	112
9	9A5A1CK5 9A5A1VR1 9A5A2Q1	6	DDG7	BAD IC IN 9AS SUBASSY.	2	1		7	3	71
9	9A5VR2	14	DDG51		2	1		7	1	43
9	MIXER ASSY. 9A4Y1	14	DDG12	BAND 9 OFF FREQ. 9A4Y1	4	1	1	7	2	89
9	9A4Y1	3	7:00-12		2	1		7	3	100
9	9A5A1	3	7:00-12		2	1		7	3	140
10	10A1V1V9	57*	DDG7		2	1		7	2	75
10		11	7:00-7	ALIGNED CV7+1	2	2		7	3	76
10	10A1V1 9A10 235 3106 9A05 452 6320 5950 617 9576 (2-11-7)	30	CG28		6	1		7	1	257
11	11A1V 11A2V 43505 007 2445 (2-11-7) 43 415 245 2209 (2-11-7)	56	FFG2	AMP BAD	6	1	4	7	3	162

WLR-16

1716 JAN - 21/71

UNIT	CIRCUIT SYMBOL	WAND HOURS	GR 7	PROBLEM	300	COPIES	JUL	3AM	REF
12	12A13R1	8	DDG12		2	1	7	1	109
12	12T3	1	FFG1	REFUGEE T3 UNIT 12	3	2	7	3	153
12	12CRS 12-1	12	SD1571		1	3	2	1	112
12	12A3R381	2*	CEN25		6	1	7	3	222
12	12A1V1	2	CEN25		2	1	7	1	222



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AVAILABILITY STUDY OF THE AN/WLR-1G AND AN/SLQ-32(V)2 ELECTRONI--ETC(U)  
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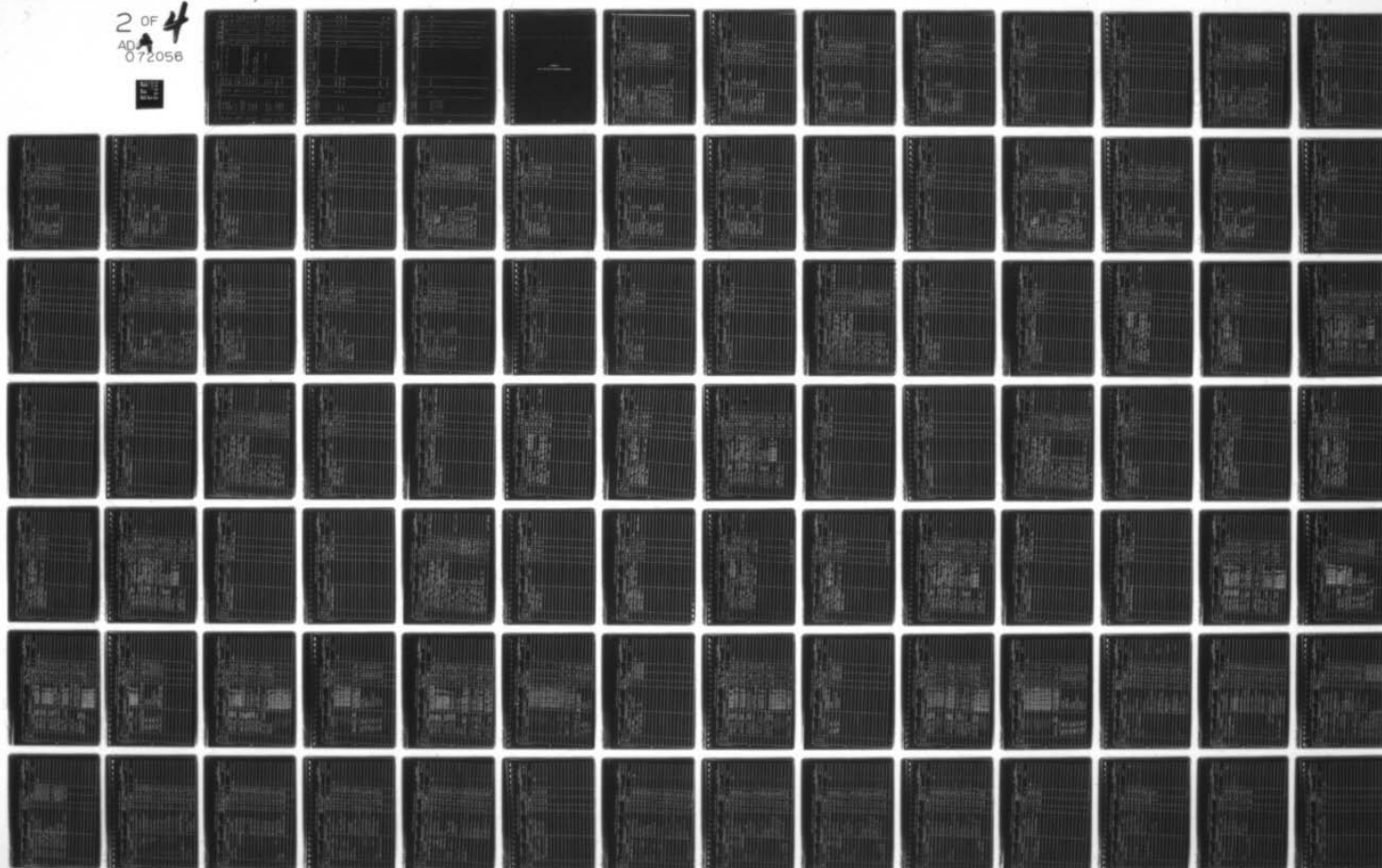
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7205

WLD 10

UNIT	CIRCUIT SYMBOL	WASD HOURS	CHIP	PROBLEM	300	SCHEM'S A TO	300	REF
12	12A2V2	2	DD948	B1 DEFECTIVE VERT SCAN	2	1	2	22
12	12A12B1	4	DD948		2	2	3	29
12	12A12B1 12A	4	DD66		6	1	3	52
12	12A13	24	DD66		2	1	3	61
12	12A1A1V3 12A1A4V1	4	DD612	REPLACE 12A1A1V3 & 12A1A4V1 VILP-12 STORAGE CHAN. BROKEN	2	1	1	101
12		6	DD612		2	2	1	107
13		6	DD948		2	1	3	27
13	13A4S11	2	DD615		2	1	3	112
13	13A1K1	9	DD836	13A1K1 FAILED C-2697 DEFECTIVE	5	1	3	126
13	13A1G1	16	CG17		2	3	1	214
15		34	DD68	CIRCUIT BOARD PP-2156	3	1	2	77
15	15A17P13	6	CG17		7	1	1	212
15	15V10	6	CG21		1	1	3	223
16	16XVS 16R32 16C36	57*	DD67		2	1	2	75
16		15	CG28		2	1	1	262



UNIT	CIRCUIT SYMBOL	MAN HOURS	SHIFT	PROBLEM	340	345	346	347	348	REF
17	17K28	3	DD948		2	1	1	1	3	31
19		2	DD818	REPAIR SE-133 AC LINE	3	1	1	1	2	183
19	19A1T1	2	CEN 25		6	1	1	1	3	222
19	19Y1	2	CEN 25		2	1	1	1	3	230
30	30MPX 30MP9 30MP10	30	DD66	REPLACE SYNC AMP PART	2	1	2	1	3	54
20	20MP12 20MP21 20MP22	2	DD612		6	1	1	1	1	93

UNIT	CIRCUIT SYMBOL	MAN HOURS	SHIFT	PROBLEM	300	92-0	92-0	300	REF.
31	31A.1V3 524 229 1009 524 578 1652 1405 405 0577 221 949 1432	4	800512		2	1	7	2	106

APPENDIX B

WLR-1G RELIABILITY PREDICTION WORKSHEETS



SYSTEM:		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:		SUBASSEMBLY:	DATE	SHEET
WLR-16					1	CV-7328			0/25/78	1 OF 1
INDEX NUMBER	DEVICE IDENTIFICATION				QUANTITY N	FAILURE RATE %	NA	REMARKS		
	NOMENCLATURE	NUMBER								
	ADAPTER, COAXIAL				2	1.1	2.2	N/S		
	FILTER, BANDPASS				2	.066	.132	"		
	CONNECTOR, PANEL				1	.56	.56	"		
	RESISTOR		RA		3	8.6	25.8	"		
	CAPACITOR		RV		1	22.0	22.0	"		
	SWITCH, SENSITIVE				2	1.1	2.2	"		
	TRANSFORMER, PWR.				1	.064	.064	"		
	PREAMPLIFIER ASSY.		A1		1	55.467	55.467	"		
	IF PREAMP. ASSY.		A2		1	113.346	113.346	"		
	OSCILLATOR ASSY.		A3		1	36.563	36.563	"		
	SERVO DRIVE ASSY.		A4		1	55.472	55.472	"		
	MAN, TUNE DRIVE ASSY.		A6		1	1.74	1.74	"		
	COUPLING ASSY.		A8 + A9		2	NEG.	NEG.	"		

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/25/78

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:
WLR-16				1	A1	
			CN-732A			
			PRESECTOR			
						SHEET 1 OF -

[illegible]

5547

DATE 10/25/78

DATE 10/25/78

WLR-16

SUBSYSTEM:

EQUIPMENT:

**GROUP:**

UNIT. 1

ASSEMBLY: A

100

SHEET 1 OF 3

[illegible]



DATE 10/25/15

[illegible]

36.563

DATE 10/25/18

...

55.472





# INTERVIEW RELIABILITY ANALYSIS WORKSHEET

[illegible]

312.395 WTBF = 3210 HRS.

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/25/78

SYSTEM: WLR-16	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 2	ASSEMBLY: A1 PRESELECTION	SUBASSEMBLY:	SHEET 1 OF 2
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[illegible]





## DATE 10/25/78

DATE 10/25/78

[illegible][illegible]



## DATE 10/25/78

DATE 10/25/78[illegible]



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/25/78

SYSTEM: WLR-16		SUBSYSTEM:		EQUIPMENT:		GROUP:		UNIT: 3		ASSEMBLY:		SUBASSEMBLY:		SHEET 1 of 3	
INDEX NUMBER	DEVICE IDENTIFICATION		QUANTITY N	FAILURE RATE λ	HA	REMARKS									
	NOMENCLATURE	NUMBER													
	ADAPTER, COAXIAL		2	1.1	2.2	NS									
	FILTER, BANDPASS		2	.066	.132	"									
	CONNECTOR, BACK & PANEL		1	.56	.56	"									
	RESISTOR	RA	3	8.6	25.8	"									
	RESISTOR	RN	1	22.0	22.0	"									
	SWITCH, SENSITIVE		2	1.1	2.2	"									
	TRANSFORMER, PWR.		1	.064	.064	"									
	PREFELECTOR ASSY.	A1	1	21426	21426	"									
	IF PREAMP. ASSY.	A2	1	145.764	145.764	"									
	OSCILLATOR ASSY.	A3	1	32.537	32.537	"									
	SERVO DRIVE ASSY.	A4	1	55.472	55.472	"									
	MAN. TUNE DRIVE ASSY.	A6	1	1.74	1.74	"									
	COUPLING ASSY.	A8+A9	2	NEG.	NEG.	"									

DATE 10/25/78

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## DATE 10/25/78

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## DATE 10/25/72

DATE 10/25/72[illegible]

DATE 10/25/78

DATE 10/25/78

[illegible][illegible]



# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: VLR-16		SUBSYSTEM:		EQUIPMENT:		GROUP:		UNIT: 4		ASSEMBLY:		SUBASSEMBLY:		DATE: 10/25/78		SHEET 1 OF 1	
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE %	NA	REMARKS										
	NOMENCLATURE	NUMBER															
	ADAPTER			1	1.1	1.1	NS										
	FILTER LOWPASS			2	.066	.132	"										
	CONNECTOR BACK			1	.56	.56	"										
	RESISTOR	RA		3	8.6	25.8	"										
	RESISTOR	RV		1	22.0	22.0	"										
	SWITCH, SENSITIVE			2	1.1	2.2	"										
	SWITCH, PUSH			1	.46	.46	"										
	TRANSFORMER			1	.064	.064	"										
	PREFELECT- OSC. ASSY.	A1		1	58.483	58.483	"										
	IF PREAMP. ASSY.	A2		1	141.326	141.386	"										
	SERVO DRIVE ASSY.	A4		1	55.472	55.472	"										
	OSC. ARM. ASSY.	AL		1	2.10	2.10	"										
	GEAR, SPUR	240T, ALUMINUM		1	1.74	1.74	"										
	SPRING, EXTENSION	SPRING STEEL		3	.02	.06	"										
	BALL BEARING			2	.70	1.40	"										
	GEAR	188T		2	.236	.472	"										











# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/78

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	SHEET
WLR-16				CV-736A			1
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY 'N	FAILURE RATE 'X	'NA	REMARKS
	NOMENCLATURE	NUMBER					
	ADAPTER			1	1.1	1.1	NS
	LAMP			1	1.0	1.0	"
	FILTER			2	.066	.132	"
	CONNECTOR RACK & PANEL			1	.56	.56	"
	CONNECTOR, COAX.			1	1.1	1.1	"
	PIEDESTAL	RA		1	8.6	8.6	"
	RESISTOR	PN		3	22.0	66.0	"
	RESISTOR	RCR		2	.0077	.015	
	RESISTOR, PRECISION			1	6.1	6.1	"
	SWITCH, SIGNATURE			2	1.1	2.2	"
	SWITCH, TOGGLE			1	.68	.68	"
	SWITCH, PUSH			1	.46	.46	"
	TRANSFORMER, PWR.			1	.064	.064	"
	TUBE, RECT.	0B2		3	65.0	195	"
	TRANSFORMER ASSY.	A1		1	23.608	23.608	"
	IF AMPLIFIER ASSY.	A2		1	140.726	140.726	"
	OSCILLATOR ASSY.	A3		1	197.54	197.54	"





DATE 10/26/78

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DATE 10/26/78

3-4-15

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/78

ASSEMBLY:

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# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: WLR-16	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 6	ASSEMBLY:	SUBASSEMBLY:	DATE: 10/26/78	SHEET 1 of 1
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## DEVICE IDENTIFICATION

INDEX NUMBER	NOMENCLATURE	NUMBER (QTY.)	QUANTITY N	FAILURE RATE λ	HA	REMARKS
	ATTN. CAX.	RD	1	1.5	1.5	NS APPROX. 100KΩ, 1/2
	CONNECTOR PANEL	4 CONTACTS - 15A 500V 16 CONTACTS - 5A RMS	1	.56	.56	"
	WHEEL, FLAP. TIME	32 115V 60Hz	1	10.0	10.0	"
	RESISTOR PRECISION	32 137K ±3% 105V (1) R4 LAYSAN 252A (2)	3	22.0	66.0	"
	SWITCH, TOSGLE	2 POS. 220VAC 9AMP.	1	.68	.68	"
	TRANSFORMER, PAR.	PR. 109V-131V 47-63Hz SEC. 16V .35ARMS 46V .2ARMS	1	.064	.064	"
	PRESTRICTOR ASSY	A2	1	3.70	3.70	"
	MIXER ASSY.	A3	1	89.0	89.0	" ONE UNIT, NO PAR-
	OSCILLATOR ASSY.	A4	1	30.412	30.412	"
	POWER SUPPLY ASSY.	A5	1	32.341	32.341	"
	GEAR DRIVE ASSY.	A6	1	59.132	59.132	"
	GEAR, ASSY.	A7	1	48.871	48.871	"
	FRONT PANEL ASSY.	A8	1	NEG.	NEG.	"
	PRESEL. CAM ASSY.	A10	1	8.80	8.80	"
	OSC. CAM ASSY.	A11	1	12.0	12.0	"
	GEAR, SPUR		2	1.74	3.48	"



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DATE 10/26/78

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# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/78

SYSTEM:		SUBSYSTEM:		EQUIPMENT:		GROUP:		UNIT:		ASSEMBLY:		SUBASSEMBLY:		SHEET	
WLR-16								CV-1159A		PREAMP.				1 of 1	
INDEX NUMBER	NOMENCLATURE			DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	NA	REMARKS					
	NUMBER (QTY)														
	CAPACITOR	GLASS VAR.	1.0-10.0 PF 100VDC @ 1MHz CK60AN102M (9)	(5)			5	2.7	13.50	NS					
	CAPACITOR		CK				9	.44	3.96	"					
	CAPACITOR	FIXED CERAMIC	FEEDTHRU 470mF ±20% 500VDC	(4)			4	.44	1.76	"					
	CAPACITOR	MICA	CMOSC100K03 (3) CMOSC050K03 (1)				4	.078	.312	"					
	CAPACITOR	FIXED GLASS	10mF 0.25mF TOL. (4) 500VDC				5	.25	1.25	"					
	CAPACITOR	FIXED CER.	DIELECTR STANDOFF 470mF ±20% 500VDC	(7)			7	.44	3.08	"					
	CONNECTOR	COAX.	UG-477/U UG-535/U				2	1.1	2.2	"					
	COIL	RF	CERAMIC SLUG TUNED				4	.066	.264	"					
	CHOKE	RF MOUNTED	150mH (4) .22mH (1)				7	.066	.462	"					
	TRANSISTOR	PNP GER.	2N2997				3	3.5	10.5	"					
	TRANSISTOR	PNP GER.	2N2996				3	3.5	10.5	"					
	RESISTOR		RC07GF472K (10) RC07GF132K (5) RC07GF271K (1) RC07GF562K (1) RC07GF222K (1) RC07GF470K (5)				21	.039	.819	"					
	TRANSFORMER	ASSY.					3	.066	.198	"					
	RESONATOR	METAL					1	.066	.066	"					







# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/24/72

SYSTEM	SUBSYSTEM	EQUIPMENT	GROUP	UNIT	ASSEMBLY	SUBASSEMBLY	SHEET
WLR-10				7	CN-1160A		1
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE $\lambda$	HA	REMARKS
	NOMENCLATURE	NUMBER					
	ATTN. COAX.	RD		1	1.5	1.5	NS APPROX. 100K, 1/2
	CONNECTOR RACK & PANEL	4 CONTACTS - 15A 500V 16 CONTACTS - 5A RMS		1	.56	.56	"
	METER, ELAP. TIME	30 115V 60 HZ		1	10.0	10.0	"
	RESISTOR PRECISION	30 137K $\pm 3\%$ 105V (1) RV4LAYS A252A (2)		3	22.0	66.0	"
	SWITCH, TACTILE	2 POS. 220VAC 9 AMP.		1	.68	.68	"
	TRANSFORMER, PUR.	PRI. 109V-131V 47-63 HZ SEC. 15V .35ARMS 46V .2ARMS		1	.064	.064	"
	PRESELECTOR ASSY	A2		1	3.70	3.70	"
	MIXER ASSY.	A3		1	89.0	89.0	" ONE UNIT, NO PLS
	OSCILLATOR ASSY.	A4		1	30.412	30.412	"
	POWER SUPPLY ASSY.	A5		1	32.341	32.341	"
	GEAR DRIVE ASSY.	A6		1	59.132	59.132	"
	PREAMP. ASSY.	A7		1	48.871	48.871	"
	FRONT PANEL ASSY.	A8		1	NEG.	NEG.	"
	PRESEL. CAM ASSY.	A10		1	12.8	12.8	"
	OSC. CAM ASSY.	A11		1	12.0	12.0	"
	GEAR, SPUR.			2	1.74	3.48	"
				SUM OF	N $\lambda$ 's = 370.540		WTBF = 2.699 HRS



DATE 10/26/78DATE 10/26/78[illegible][illegible]







# IMPROVING RELIABILITY ANALYSIS WORKSHEET.

DATE 10/26/78

**SUBASSEMBLY:**

13385

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# INDEPENDENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/78

SYSTEM:		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	SHEET	
VLR-16					CV-1160A	PREAMP.		1	
INDEX NUMBER	DEVICE IDENTIFICATION				QUANTITY N	FAILURE RATE λ	HA	REMARKS	
	NOMENCLATURE	NUMBER	(QTY)						
	CAPACITOR, GLASS VAR.	1.0 - 10.0 PF 100VDC @ 1MHz	(5)		5	2.7	13.50	NS	
	CAPACITOR	CK CKLOANW102M (9)			9	.44	3.96	"	
	CAPACITOR, FIXED CERAMIC	FEEDTHRU 470nF ±20% 500VDC	(4)		4	.44	1.76	"	
	CAPACITOR, MICA	CMOSC100K03 (3) CMOSC050K03 (1)			4	.078	.312	"	
	CAPACITOR, FIXED GLASS	1.0nF 0.125nF TOL. (4) 500VDC 2.2nF (1)			5	.250	1.25	" CY	
	CAPACITOR, FIXED, CER.	DIELECT STANDOFF 470nF ±20% 500VDC	(7)		7	.44	3.08	"	
	CONNECTOR, COAX.	VG-477/U VG-535/U			2	1.1	2.2	"	
	COIL, RF	CERAMIC SLUG TUNED			4	.066	.264	"	
	CHOKE, RF MOLDED	150nH (4) .22nH (1)			7	.066	.462	"	
	TRANSISTOR, GER. PNP	2N2997			3	3.5	10.5	"	
	TRANSISTOR, GER. PNP	2N2996			3	3.5	10.5	"	
	RESISTOR	RC070F 472K (10) RC070F 122K (5) RC RC070F 221K (1) RC070F 562K (1) (1) RC070F 222K (1) (1) RC070F 470K (3)			21	.039	.819	"	
	RF TRANSFORMER ASSY.				3	.066	.198	"	
	RESONATOR, HELICAL				1	.066	.066	"	
					SUM OF	NA	48.871		







# INTERMITTENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/78

SYSTEM: WLR-16		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 8	ASSEMBLY:		SUBASSEMBLY:		SHEET 1						
INDEX NUMBER	NOMENCLATURE		DEVICE IDENTIFICATION		NUMBER (QTY)	QUANTITY N	FAILURE RATE %	RFA	REMARKS							
	ATTN. COAX.	CONNECTOR PANEL	METER, ELAP. TIME	RESISTOR PRECISION						SWITCH, TOGGLE	TRANSFORMER, PWR.	PRESSELECTOR ASSY	MINER ASSY.	OSCILLATOR ASSY.	POWER SUPPLY ASSY.	GEAR DRIVE ASSY.
	ATTN. COAX.	RACK & PANEL	RD	4 CONTACTS - 15A 500V 16 CONTACTS - 5A RMS	1	1	1.5	1.5	NS APPROX. 100KΩ, 1/2							
	CONNECTOR PANEL			3W 115V 60 Hz	1	1	1.56	1.56	"							
	METER, ELAP. TIME			3W 13.7K ±3% 105V (1) RV4LAYS A252A (2)	3	3	10.0	10.0	"							
	RESISTOR PRECISION			2 POS. 220VAC 9 AMP.	1	1	22.0	66.0	"							
	SWITCH, TOGGLE			PRI. 109V-131V 47-63 Hz SEC. 16V .35ARMS 46V .2A RMS	1	1	.68	.68	"							
	TRANSFORMER, PWR.				1	1	.064	.064	"							
	PRESSELECTOR ASSY		A2		1	1	3.70	3.70	"							
	MINER ASSY.		A3		1	1	89.0	89.0	" ONE UNIT, NO PWR							
	OSCILLATOR ASSY.		A4		1	1	5.21	5.21	"							
	POWER SUPPLY ASSY.		A5		1	1	30.436	30.436	"							
	GEAR DRIVE ASSY.		A6		1	1	59.132	59.132	"							
	PREAMP. ASSY.		A7		1	1	48.871	48.871	"							
	FRONT PANEL ASSY.		A8		1	1	NEG.	NEG.	"							
	PRESEL. CAM ASSY.		A10		1	1	14.0	14.0	"							
	OSC. CAM ASSY.		A11		1	1	11.60	11.60	"							
	CAPACITOR, ELECTRO		1000mf 50V CU		1	1	1.9	1.9	"							
	GEAR, SPUR				2	2	1.74	3.48	" WTRF = 2889 LR							







DATE 10/26/98

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:
WLR-16				8	ASSEMBLY: A5	SUBASSEMBLY: POWER SUPPLY
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE %	REMARKS
	NOMENCLATURE	NUMBER				
	CAPACITOR, ELECTRO.	CLR	CLR 25 BH 2317EP (1) CLR 25 BH 1807EP (2)	3	.033	Ns
	CAPACITOR	CKR	CKR06BX103KP	2	.0264	"
	DIODE, SILICON	1N3189		4	.75	" 200V : 1/2 AMP
	RESISTOR, VAR.	RJ	MIL-R-22097 R350 35V 5K ±20%	2	13.0	"
	REGULATOR, DC VOLT.		INPUT 40V, OUTPUT 5-10V 4W PWR. DISS. TO-3	2	.103	"
	TRANSISTOR, NPN PWR		MIL TYPE 2N3584	1	1.1	"
	P.C. BOARD		EPOXY GLASS	1	.0048	"





## INTERIM RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/78

SYSTEM	SUBSYSTEM	EQUIPMENT	GROUP	UNIT	ASSEMBLY	SUBASSEMBLY	SHEET
WLR-16				8	CN-1161A PREAMP.		1
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE %	HA	REMARKS
	NOMENCLATURE	NUMBER	(QTY)				
	CAPACITOR, GLASS	1.0 - 10.0 PF	(5)	5	2.7	13.50	NS
	CAPACITOR	100VDC @ 1MHz CKL04W102M (9)		9	.44	3.96	"
	CAPACITOR, FIXED	FEEDTHRU 470uF ±20% 500VDC	(4)	4	.44	1.76	"
	CAPACITOR, MICA	CM05C100K03 (3) CM05C050K03 (1)		4	.078	.312	"
	CAPACITOR, GLASS	10uF 0.25mF TOL. (4) 500VDC		5	.250	1.25	" CY
	CAPACITOR, FIXED, CER.	DIELECTR STANDOFF 470uF ±20% 500VDC	(7)	7	.44	3.08	"
	CONNECTOR, COAX.	UG-477/U V6-535/U		2	1.1	2.2	"
	COIL, RF	CERAMIC SLUG TUNED		4	.066	.264	"
	CHOKE, RF	150uH (4) .22mH (1)		7	.066	.462	"
	TRANSISTOR, PNP	2N2997		3	3.5	10.5	"
	TRANSISTOR, PNP	2N2996		3	3.5	10.5	"
	RESISTOR	RC07GF472K (10) RC07GF122K (5) RC RC07GF221K (1) RC07GF562K (1) (1) RC07GF222K (1) (1) RC07GF470K (5)		21	.039	.819	"
	RF TRANSFORMER ASSY.			3	.066	.198	"
	RESONATOR, MECHANICAL			1	.066	.066	"
				SUM OF	NA	48.871	

DATE 10/26/78

DATE 10/26/78

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# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/78

SYSTEM	SUBSYSTEM	EQUIPMENT	GROUP	UNIT	ASSEMBLY	SUBASSEMBLY	SHEET
WLR-16				9	CV-1162A		1
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE λ	HA	REMARKS
	NOMENCLATURE	NUMBER					
	ATTN. COAX.	RD		1	1.5	1.5	Ns APPROX. 100KΩ, ±
	CONNECTOR PANEL	4 CONTACTS - 15A 500V 16 CONTACTS - 5A RMS		1	.56	.56	"
	METER, ELAP. TIME	3W 115V 60Hz		1	10.0	10.0	"
	RESISTOR PRECISION	3W 137K ±3% 105V (1) RN41A5A252A (2)		3	22.0	66.0	"
	SWITCH, TOGGLE	2 POS. 220VAC 9AMP.		1	.68	.68	"
	TRANSFORMER, PWR.	PR1. 109V-131V 47-63Hz SEC. 16V .35ARMS 46V .2A RMS		1	.064	.064	"
	PREFECTOR ASSY	A2		1	3.70	3.70	"
	MIXER ASSY.	A3		1	89.0	89.0	" ONE UNIT, NO P.R.
	OSCILLATOR ASSY.	A4		1	5.61	5.61	"
	POWER SUPPLY ASSY.	A5		1	30.436	30.436	"
	GEAR DRIVE ASSY.	A6		1	59.132	59.132	"
	PREAMP. ASSY.	A7		1	48.871	48.871	"
	FRONT PANEL ASSY.	A8		1	NEG.	NEG.	"
	PRESEL. CAM ASSY.	A10		1	14.40	14.40	"
	OSC. CAM ASSY.	A11		1	11.60	11.60	"
	CAPACITOR, ELECTRO.	1000μF 50V		1	1.9	1.9	"
	GEAR, SPUR			2	1.74	3.48	" MTBF = 2882 HRS



DATE 10/26/98

DATE 10/26/98

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DATE 10/26/97

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# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/72

SYSTEM	SUBSYSTEM	EQUIPMENT	GROUP	UNIT	ASSEMBLY	SUBASSEMBLY	SHEET
WLR-16				9	A7	PREAMP.	1
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY	FAILURE RATE X	WA	REMARKS
	NOMENCLATURE	NUMBER	(QTY)	N			
	GLASS CAPACITOR, VAR.	1.0 - 10.0 PF 100VDC @ 1MHz CKL0A1102M (9)	(5)	5	2.7	13.50	NS
	CAPACITOR	CK		9	.44	3.96	"
	FIXED CAPACITOR, CERAMIC	FEEDTHRU 470MMF ±20% 500VDC (4)	(4)	4	.44	1.76	"
	CAPACITOR, MICA	CMOS100K03 (3) CMOS050K03 (1)	(3)	4	.078	.312	"
	FIXED CAPACITOR, GLASS	1.0mF 0.25mF TOL. (4) 500VDC 2.2mF (1) DIELECT STANDOFF	(4)	5	.250	1.25	" CY
	CAPACITOR	470mF ±20% 500VDC (7)	(7)	7	.44	3.08	"
	CONNECTOR, COAX.	VG-477/U VG-535/U		2	1.1	2.2	"
	COIL, RF	CERAMIC SLUG TUNED		4	.066	.264	"
	CHOKE, RF	150mH (4) .22mH (1)	(2)	7	.066	.462	"
	TRANSISTOR, GER.	2N2997		3	3.5	10.5	"
	TRANSISTOR, GER.	2N2996		3	3.5	10.5	"
	RESISTOR	RC070F472K (10) RC070F132K (5) RC070F271K (1) RC070F562K (1) RC070F222K (1) RC070F470K (3)	(10)	21	.039	.819	"
	RF TRANSFORMER ASSY.			3	.066	.198	"
	RESONATOR, MECHANICAL			1	.066	.066	"
				SUM OF NAs		48.871	





DATE 10/26/78

3C T-155HS

# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: WLR-1C	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: CV-741 FREQ. CONV.	ASSEMBLY:	SUBASSEMBLY:	DATE: 10/27/78	SHEET 1 OF 1
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INDEX NUMBER	DEVICE IDENTIFICATION				QUANTITY N	FAILURE RATE X	HA	REMARKS
	NOMENCLATURE	NUMBER (QTY)						
	CAPACITOR, FIXED CERM.	CC30UJ750J (2) CC20CH100C (1) CC30BH390F (1)			4	.44	1.76	Ns
	CAPACITOR, FIXED MICA	1000P ±20% 500VDC (4) CB11PE102M (3)			7	.99	6.93	"
	CAPACITOR, FIXED CERM.	CK60AW102M (13) CK70AW102M (2)			15	.44	6.6	"
	CAPACITOR, FIXED PAPER	CP11A3KB105K (1) CP11A3KE104K (4)			5	.016	.080	"
	DIODE, SILICON	JAN IN458			1	.75	.75	"
	DIODE, SILICON	JAN IN251			2	.75	1.50	"
	CONNECTOR RACK & PANEL	4 CONT. 750VDC 15A (1) 16 CONT. 900VAC 5A (1) 15 CONT. 490VDC 5A (1)			2	.56	1.12	"
	CONNECTOR, COAX.	UG-1094/U			2	1.1	2.2	"
	RELAY, GEN. PUR.	4PDT, 280~27.5VDC			1	1.6	1.6	"
	COIL, RF	STEATITE FORM W/ADT. CORE			2	.066	.132	"
	CHOKE, RF, MOLDED	MS75008-33 (2) MS75008-41 (2) MS75008-37 (1) MS75008-36 (1) MS91189-37 (1) MS75055-2 (1)			8	.066	.528	"
	CHOKE, RF	.25uH 0.05~1.5A			2	.066	.132	"
	RESISTOR, COMP.	RCR206271KM (2) RCR206332KM (2) RCR206104JM (2) RCR206470JM (2) RCR206103JM (1) RCR206121KM (1) RCR206472JM (1) RCR206123JM (1) RCR206152KM (1)			23	.0077	.177	"
								"
								"



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/27/77

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	SHEET
WLR-16				10 CV-741 FREQ. CONV.			2
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	HA	REMARKS
	NOMENCLATURE	NUMBER (QTY)					
		RCR 206 154 KM	(1)				NS
		RCR 206 193 KM	(1)				
		RCR 206 191 KM	(1)				
		RCR 206 102 KM	(1)				
		RCR 206 222 KM	(1)				
		RCR 206 224 JM	(1)				"
		RCR 206 471 KM	(1)				
		RCR 206 105 KM	(1)				
	RESISTOR, FIXED	RV43B 6813F	(1)	4	.03	.12	
	RESISTOR, FILM	RV43B 340F	(2)				
	RESISTOR	RV4WAYS 502A	(1)	3	22.0	66.0	"
		RV4WAYS 102A	(1)				
		RV4WAYS 252B	(1)				
	TRANSFORMER, IF	11.0 MHZ INTERSTAGE		2	.066	.132	
		SLUG TUNED					
	TRANSFORMER, PWR.	PR1 115V 57/63 Hz		1	.064	.064	"
		SEC. 6.3V @ 5.0A					
		SEC. 6.3V @ 2.5A					
	TUBE, REC.	5654		2	32.5	65.0	
	TUBE, REC.	5670		1	32.5	32.5	
	TUBE, REC.	6AH6WA		1	32.5	32.5	"
	TUBE, REC.	5687WA		1	32.5	32.5	
	IF AMP. ASSY.	A1		1	403.822	403.822	
	OSCILLATOR - MIXER	A2		1	332.780	332.780	

# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM:		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE:	SHEET
WLR-16					CV-741	A1	10/27/78	1 of 1
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE λ	HA	REMARKS	
	NOMENCLATURE	NUMBER (QTY)						
	CAPACITOR, FIXED	CK60AV102M (4)	28	.44	12.32	NS		
	CAPACITOR, FIXED	CK70AV102M (5)	1	.078	.078	"		
	CAPACITOR, FIXED	CM15E8206 (1)	12	.44	5.28	"		
	CAPACITOR, FIXED	CC20CJ030C (1)	—	—	—	"		
	CAPACITOR, FIXED	CC20CH120F (1)	18	.99	17.82	"		
	CAPACITOR, FIXED	CC20UJ100B (1)	2	2.7	5.4	"		
	CAPACITOR, FIXED	CB21PE102M (1)	2	1.1	2.2	"		
	CAPACITOR, FIXED	CB21PE102M (1)	2	.066	.132	"		
	CAPACITOR, FIXED	8-504F 350VDC (1)	19	.066	1.254	"		
	CAPACITOR, FIXED	UG-1094/U	—	—	—	"		
	COIL, RF	STEATITE FORM W/ADJ. SLUG	2	.066	.132	"		
	CHOKE, RF	MS75008-38 (1)	2	.066	.132	"		
	CHOKE, RF	MS75008-21 (1)	19	.066	1.254	"		
	CHOKE, RF	MS75008-33 (1)	—	—	—	"		
	CHOKE, RF	MS75008-41 (4)	—	—	—	"		
	CHOKE, RF	125mh 0.05Ω 1.5A (2)	2	.066	.132	"		
	CHOKE, RF	24h 0.072Ω 110ma (3)	6	.066	.396	"		
	CHOKE, RF	1.25mh 0.072Ω 110ma (3)	1	.56	.56	"		
	CONNECTOR, RF	15 CONT. 490VDC @ 5A	1	.0077	.154	"		
	RESISTOR, FIXED	ROR20G103KM (1)	20	.0077	.154	"		
	RESISTOR, FIXED	ROR20G331KM (1)	—	—	—	"		
	RESISTOR, FIXED	ROR20G121KM (1)	—	—	—	"		
	RESISTOR, FIXED	ROR20G151KM (1)	—	—	—	"		
	RESISTOR, FIXED	ROR20G221KM (1)	—	—	—	"		
	RESISTOR, FIXED	ROR20G562KM (1)	—	—	—	"		
	RESISTOR, FIXED	ROR20G232KM (1)	—	—	—	"		
	RESISTOR, FIXED	ROR20G101KM (1)	—	—	—	"		
	RESISTOR, FIXED	ROR20G151KM (1)	—	—	—	"		

DATE: 10/22/97

[illegible]



# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: <b>WLR-16</b>	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: <b>10 CV-741</b>	ASSEMBLY: <b>A2</b>	SUBASSEMBLY:	DATE <b>10/21/78</b>	SHEET <b>1</b> OF <b>3</b>
				FREQUENCY: <b>CONV.</b>				
				OSC. MIXER				

INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	NA	REMARKS
	NOMENCLATURE	NUMBER	(QTY)				
	CAPACITOR, FIXED, CER.M.	CK70AN102M CK60AN102M	{6}	16	.44	7.04	NS
	CAPACITOR, FIXED, CER.M.	CC30VJ620J CC30VJ101J CC20VJ300J	{3}	10	.44	4.4	"
		CC30VJ820J CC30CH180J CC20CH050J	{1}	—	—	—	"
	CAPACITOR, FIXED, MICA	CB21PD101J 1000PF 20% 500VDC	(2)	3	.99	2.97	"
	CAPACITOR, FIXED, PAPER	CPV09A1KE104KM	(2)	2	.0016	.003	"
	CAPACITOR, FIXED, CER.M.	CC20VJ100B	(1)	1	.44	.44	"
	CAPACITOR, FIXED, PAPER	CP11A3KE104K	(1)	1	.16	.16	"
	CONNECTOR, COAX.	UG-1094/U		1	1.1	1.1	"
	CHOKE, RF	.25mH 0.05W 1.5A	(8)	8	.066	.528	"
	COIL, RF, MOLDED	MS75008-41		1	.066	.066	"
	COIL, RF	FORM W/ADJ CORE		6	.066	.396	"
	RESISTOR	RCR20G563JM (2)		23	.0077	.177	"
		RCR20G155KM (1)		—	—	—	"
		RCR20G471JM (1)		—	—	—	"
		RCR20G561JS (1)		—	—	—	"
		RCR20G564JM (2)		—	—	—	"
		RCR20G222JM (1)		—	—	—	"
		RCR20G151JM (1)		—	—	—	"
		RCR20G473JM (1)		—	—	—	"
		RCR20G152JM (1)		—	—	—	"
		RCR20G822JM (1)		—	—	—	"
		RCR20G153JM (1)		—	—	—	"
		RCR20G121JM (1)		—	—	—	"

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/2/78

SYSTEM: WLR-16		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 10 CV-741 FREQ. CONV.	ASSEMBLY: A2	SUBASSEMBLY:	SHEET 2 OF 3
INDEX NUMBER	DEVICE IDENTIFICATION		HUMBER	QUANTITY N	FAILURE RATE %	HA	REMARKS	
	NOMENCLATURE							
			RCR 206 222JM (1)	—	—	—	NS	
			RCR 206 391KM (1)	—	—	—		
			RCR 206 470KM (1)	—	—	—	"	
			RCR 206 472JM (1)	—	—	—	"	
			RCR 206 101KM (1)	—	—	—	"	
			RCR 206 102KM (1)	—	—	—	"	
			RCR 206 471KM (1)	—	—	—	"	
			RCR 206 154KM (1)	—	—	—	"	
			RCR 206 224KM (1)	—	—	—	"	
	RESISTOR, COMP.	VAR.	RV4 LAYSAS02B (1)	4	22.0	88.0	"	
			RV4 LAYSAS103B (1)	—	—	—	"	
			RV4 LAYSAS105B (1)	—	—	—	"	
			RV4 LAYSAS252B (1)	—	—	—	"	
	TUBE, REC.		6CAWA	1	32.5	32.5	"	
	TUBE, REC.		6AH6WA	1	32.5	32.5	"	
	TUBE, REC.		8113	1	32.5	32.5	"	
	TUBE, REC.		5727/2D21W	1	32.5	32.5	"	
	TUBE, REC.		5814A	1	32.5	32.5	"	
	TUBE, REC.		5670	2	32.5	65.0	"	

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/78

SYSTEM: WLR-10		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 11	ASSEMBLY:	SUBASSEMBLY:	SHEET 1 OF 1
INDEX NUMBER	DEVICE IDENTIFICATION			NUMBER (QTY)	QUANTITY N	FAILURE RATE %	MA	REMARKS
	NOMENCLATURE							
	CAPACITOR, FIXED, MICA	100PF ±20% 500VDC (2)		4	.99	3.96	Ns	
	CAPACITOR, FIXED, CERAM.	1000PF ±20% 500VDC (2)		15	.44	6.60	"	
	CAPACITOR, FIXED, CERAM.	CK60AW102M (13)		6	.44	2.64	"	
		CK70AW102M (2)		—	—	—	"	
		CC300J6203 (2)		6	.016	.096	"	
		CC20CH100C (1)		1	.078	.078	"	
		CC20CH050B (1)		3	.99	2.97	"	
		CC30UJ101J (1)		2	.75	1.50	"	
		CP11A3KE104K (1)		1	.75	.75	"	
		CP11A3K473K (1)		2	.56	1.12	"	
		CP11A3K8105K (1)		—	—	—	"	
		CM15C470J (1)		2	1.1	2.2	"	
		CB11PE102M (3)		1	1.6	1.6	"	
	DIODE	JAN 1N251		9	.066	.594	"	
	DIODE	JAN 1N458		—	—	—	"	
	CONNECTOR, BACK + PANEL	4 CONT. 750VDC 15A (1)		2	.0077	.169	"	
		16 CONT. 900VAC 5A (1)		3	.066	.198	"	
		15 CONT. 490VDC 5A (1)		22	.0077	.169	"	
	CONNECTOR, COAX.	VE-1094/U		2	.066	.198	"	
	RELAY, GEN. PUR.	4PDT, 280 ~ 27.5VDC		1	.066	.198	"	
	COIL, RF, MOLDED	MS75008-33 (7)		9	.066	.594	"	
		MS75008-28 (1)		—	—	—	"	
		MS75008-41 (1)		3	.066	.198	"	
	COIL, RF	.25uh 0.05 ~ 1.5A (2)		22	.0077	.169	"	
		2.0mh 35mA 3π SEC. (1)		3	.066	.198	"	
	RESISTOR, FIXED, SOME	ROR 20G 271KM (2)		22	.0077	.169	"	
		ROR 20G 332KM (2)		—	—	—	"	



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/72

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	SHEET
WJ-10				CV-742B			2 OF 2
INDEX NUMBER	DEVICE IDENTIFICATION		NUMBER (QTY)	QUANTITY N	FAILURE RATE λ	HA	REMARKS
	NOMENCLATURE						
		RCR 20G100JM (2)		1			NS
		RCR 20G104JM (1)		1			
		PWR 20G470JM (1)		1			"
		PWR 20G103JM (1)		1			"
		PWR 20G151KM (1)		1			"
		PWR 20G472JM (1)		1			"
		RCR 20G183JM (1)		1			"
		RCR 20G152KM (1)		1			"
		RCR 20G103KM (1)		1			"
		PWR 20G101KM (2)		1			"
		PWR 20G154KM (1)		1			"
		PWR 20G102KM (1)		1			"
		RCR 20G222KM (1)		1			"
		RCR 20G274JM (1)		1			"
		RCR 20G105KM (1)		1			"
		RCR 20G470KM (1)		1			"
	RESISTOR	RV4 NAYSD502A (1)		3	22.0	66.0	"
		RV4 NAYSD102A (1)		1			"
		RV4 NAYSA252B (1)		1			"
	RESISTOR	RV65B1003F (1)		5	.03	.150	"
		RV65B6813F (1)		1			"
		RV65B3420F (1)		1			"
		RV75B5112F (2)		2	.066	.132	"
	TRANSFORMER, IF	39.0 MK2, 520G TUNED		1	.064	.064	"
	TRANSFORMER, PWR.	APL 115X 57/53 H2 SEC 6.3V @ 2.5A		2	32.5	65.0	"
	TUBE, REC.	S654		1	32.5	32.5	"
	TUBE, REC.	S670		1	32.5	32.5	"
	TUBE, REC.	6AN6WA		1	32.5	32.5	"

SUM OF HA

DATE 10/30/78 SUBASSEMBLY: \_\_\_\_\_ SHEET 3 OF 3

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:
WLR-10				11 CV-742A		
						SHEET 3 OF 3

[illegible]

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/77

SYSTEM:		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY: A1		SUBASSEMBLY:		SHEET
WLR-16					CV-742B	FREQ. CONV.	IF AMP.			1 of 1
INDEX NUMBER	DESCRIPTION	QUANTITY	FAILURE RATE	HA	REMARKS					
	CAPACITOR, FIXED MICA	22	.99	21.78	N3					
	CAPACITOR, FIXED CERAM.	35	.44	15.40	"					
		—	—	—	"					
	CAPACITOR, FIXED CERAM.	14	.44	6.16	"					
		—	—	—	"					
	CAPACITOR, FIXED PAPER	1	.0016	.0016	"					
	CONNECTOR, JACK	2	1.1	2.2	"					
	CHOKE, RF	12	.066	.792	"					
	COIL, P.F. MOLDED	19	.066	1.254	"					
		—	—	—	"					
	CONNECTOR, PANEL	1	.56	.56	"					
	RESISTOR, FIXED	23	.0077	.177	"					
		—	—	—	"					
		—	—	—	"					
		—	—	—	"					
		—	—	—	"					
	RESISTOR, FIXED FILM	9	.03	.270	"					



# INTERVIEW RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/72

2  
sheet

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**THE UNIVERSITY OF CHICAGO**

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/72

SYSTEM: NLR-1C		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 11 CV-742D FREQ. CONV.	ASSEMBLY: A2 OSC. MIXER	SUBASSEMBLY:	SHEET 1 OF 3
INDEX NUMBER	DEVICE IDENTIFICATION			NUMBER (QTY)	QUANTITY N	FAILURE RATE λ	HA	REMARKS
	DESCRIPTION	VALUE	UNIT					
	CAPACITOR, FIXED	CK70AW102M	(12)	25	.44	11.0	N5	
	CAPACITOR, FIXED	CK60AW102M	(13)	14	.44	6.16	"	
	CAPACITOR, FIXED	CC30VJ620J	(3)	1	—	—	"	
	CAPACITOR, FIXED	CC30VJ101J	(1)	1	—	—	"	
	CAPACITOR, FIXED	CC20VJ300J	(1)	1	—	—	"	
	CAPACITOR, FIXED	CC20VJ150J	(1)	1	—	—	"	
	CAPACITOR, FIXED	CC20VJ050J	(1)	1	—	—	"	
	CAPACITOR, FIXED	CC30VJ820J	(1)	7	.99	6.930	"	
	CAPACITOR, FIXED	CB21PD101J	(1)	3	.0016	.005	"	
	CAPACITOR, FIXED	1000PF ±20% 500VDC	(6)	1	.016	.016	"	
	CAPACITOR, FIXED	CPV09AIKF103KM	(1)	1	1.1	1.1	"	
	CAPACITOR, FIXED	CPV09AIKE104KM	(1)	1	1.4	1.6	"	
	CAPACITOR, FIXED	CPV09AIKC105KM	(1)	16	.066	1.056	"	
	CAPACITOR, FIXED	CP11A3KE104K	(1)	2	.066	.132	"	
	CONNECTOR, COAX.	UG-1094/U		31	.0077	.239	"	
	RELAY, GEN. PUR.	4PBT, 280~ 27.5VDC		1	—	—	"	
	CHOKES, RF	.25mh 0105~ 1.5A		1	—	—	"	
	COIL, RF, MOLDED	MS75008-41	(1)	1	—	—	"	
	RESISTORS, FIXED	MS75009-30	(1)	1	—	—	"	
	RESISTORS, COMP.	RCR20G563JM	(1)	1	—	—	"	
	RESISTORS, COMP.	RCR20G155JM	(1)	1	—	—	"	
	RESISTORS, COMP.	RCR20G471JM	(2)	1	—	—	"	
	RESISTORS, COMP.	RCR20G102JM	(3)	1	—	—	"	
	RESISTORS, COMP.	RCR20G822JM	(1)	1	—	—	"	
	RESISTORS, COMP.	RCR20G223JM	(1)	1	—	—	"	
	RESISTORS, COMP.	RCR20G562JM	(1)	1	—	—	"	
	RESISTORS, COMP.	RCR20G181JM	(1)	1	—	—	"	

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/78

SHEET 2 OF 3

SYSTEM	SUBSYSTEM	EQUIPMENT	GROUP	UNIT	ASSEMBLY	SUCASSEMBLY	REMARKS
NR-10				CV-7420 PRFA-CONV.	A2 OSC-MIXER		
INDEX NUMBER	DEVICE IDENTIFICATION		NUMBER (QTY)	QUANTITY N	FAILURE RATE %	HA	
	NOMENCLATURE						
			ROR 206 3923M (2)	1	—	—	NS
			ROR 206 123JM (2)	1	—	—	"
			ROR 206 153JM (1)	1	—	—	"
			ROR 206 154JM (1)	1	—	—	"
			ROR 206 104JM (1)	1	—	—	"
			ROR 206 222KM (2)	1	—	—	"
			ROR 206 472JM (3)	1	—	—	"
			ROR 206 823JM (1)	1	—	—	"
			ROR 206 331JM (1)	1	—	—	"
			ROR 206 121JM (1)	1	—	—	"
			ROR 206 564JM (1)	1	—	—	"
			ROR 206 101 KM (1)	1	—	—	"
			ROR 206 224JM (1)	1	—	—	"
			ROR 206 471 KM (1)	1	—	—	"
			ROR 206 151 KM (1)	1	—	—	"
	RESISTOR, VAR.		RV4 LAYSA 105B (1)	6	22.0	132.0	"
	COMP.		RV4 LAYSA 253B (2)	1	—	—	"
			RV4 LAYSA 502B (3)	1	—	—	"
	TUBE, REC.		6CAWA	1	32.5	32.5	"
	TUBE, REC.		6AH6WA	1	32.5	32.5	"
	TUBE, REC.		8113	1	32.5	32.5	"
	TUBE, REC.		5654	2	32.5	65.0	"
	TUBE, REC.		5727/2D21W	1	32.5	32.5	"
	TUBE, REC.		5814A	1	32.5	32.5	"
	TUBE, REC.		5670	2	32.5	65.0	"

10/30/78

10/30/78



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/25/78

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 12 ARMUTH IND. PULSE ANALYZER	ASSEMBLY:	SUBASSEMBLY:	SHEET 1 OF 3
INDEX NUMBER	NOMENCLATURE	NUMBER	QUANTITY N	FAILURE RATE X	HA	REMARKS	
	CAPACITOR	CPV	12	.0016	.0732	NS, $\pi_0 = 1$	
	"	CM	2	.078	.156	"	
	DIODE	JANIN458	5	.75	3.75	"	
	LAMP INCANDESCENT		20	1.0	20	"	
	CONN	34-20P5	1	.56	.56	" 34 PINS, 5 P, 21V, 2	
	"	MRE-50P-J	1	.56	.56	" 50 " " "	
	"	BNC MIL UG-1094/U	9	1.1	9.9	"	
	"	DBF-255-C7	1	.56	.56	" 25 PINS	
	"	DCF-375-C7	3	.56	1.68	" 27 PINS	
	"	ADAPTER, 2 CONNECTS	2	4.1	2.2	"	
	"	BNC MIL-UG-1094/U	5	.56	2.8	" 15 PINS	
	"	DAF-155-C7	1	1.1	1.1	"	
	"	TELEPHONE JACK (COAX)	5	.56	2.80	" 25 PIN	
	"	DBF-255-C7	1	.56	.56	"	
	"	20 AMP, 20V, 2 P, 20 M53102A-125-35	5	1.6	8.00	"	
	RELY	4 PDT, GP	1	1.6	1.6	"	
	"	SPDT, 150V, 10 MA	1	1.6	1.6	"	
	"	SPDT, 150V, 10 A	1	1.6	1.6	"	

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/26/48

SYSTEM:		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 12 AZIMUTH IND. PULSE ANALYZER	ASSEMBLY:	SUBASSEMBLY:	DATE: 10/26/98	SHEET 2 OF 2
INDEX NUMBER	DEVICE IDENTIFICATION				QUANTITY N	FAILURE RATE %	IN	REMARKS	
	NOMENCLATURE	NUMBER							
	RF COIL	500V, 9000 OHM	1000 OHM, 1.65K OHMS		1	.066	.066	NS	
	METER, MICRO AMP				1	10	10.0	"	
	RESISTOR		RCR 42G 8237M "		3	.0077	.023	"	
	"		RCR 42G 1044M, 224KM "		6	.0077	.046	"	
	"		RCR 42G 273 KM (1)		5	.0077	.039	"	
	"		RCR 20G 102 KM		4	.0077	.031	"	
	"		RCR 20G 181 KM, 150 KM "		2	.0077	.015	"	
	"		RCR 20G 683 KM, 472 KM "		5	.0077	.039	"	
	"		RCR 20G 105 KM		3	.0077	.023	"	
	"		RCR 20G 154 KM, 155 KM "		4	.0077	.031	"	
	"		RCR 20G 105 KM		1	.0077	.0077	"	
	"		RCR 20G 104 KM		5	.0077	.039	"	
	"	VARIABLE	RV4NAYS0105A		6	22	132	"	
	"	FILM	RN65B2J51E		1	.03	.03	"	
	"	"	RN65B133E, 2370E		1	.03	.03	"	
	RESISTOR, VARIABLE		RV4CHYSA104B		1	.03	.03	"	
	"	"	RV4NAYS0103A		1	.03	.03	"	

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/27/78

SUBSYSTEM:		EQUIPMENT:	GROUP:	UNIT: 12 MINIMUM PULSE AMPLIFIER	ASSEMBLY:	SUBASSEMBLY:	SHEET 3 OF 3
INDEX NUMBER	NOMENCLATURE	NUMBER	FAILURE RATE X	QUANTITY N	NA	REMARKS	
	RESISTOR, VARIABLE	RV44MYSD504A		10	.03	NS	
	"	RP101FH320KK		1	7.5	"	
	SWITCH, TOGGLE, DP	MS35059-22-31 <sup>(1)</sup>		3	.68	"	
	"	250VAC, 5A; 3000C, 4A		1	.68	"	
	"	250VAC, 3A		1	.46	"	
	TRANSFORMER, PWR	115VAC, 600W		1	.064	"	
	"	MFG 80089, P/N 26740		1	.064	"	
	"	115VAC, 600W		1	.064	"	
	"	MFG 80087, P/N 26045		1	.064	"	
	"	115V, 600W		1	.064	"	
	"	MFG 80079, P/N 25347		1	.064	"	
	TUBE, ELECTRON, CRT	7Y12		1	97.5	"	
	"	5KPT399M		1	97.5	"	
	LAMP, NEON	NE-2		6	.2	"	
	12A1 VIDEO AMP	545 1694 005		1	223.666	"	
	12A2 PANORAMIC AMP			1	206.141	"	
	12A3 0-5 MSEC SWEEP			1	320.157	"	
	12A4 PULSE STRETCHER			1	349.423	"	
	12A5 5-500 MSEC SWEEP			1	302.941	"	
	12A6	NOT USED		—	—	"	



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/27/78

**SUBASSEMBLY:**

**ASSEMBLY:**

UNIT: 12  
AZIMUTH IND  
PULSE ANALYZER

SHEET 4 OF 11

[illegible][illegible]

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/27/78

SYSTEM: IVLR-1G	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 12 AZIMUTH IN PULSE ANALYZER	ASSEMBLY: 12A1 VIDEO AMP	SUDASSEMBLY:	SHEET 1 OF 3
INDEX NUMBER	NOMENCLATURE		NUMBER	QUANTITY N	FAILURE RATE λ	WA	REMARKS
	CAPACITOR	PAPER	CPV09A1KC224KM	1	.0016	.0016	NS
	"	"	CM15E101G	1	.078	.078	"
		PAPER	CPV09A1KE473KM	2	.0016	.0032	"
	"	"	CP11A34C224K	2	.0016	.0032	"
	"	MICA	CM15E151G	1	.078	.078	"
		CER	CC60A102M	4	.44	1.76	"
	"	"	CC20CH050C	1	.44	.44	"
	"	"	CC30CH180J	29	.44	12.76	"
	"	"	CC20CH050C	1	.44	.44	"
	"	PAPER	CPV04A1K3104K	1	.0016	.0016	"
	"	MICA	CM150D102G43	2	.078	.156	"
	"	PAPER	CPV09A1KC473KM	1	.0016	.0016	"
	"	"	CPV09A1KC473KM	1	.0016	.0016	"
	CONNECTOR	CONX	TERLON DIELECT, 125KV 5A	2	.56	1.12	"
	CONN.		AIR 813.2 P/N 54555K	1	.56	.56	"
	COIL, RF		145 75008	38	.56	21.28	"
	"		M5 90542-16	1	.066	.066	"

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/27/78

SYSTEM: WLR-15		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 12 AEROMUTH INDI PULSE ANALYZER	ASSEMBLY: 12 A1 VIDEO AMP.	SUBASSEMBLY:	SHEET 2 OF
INDEX NUMBER	DEVICE IDENTIFICATION			NUMBER	QUANTITY N	FAILURE RATE X	HA	REMARKS
	NOMENCLATURE							
	CHOKER		11591189-		2	.066	.132	NS
	RESISTOR		RCR 20G62JM		1	.0077	.0077	"
	"	VARINALE AMP	RV6LNYSA251B		1	.22	.22.0	"
	"		RCR 20G104KM		9	.0077	.069	"
	"		" 121KM		1	.0077	.0077	"
	"		RCR 42G352KM		3	.0077	.023	"
	"		RCR 32G103KM		1	.0077	.0077	"
	"		RCR 32G105KM		1	.0077	.0077	"
	"		RCR 42G67JM		3	.0077	.023	"
	"		RCR 20G332JM		3	.0077	.023	"
	"		RCR 20G108KM		5	.0077	.039	"
	"		RCR 20G150KM		4	.0077	.031	"
		FILM	RA 613 3540F		1	.030	.030	"
PCB			80 connections		3	.0048	.014	"
TUBE			50 20, 5347, 5814 6CL5, 5887		5	.32.5	.162.5	"

007 1.11





# HERNANDEZ RELIABILITY ANALYSIS WORKSHEET

SYSTEM: WLR-1G		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 12	ASSEMBLY: A3 0-5M SEC		DATE: 2/29/78		SHEET 1 OF 3
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE λ	MA	REMARKS			
	NOMENCLATURE	NUMBER								
	CAPACITOR, PAPER	CPV02H12CXX4KM - XX2KM	6	.0016	1010	NS				
	"	CIV15C471G -	3	.078	.234	"				
	"	CER	5	.44	2.2	"				
	"	VAR. CER	1	2.7	2.7	"				
	"	ELECT. ST	1	.56	.56	"				
	DIVIDE	JAN 111458	9	.75	6.75	"				
	CONN, COAX	CN401-F-80 NFC 81312 M45-L2N	1	1.1	1.1	"				
	COIL, RF		1	.56	.56	"	2 AG-104PUS			
	"	NIS-9000-23	5	.066	.33	"				
	RESISTOR		1	.066	.066	"				
	"	RCR20GXX34M - 1KM	12	.0077	.092	"				
	"	RCR20CXX4KM	8	.0077	.062	"				
	"	RCR20GXX5KM	5	.0077	.039	"				
	"	RCR32GXX2KM	2	.0077	.015	"				
	"	RCR42	9	.0077	.069	"				
	"	RN65B:XX4/E - XXV3F	8	.03	.24	"				
	"	RN70SXXZF	1	.03	.03	"				

## DATE: 10/29/78

101



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/29/78

SYSTEM: WLR-1G		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 12	ASSEMBLY: A4		SUBASSEMBLY:		SHEET 1 OF 1
INDEX T.O. 00000	NOMENCLATURE		DEVICE IDENTIFICATION		QUANTITY N	FAILURE RATE λ	WA	REMARKS		
		NUMBER								
	CAPACITOR	PRIMER		CPV09A1K1E X3XN1	11	.0016	.018		NS	
	"	"		CPV09A1K1E X4XK1	3	.0016	.005		"	
	"	"		CPV09A1K1E X4XK1	3	.0016	.005		"	
	"	MICA		CM15C100J	4	.078	.312		"	
	DIODE			JAN1N458	7	.75	5.25		"	
	"			JAN1N627	2	.75	1.50		"	
	CONN	CONN		CN401-F-80	2	1.1	2.2		"	
	"			55-45N	1	.56	.56		"	
	RELAY	4PDT		2400-00	1	1.6	1.6		"	
	RESISTOR			2400-00	17	.0077	.131		"	
	"			RES208-5K	10	.0077	.1077		"	
	"			RES325X3C, X4XK	13	.0077	.100		"	
	"			RES426X4X	2	.0077	.015		"	
	"			RN105V11EF	1	.03	.03		"	
	"			RA258V112F, X4X3F	4	.03	.12		"	
	"			RV6LAY	5	22	110.0		"	
	TUBE	RECEIVER			7	32.5	227.5		"	

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 20/2/78

SYSTEM	SUBSYSTEM	EQUIPMENT	GROUP	UNIT: 12	ASSEMBLY: 15 5-500MSEC SWEEP	SUBASSEMBLY	SHEET 1 OF	
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE %	HA	REMARKS	
	NOMENCLATURE	NUMBER						
	CAPACITOR	PAPER	CD1001X3K1 XX44M		5	.0016	1008	NS
	"	MICA	CM15EXVIG		5	.078	.390	"
	"	MICA	CM20DXXIG		1	.078	.078	"
	VARIABLE CER CV				1	2.7	2.7	"
	DIODE		TA111458		4	.75	3.0	"
	CONN. CONX		CN401-F-80		1	1.1	1.1	"
	CONN.		M45-LEN		1	.56	.56	"
	RESISTOR		R000000000		14	.0077	.108	"
	"		R000000000		3	.0077	.023	"
	"		R00326VIZ		1	.0077	.0077	"
	"		R0R42RVV		6	.0077	.046	"
	"		RN65BXX1F-XX43F		6	.03	.180	"
	"		RN70BXX1F-XX43F		2	.03	.060	"
	"		RN75BXX1F-3F		6	.03	.180	"
	"	VARIABLE	RV65FVSX-3B		6	22	132.0	"
	TUBE, RECEIVER				5	32.5	162.5	"



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 7/29/78

SYSTEM: WLC-18		SUBSYSTEM:		EQUIPMENT:		GROUP:		UNIT: 12		ASSEMBLY: A5		SUCASSEMBLY:		SHEET 1 OF 1	
INDEX NUMBER	NOMENCLATURE		NUMBER		QUANTITY N	FAILURE RATE λ	HA	REMARKS							
	CAPACITOR	PAPER		CD100P1X3KM XX4KM	5	.0016	1008	NS							
	"	MICA		CM15EXX1G	5	.078	.390	"							
	"	MICA		CM20DXX1G	1	.078	.078	"							
		VARIABLE CER	CV		1	2.7	2.7	"							
	DIODE			TA111458	4	.75	3.0	"							
	CONN. CONX			CN401-F-80	1	1.1	1.1	"							
	CONN.			MUS-ERN	1	.56	.56	"							
	RESISTOR			RESISTOR	14	.0077	.108	"							
	"			RESISTOR	3	.0077	.023	"							
	"			RESISTOR	1	.0077	.0077	"							
	"			RESISTOR	6	.0077	.046	"							
	"			RN65BXX1F-XX3F	6	.03	.180	"							
	"			RN70BXX1F-XX3F	2	.03	.060	"							
	"			RN75BXX1F-3F	6	.03	.180	"							
	"	VARIABLE		CV65CM45XX32	6	22	132.0	"							
	TOBE, RECEIVER				5	32.5	162.5	"							



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 8/29/78

SYSTEM		SUBSYSTEM	EQUIPMENT	GROUP	UNIT	ASSEMBLY	SUBASSEMBLY	SHEET
INDEX NUMBER		DEVICE IDENTIFICATION			QUANTITY	FAILURE RATE	HA	REMARKS
		NOMENCLATURE	NUMBER		N			
		CAPACITOR	CPV09A1	XX3M - XX44	3	.0016	.005	NS
		"	CM352	XXV6	1	.078	.078	"
		"	CM15E	XXV6	3	.078	.234	"
		"	CM30E	XXV5	1	.078	.078	"
		"	CP1N3K	XXV4	1	.0016	.0016	"
		DIODE	1N458		4	.75	3.0	"
		TRANSISTOR	RCR120	XXV6 - XX44	10	.0077	.077	"
		"	RCR200	XX5K	1	.0077	.0077	"
		"	RCR32	XXV	2	.0077	.015	"
		"	RCR42	XXV3	2	.0077	.015	"
		"	RG65B	XXV7 - XX3C	10	.03	.130	"
		"	RN708	XXV1E - XX3F	2	.03	.106	"
		"	RN75B	XXV1E - 3F	4	.03	.12	"
		VARIABLE	RV6L	XXV3B	5	.22	.110.0	"
		TUBE RECEIVER			4	32.5	130.0	"

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/29/72

7-13-1915

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# HERÉNV RELIABILITÁSI ANALYSIS VORKSHEET

SYSTEM:

SUBSYSTEM:

FOURTH.

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DATE \_\_\_\_\_

DATE 10/30/18

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## DATE: 10/29/78

DATE 10/29/78[illegible][illegible]

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EVALUATION RESEARCH CORP SAN DIEGO CA

F/G 17/4

AVAILABILITY STUDY OF THE AN/WLR-16 AND AN/SLQ-32(V)2 ELECTRONI--ETC(U)

FEB 79 J VALENZUELA, W EICHELBERGER

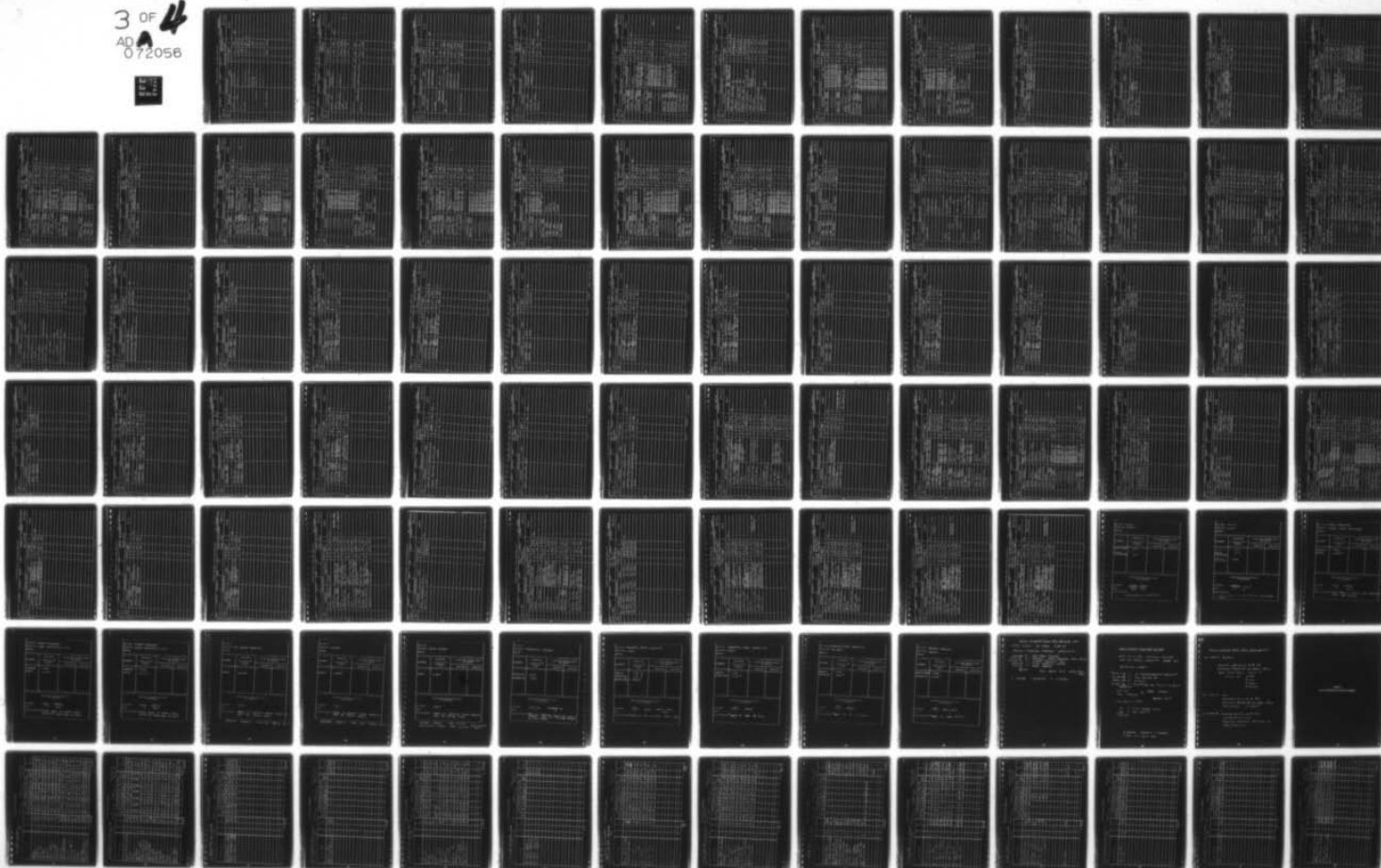
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3 OF 4  
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# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE:	SHEET
WLR-1C				13	C-26976	10/30/78	1 of 2

INDEX NUMBER	DEVICE IDENTIFICATION		QUANTITY N	FAILURE RATE X	HA	REMARKS
	NOMENCLATURE	NUMBER (QTY)				
	CAPACITOR, FIXED	CP53B1FB405K	2	.016	.032	NS
	DIODE, SILICON RECTIFIER	1N645	1	.75	.75	"
	LAMP, INCAND.	MS25237-328	10	1.0	10.0	"
	CONNECTOR, BACK PANEL	50 CONT. 5A 2100VAC (1) 34 CONT. 5A 2100VAC (1) 25 CONT. DBF-255-C7 (1)	3	.56	1.68	"
	RELAY, GEN. PUR.	4PDT, 280-2 27.5VDC	1	1.6	1.6	"
	RESISTOR, FIXED	RCR328223KM (5) RCR206183KM (2) RCR206221KM (1) RCR206121KM (1) RCR206102KM (1) RCR206331KM (1) RCR206181KM (1)	12	.0077	.0924	" 1 WATT
	RESISTOR, VAR.	RP101FH3R0KK (1)	1	7.5	7.5	"
	RESISTOR, VAR.	RN4NAYSK503B (2) RN4LAYS104B (9) RN65B1473F (2)	11	22.0	242	"
	RESISTOR, FIXED FILM	5000 ±10% 2W	2	.03	.06	"
	RESISTOR, VAR.		2	8.6	17.2	" RA
	SWITCH, ROTARY		4	1.7	6.8	"
	SWITCH, TOGGLE		2	.68	1.36	"
	SWITCH, SENS.		1	1.1	1.1	"



DATE 10/30/77

DATE 10/30/77

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# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/78

SYSTEM	SUBSYSTEM	EQUIPMENT	GROUP	UNIT	ASSEMBLY	SUBASSEMBLY	SHEET
WLR-16				C-26976	SERVO AMP, TRANSFER		1-3
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE %	HA	REMARKS
	NOMENCLATURE	NUMBER	(QTY)				
	FIXED CAPACITOR, PAPER	CPV09AIKB104K	(1)	12	.0016	.019	N5
		CPV09AIKC103KM	(1)				
		CPV09AIKE332KM	(2)				
		CPV09AIKF224KM	(1)				
		CPV09AIKF103KM	(3)				
		CPV09AIKF223KM	(4)				
	FIXED CAPACITOR, PAPER	CP09AIKC472KM	(2)	4	.016	.064	
		CP54BIEB205K	(1)				
		10uf ±20% 200VDC	(1)				
	DIODE, SILICON	JAN IN458		4	.75	3.00	
	CHOPPER, TRANSISTOR	4 PNP TRANSISTORS & 1 TRANSFORMER		1	6.82	6.82	
	RELAY, GEN. PUR.	APDT, 280 ~ 27.5VDC		1	1.6	1.6	
	CONNECTOR, PANEL	25 CONTACTS DB-25P-C7		1	.56	.56	
	RESISTOR, COMP.	RCR20B104KM (3)		46	.0077	.354	
		RCR42G683KM (1)					
		RCR20G103KM (4)					
		RCR20G105KM (7)					
		RCR20G683KM (2)					
		RCR20G225KM (2)					
		RCR20G564KM (2)					
		RCR32G333KM (1)					
		RCR32G393KM (1)					
		RCR20G123KM (1)					
		RCR20G224KM (1)					
		RCR20G332KM (3)					
		RCR20G473KM (2)					
		RCR20G474KM (2)					
		RCR42G222KM (1)					
		RCR42G103JM (1)					



# THE REVIEW RELIABILITY ANALYSIS WORKSHEET

[illegible]



DATE 10/20/78

[illegible]

# INTERVIEW RELIABILITY ANALYSIS WORKSHEET

[illegible]

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/30/78

DATE: \_\_\_\_\_  
SUBASSEMBLY: \_\_\_\_\_

ASSEMBLY: A4  
STOR. CHAS.

UNIT: 13  
C-2697E

GROUP:

EQUIPMENT:

**SUBSYSTEM:**

81-272

1536

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# THE HERNIM RELIABILITY ANALYSIS WORKSHEET

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE
WLR-10				RF-89D FREQ-DISC.		10/31/72
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE %	REMARKS
	NOMENCLATURE	HUMBER (QTY)	HA			
	CAPACITOR, FIXED	CK70AW102M (11)	.44	11	4.84	N3
	CAPACITOR, FIXED	CP5382EF205M	.016	1	.016	"
	CONNECTOR, COAX.		1.1	9	9.9	"
	CONNECTOR, PANEL	4 CONT. 750VDC 13A 16 CONT. 900VAC 5A	.56	1	.56	"
	RELAY, COAX.	SPDT 50~100W 50MHz 28VDC 300~200L	1.6	1	1.6	"
	TRANSFORMER, PWR.	PRI. 115V 60Hz SEC. 6.3V @ 5A CT.	.064	1	.064	"
	160MHz CONV. ASSY.	A1	181.205	1	181.205	"
	60MHz LIM.+DISC. ASSY.	A2	289.910	1	289.910	"
	AUTO. FREQ. CONTROL ASSY.	A3	217.260	1	217.260	"
	11MHz. DISC. ASSY.	A4	159.846	1	159.846	"
	VIDEO AMP. ASSY.	A5	128.622	1	128.622	"

# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	DATE:	SHEET	OF
VLR-16				14 RF-89D FREQ. DISC.	A1 160MHz CONVERTER		10/31/78	1	CF
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY	FAILURE RATE	HA	REMARKS		
	NOMENCLATURE	NUMBER (QTY)		N	λ				
	CAPACITOR, FIXED, CERAM.	CK60AW102M (24)		24	.44	10.56	NS		
	CAPACITOR, FIXED, CERAM.	CC300J1013 (3)		5	.44	2.20	"		
		CC200K0200 (1)		—	—	—	"		
		CC20CH2000 (1)		—	—	—	"		
	CAPACITOR, FIXED, GLASS	470PF ±5% 500VDC		5	.25	1.25	"		
	CONNECTOR, COAXIAL	250PFM/°C TC UG-1094/U (1)		2	1.1	2.2	"		
	COIL, RF, WOUND	1 CONT. 500VDC PLAS. DI. (1)		14	.066	.924	"		
		M375008-35 (3)		—	—	—	"		
		M375008-26 (1)		—	—	—	"		
		M375008-23 (2)		—	—	—	"		
		M375008-34 (8)		1	.066	.066	"		
	CHOKE, RF	0.25μh 0105-2 1.5A		—	—	—	"		
	CONNECTOR, PANEL	15 CONT. 190VDC @ 5A DA-15P-C7		2	.56	1.12	"		
	RESISTOR, FIXED, COMP.	RCR20G470KM (2)		11	.0077	.085	"		
		RCR20G474KM (1)		—	—	—	"		
		RCR20G181KM (1)		—	—	—	"		
		RCR20G101KM (3)		—	—	—	"		
		RCR20G472KM (1)		—	—	—	"		
		RCR20G471KM (2)		—	—	—	"		
		RCR20G100JM (1)		—	—	—	"		
	RESISTOR, FIXED, FILM	RN65B5110F (1)		3	.03	.09	"		
		RN65B2151F (2)		1	32.5	32.5	"		
	TUBE, REC.	5725/6AS6W		3	32.5	97.5	"		
	TUBE, REC.	5654		1	32.5	32.5	"		
	TUBE, REC.	5670		—	—	—	"		

DATE 10/31/78

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# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: <b>WLR-16</b>	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: <b>14</b> <b>RF-89S</b>	ASSEMBLY: <b>A2</b> <b>60MHz</b>	SUBASSEMBLY:	DATE: <b>10/31/78</b>	SHEET <b>1</b> OF <b>1</b>
				FREQ. DISC.	LIM. + DISC.			

INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	HA	REMARKS
	NOMENCLATURE	NUMBER (QTY)					
	CAPACITOR, FIXED	CK60A2102W (30)		36	.44	15.84	NS
		CC300J101J (5)		—	—	—	"
		CC20CKOR5C (1)		—	—	—	"
	CAPACITOR, FIXED	470PF ±5% +250PPM/°C		4	.25	1.0	"
	CAPACITOR, GLASS	500NDCN (4)		3	1.1	3.3	"
	CAPACITOR, ELECTRO.	CL31CN020MP3 (3)		7	.47	3.29	"
	CAPACITOR, VAR.	PC36H080 (7)		4	.75	3.0	"
	DIODE, SILICON	1N251		3	1.1	3.3	"
	CONNECTOR, COAX.			1	1.6	1.6	"
	RELAY	DPDT, 28VDC OR 115VAC @ 2A, 10KΩ COIL 6mA TRIP		12	.066	.792	"
	COIL, RF, MOLDED	MS75008-34		1	.56	.56	"
	CONNECTOR, BACK & PANEL	15 CONT. 490VDC 5A DA-15P-C7		13	.0077	.100	"
	RESISTOR, FIXED	RCR20G221K (1)		—	—	—	"
		RCR20G562K (1)		—	—	—	"
		RCR20G561K (1)		—	—	—	"
		RCR20G821K (1)		—	—	—	"
		RCR20G121K (3)		—	—	—	"
		RCR20G222K (1)		—	—	—	"
		RCR20G104K (3)		—	—	—	"
		RCR20G121K (1)		—	—	—	"
		RCR20G102K (1)		—	—	—	"
	RESISTOR, FIXED	RN65B75R0F (1)		24	.03	.720	"
	FILM	RN65B1420F (1)		—	—	—	"
		RN65B2871F (1)		—	—	—	"
		RN65B1961F (1)		—	—	—	"

# INTERVIEW RELIABILITY ANALYSIS: WORKSHEET

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE:	
WLR-16				14 RF-89B	A2 60 MHz.	10/31/71	
				FREQ. DISC.	LIMIT DISC.	SHEET 2 OF 2	
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE %	HA	REMARKS
	NOMENCLATURE	NUMBER (QTY)					
		RN65B5620F	(1)	—	—	—	NS
		RN65B4640F	(1)	—	—	—	
		RN65B6810F	(1)	—	—	—	
		RN65B1004F	(4)	—	—	—	
		RN65B5621F	(4)	—	—	—	
		RN65B4642F	(1)	—	—	—	
		RN65B1473F	(1)	—	—	—	
		RN65B1213F	(1)	—	—	—	
		RN65B1103F	(1)	—	—	—	
		RN65B3480F	(1)	—	—	—	
		RN65B3161F	(1)	—	—	—	
		RN65B2151F	(1)	—	—	—	
		RN65B1333F	(1)	—	—	—	
		RN65B4624F	(1)	—	—	—	
	VAR.	RV6LAYSA103B	(1)	2	22.0	44.0	
	COMP.	RV6LAYSA252B	(1)	2	8.6	17.2	
	VAR.	20K ±10% 0.8W		3	.066	.198	
	VAR.			5	32.5	162.5	
	RF TRANSFORMER			1	32.5	32.5	
	TUBE, REC.	5654		2	.0048	.010	
	TUBE, REC.	68N6					
	P.C. BOARD	CLASS EPOXY					



# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: WLR-10		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 14	ASSEMBLY: A3	SUBASSEMBLY:	DATE: 10/31/78	SHEET: 1 of 1
INDEX NUMBER		DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	NA	REMARKS	
NOMENCLATURE		NUMBER (QTY)							
	CAPACITOR, FIXED, CERM.	CK60AW102W			14	.44	6.16	NS	
	CAPACITOR, FIXED, PAPER	CP11A3KB105K (1)			2	.016	.032	"	
	CAPACITOR, FIXED, CERM.	CC30UJ620J (3)			6	.44	2.64	"	
		CC20CH100C (1)			1	—	—	"	
		CC30UJ101J (2)			3	.25	.75	"	CY
	CAPACITOR, FIXED, GLASS	470pf ±5% +250ppm/°C			1	.56	.56	"	
	CONNECTOR, COAX.	500VDC			1	1.1	1.16	"	
	RELAY, GEN. PUR.	28VDC OR 115VAC @ 2A			15	.066	.990	"	
	COIL, RF, MOLDED	10K-2 COIL 6MA. TRIP			—	—	—	"	
		MS75008-35 (3)			—	—	—	"	
		MS75009-41 (2)			1	.56	.56	"	
		MS75008-34 (10)			16	.0077	.123	"	
	CONNECTOR, COAX.				—	—	—	"	
	RESISTOR, FIXED, COMP.	RCR20G154KM (1)			1	.56	.56	"	
		RCR20G561KM (1)			—	—	—	"	
		RCR20G563KM (1)			—	—	—	"	
		RCR20G152KM (1)			—	—	—	"	
		RCR42G102KM (1)			—	—	—	"	
		RCR20G822KM (1)			—	—	—	"	
		RCR20G471KM (1)			—	—	—	"	
		RCR20G224KM (1)			—	—	—	"	
		RCR20G105KM (1)			—	—	—	"	
		RCR20G222KM (1)			—	—	—	"	
		RCR20G103KM (2)			—	—	—	"	
		RCR20G473KM (1)			—	—	—	"	
		RCR20G104KM (1)			—	—	—	"	



# INHERENT RELIABILITY ANALYSIS SOFTWARE

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE:
WLR-16				14 RF-89D FREQ. DISC.	A3 AUTO. FREQ. CONTROL	10/3/78
SHEET 2 OF 2						
INDEX NUMBER	NOMENCLATURE	NUMBER	QUANTITY N	FAILURE RATE %	NA	REMARKS
		RCR 206102 KM (1)	1	—	—	NS
	RESISTOR, FIXED	RN65B3160F (1)	8	.03	.240	"
	RESISTOR, FILM	RN65B1473F (3)	1	—	—	"
		RN65B1783F (1)	1	—	—	"
		RN75B5232F (1)	1	—	—	"
		RN75B4532F (1)	1	—	—	"
		RN65B2871F (1)	1	—	—	"
	RESISTOR, VAR.	1K $\Omega$ $\pm$ 10% 0.8W	1	8.6	8.6	"
	TUBE, REC.	5751	1	32.5	32.5	"
	TUBE, REC.	6C4-VA	2	32.5	65.0	"
	TUBE, REC.	6AH6WA	1	32.5	32.5	"
	TUBE, REC.	5654	2	32.5	65.0	"
	P.C. BOARD		1	.0048	.0048	"

# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: <b>WLR-16</b>	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: <b>RF-89D</b>	ASSEMBLY: <b>A4</b>	SUBASSEMBLY:	DATE <b>10/31/78</b>	SHEET <b>1</b> OF <b>3</b>
				<b>FREQ. DISC.</b>				

INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	NA	REMARKS
	NOMENCLATURE	NUMBER					
	CAPACITOR, FIXED, CER.M.	CK60A2102W		14	.44	6116	NS
	CAPACITOR, FIXED, CER.M.	CC32VJ301F (1)		3	.44	1,32	"
	CAPACITOR, FIXED, CER.M.	CC20SH060B (2)		4	.75	3.0	"
	DIODE, SILICON	1N251		3	1.1	3.3	"
	CONNECTOR, COAX.			2	1.6	3.2	"
	RELAY	DDPT 28VDC OR 115VAC @ 2A 10KA COIL		7	.066	.462	"
	COIL, RF, WOLDED	MS75008-41 (2)		1	.56	.56	"
	CONNECTOR, RACK & PANEL	MS75008-34 (5)		19	.0077	.146	"
	CONNECTOR, RACK & PANEL	15 CONT. 490VDC @ 5A DA-1SP-C7		—	—	—	"
	RESISTOR, COMP.	ROR 206 223KM (1)		—	—	—	"
		ROR 206 820KM (1)		—	—	—	"
		ROR 206 272KM (1)		—	—	—	"
		ROR 206 225KM (1)		—	—	—	"
		ROR 206 101KM (1)		—	—	—	"
		ROR 206 470KM (2)		—	—	—	"
		ROR 206 121KM (2)		—	—	—	"
		ROR 206 154KM (2)		—	—	—	"
		ROR 206 104KM (2)		—	—	—	"
		ROR 206 105KM (2)		—	—	—	"
		ROR 206 474KM (2)		—	—	—	"
		ROR 206 564KM (2)		2	22.0	44.0	"
	RESISTOR, VAR. COMP.	RVL6LAYS 504B (2)		3	.066	.198	"
	TRANSFORMER, RF			1	32.5	32.5	"
	TUBE, REC.	6BA7		2	32.5	65.0	"
	TUBE, REC.	5654					



# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: WLR-16		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: 14 RF-89D FREQ. DISC.	ASSEMBLY: A5 VIDEO AMP.	SUBASSEMBLY:	DATE: 10/31/78	SHEET 1 OF 1
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	HA	REMARKS		
	NOMENCLATURE	NUMBER (QTY)							
	CAPACITOR, FIXED	CL33CB100MNI (1)	3	1.1	3.3	Ns			
	CAPACITOR, ELECTRO.	CL21CN040SP3 (2)	2	.016	.032	"			
	CAPACITOR, FIXED	CP05AIKB224K (1)	4	.0016	.006	"			
	CAPACITOR, ELECTRO.	CP05AIKC104K (1)	1	.078	.078	"			
	CAPACITOR, FIXED	CPV09AIKC104KM (1)	2	.016	.032	"			
	CAPACITOR, PAPER	CPV09AIKE473KM (3)	3	1.1	3.3	"			
	CAPACITOR, MICA	CM20E242G (1)	1	.066	.066	"			
	CAPACITOR, FIXED	10mf ±20% 200VDC	1	.56	.56	"			
	CAPACITOR, PAPER	1.0mf ±5% 200VDC	18	.0077	.139	"			
	CONNECTOR, COAX.	1 CONT. 500VDC (2) V6-109410 (1)	1	—	—	"			
	RELAY, GEN. PUR.	DPDT 28VDC OR 115 VAC @ 2A 10KA COIL	1	—	—	"			
	COIL, RF	220mh 5.9 ~ 290ma. 1 IT SEC.	1	—	—	"			
	CONNECTOR, PANEL	15 CONT. 490VDC 5A	1	—	—	"			
	RESISTOR, FIXED	RCR206332KM (1)	1	—	—	"			
		RCR206104KM (1)	1	—	—	"			
		RCR206224KM (1)	1	—	—	"			
		RCR206684KM (1)	1	—	—	"			
		RCR426333KM (1)	1	—	—	"			
		RCR426822KM (2)	1	—	—	"			
		RCR426103KM (2)	1	—	—	"			
		RCR206151KM (2)	1	—	—	"			
		RCR206103KM (2)	1	—	—	"			
		RCR206184KM (2)	1	—	—	"			
		RCR206102KM (1)	1	—	—	"			
		RCR206472KM (1)	1	—	—	"			
		RCR206473KM (1)	1	—	—	"			
	VAR.	RJ11AKAS04B (1)	1	—	—	"			



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/31/78

**SUBASSEMBLY:**

SHEET 2 OF 2

[illegible]

100

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 12/29/72

SYSTEM: WLC-16		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT: POWER SUPPLY PP2156D	ASSEMBLY:		SUBASSEMBLY:		SHEET 1 OF 1
INDEX NUMBER	DEVICE IDENTIFICATION			NUMBER	QUANTITY N	FAILURE RATE λ	RA	REMARKS		
	NOMENCLATURE									
	CAPACITOR			CP60B1FHX5M	1	.016	.032	1	NS	
	"			CP70B1F6XX5M	2	.016	.032	"	"	
	"			CP72B1F6XX5K	2	.016	.032	"	"	
	"			CP09A1	2	.016	.032	"	"	
	"			CP70 FF, CP41 FF	4	.016	.064	"	"	
	FUSE			MIL F02A250X1 A1E204221	6	0.1	0.6	"	"	
	RELAY DDDT			RLN15 5NAPS	1	1.6	1.6	"	"	
	" SPDT			1AMP	1	1.6	1.6	"	"	
	" SPST, Thermal			(C/S) 32V 0.1A	1	.40	.40	"	"	
	DDDT			2A	2	1.6	3.2	"	"	
	CHOKE			10H, 60mA, SEALED	1	.066	.066	"	"	
	"			5H, 170mA/24 170mA	1	.066	.066	"	"	
	"			3H, 50mA/1.5 100mA	2	.066	.132	"	"	
	METER				1	10	10	"	"	
	RESISTOR			RCR32 x 5M	4	.0077	.308	"	"	
	"			RCR206 x 1/4 - 4K	22	.0077	1.694	"	"	
	"			RCR206 x 1/4 5K	5	.0077	.385	"	"	
					SUM OF N λ					

# IMMEDIATE RELIABILITY ANALYSIS WORKSHEET

SYSTEM:		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE:	SHEET
WLR-14					POWER SUPPLY		10/27/77	2 OF 2
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY	FAILURE RATE X	HRS	REMARKS	
	NOMENCLATURE	NUMBER						
	RESISTOR, Fixed	RCR42X1K-4K	18	.0077	1386	174 IN "	NS	
	COMPONENT, INCANDESCENT		3	1.0	3.0		"	
	RESISTOR, Variable	RV42X1K-4K	4	22	88	111	"	
	" Fixed	RCR32X1K-4K	2	.0077	.154	"	"	
	"	RV59X1K-4K	2	.43	0.86	"	"	
	"	RV59X1K-4K	1	0.9	0.9	"	"	
	"	RV59X1K-4K	2	0.9	1.8	"	"	
	"	RV59X1K-4K	8	.03	.24	174 IN "	"	
	SWITCH, ROTARY	8POS, 2 SEC, .25A	1	1.7	1.7		"	
	" TOGGLE	125V, 20A, 115-054-22	1	.68	0.68		"	
	SWITCH DISTRIBUTION	3POS, 2 SEC, .25A	1	.46	.46		"	
	TRANSFORMER, POWER	125V, 20A, 115-054-22	5	.064	.32		"	
	TUBE, RECTIFIER	5Y4, 250V, 300mA	2	65	130		"	
	TUBE, REGULATOR (GAS DIODE)	5Y4, 250V, 300mA	3	65	195		"	
	TUBE, RECENER	5Y4, 250V, 300mA	10	32.5	325		"	
	AIS ELECTRICAL EQUIPMENT CABINET		1	11,096	11,096		"	
	DIODE	1N3614 (20) 1N1002	22	.75	16.5		"	

SUM OF HRS:

794.339

MTBF = 1259 HRS



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/29/72

WLR-16

**SUBSYSTEM:**

EQUIPMENT:

**GROUP:**

UNLT: 15

UNIT: 15  
DOWNSIDE  
P251260

ASSEMBLY: A15-  
CABINET

**SUBASSEMBLY:**

—

[illegible]

# IMMEDIATE RELIABILITY ANALYSIS WORKSHEET

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE:	SHEET	OF
IVLR-1G				16 POWER SUPPLY PD-2157D		10/29/72	1	01
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY	FAILURE RATE	NA	REMARKS	
	NOMENCLATURE	NUMBER		N	λ			
	CAPACITOR							
		CP60B1FHXXSM		6	.016	.096	NA	NS
		CPV09AK1E100KXN	600V	7	.016	.112	NA	"
		CP11A3K104K	200V	6	.016	.096	NA	"
		CD70B1FAXX5K	500V	7	.016	.112	NA	"
		CP72E1E1E106K	600V	1	.016	.016	1	"
		CP54B1E1E105M	1000V	1	.016	.016	1	"
		CP11A3K1E103K	600V	3	.016	.048	NA	"
		CN115E101G	500V	3	.078	.234	NA	"
		CD10A3K1E101V	500V	1	.016	.016	1	"
	DIODE, RECT	1N3614		36	.75	27.0		"
	LAMP, INCANDESCENT			3	1.0	3.0		"
	SWITCH, INTERLOCK (P/B)			2	.46	0.92		"
	FUSE	F02B250V 80084		6	0.1	0.6		"
	RELAY, GP	4PDT P/N-23509-9C 04231		2	1.6	3.2		"
	" , GP	DPDT, 5A P/N115		1	1.6	1.6		"
	REACTOR	100MR, 2-10H		2	0.066	0.132		"
	" (2 COILS)	2-5H, 200-500MH		2	0.066	0.132		"
					SUM OF NAs		37.33	

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 10/29/72

SYSTEM: WLR-16		SUBSYSTEM:		EQUIPMENT:		GROUP:		UNIT: 16		ASSEMBLY:		SUBASSEMBLY:		SHEET 2 OF 2	
POWER SUPPLY		PP-2157D		FAILURE RATE λ		QUANTITY N		FAILURE RATE λ		REMARKS					
INDEX NUMBER		NOMENCLATURE		NUMBER		FAILURE RATE λ		QUANTITY N		FAILURE RATE λ		REMARKS			
	REACTOR		3M 250MA/6H 100VAC		1	0.066	0.066	1	0.066	0.066	NS				
	VOLTMETER				1	10	10	1	10	10					
	RESISTOR	FIXED	RCR 20GXX/K - XXK		52	.0077	.0077	52	.0077	.4004					
	"	"	RCR 20GXX/K - 5K		11	.0077	.0077	11	.0077	.0847					
	"	"	ROR 32GXX/K - 4K		-			-							
	"	"	ROR 42GXX/K - XXK		14	.0077	.0077	14	.0077	.1078					
	"	"	RNG 50XX/K - 4K 1/4W		51	.03	.03	51	.03	1.53					
	"	VARIABLE	RV 4-XX/K - 4A		5	22	22	5	22	110					
	"	"	RV 4-XX/K - 4A		1	22	22	1	22	22					
	"	FIXED	RW 59VXX/K 3W		14	.43	.43	14	.43	6.02					
	"	"	RW 29V502 11W 5K		1	.43	.43	1	.43	.43					
	"	"	RN 70BXX/K - 4F 1/2W		1	.03	.03	1	.03	.03					
	"	"	RB 77AKXX/K - 2F 1/2W		2	0.9	0.9	2	0.9	1.8					
	"	"	RB 19AEXX/K - 1-2		2	0.9	0.9	2	0.9	1.8					
	SWITCH, ROTARY, NON-SHORT		PPUS, 3 SEC 250VAC		1	1.7	1.7	1	1.7	1.7					
	"	PUSHBUTTON	DPDT, 3A		1	0.46	0.46	1	0.46	.46					
	"	TOGGLE	SPST, 4A		1	0.68	0.68	1	0.68	.68					
										SUM OF N λ's		157.1084			



DATE: 10/30/78

DATE: 10/30/78

[illegible]
$$MTBF = 18,500 \text{ HR}$$



DATE 11/2/78[illegible]





DATE: 11/2/78

[illegible]

# INHERENT RELIABILITY ANALYSIS WORKSHEET

[illegible]

Sum of 30 trials

22,24

$$\text{WTRF} = 44,964 \text{ lrs.}$$



# ANALYSIS OF WORKSHEET

DATE 11/2/78

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:
ALC-10				21	A1	
				CY-2519	CABINET ASSY	

[illegible]

SUM OF N'S

11,12

DATE 11/2/78

11/2/28

[illegible]

5110 NE N.Y.

11.12

DATE 11/2/78

[illegible]

WILLIAM W. WILSON

24.88

WTBF = 40193 lbs.







# INTERVIEW RELIABILITY ANALYSIS VORAKSHEET

DATE 11/2/19

SUBASSEMBLY:

十

[illegible]



# INTERVIEW RELIABILITY ANALYSIS

[illegible]







# INTERVIEW RELIABILITY ANALYSIS WORKSHEET

DATE 11/3/78

— SHEET

[illegible]



DATE 11/3/88

[illegible]



DATE 1930/18

[illegible]



DATE 10/30/78[illegible]

NOTE = 42, 141 HRS.



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 11/1/78

SYSTEM: AS-89F		SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	SHEET 1 OF 3	
INDEX NUMBER	NOMENCLATURE			DEVICE IDENTIFICATION		QUANTITY N	FAILURE RATE %	HA	REMARKS
			HUMBER (QTY)						
	MOTOR, SPLIT PHASE	100W DRIVE MOTOR		INDUCTION GENERATOR		1	70.0 0.80	70.8	Nu
	SYNCHRO GENERATOR	115VAC 60Hz		TRANSMITTER		1	2.119	2.119	"
	CAPACITOR, FIXED	CP53BIEF20SK (1)				2	.09	.18	"
	FILTER	TYPE FL53BIEA PER MIL-F-15733B				2	.066	.132	"
	HEATER	115V, 150W				2	4.468	8.936	"
	CONNECTOR, COAX-					12	2.6	31.2	"
	CONNECTOR, CIRC.	MS-3112E-20-16PW (2)				3	2.0	6.0	"
	INDUCTOR, ARDJ.	UNITED TRANSFORMER INC-7 (1) INC-12 (1)				2	.066	.132	"
	GEARING					1	20	20	"
	BEARING, BALL					7	34.4	240.8	" ← 380.30
	BEARING+PULLEY ASSY.					1	1.27 2.0	21.27	"
	SHAFT, CIRC. STEEL					4	1.237	4.948	"
	TIMING BELT	FIBRE CABLE, NEOPRENE TEETH, NYLON FACING				1	4.007	4.007	"
	GEAR, SPUR	COTTON BASE PHENOLIC, HVB C'RES STEEL				2	86	172	"
	GEAR, SPUR	C'RES STEEL				1	86	86	"
	PULLEY					2	1.27	2.54	"
	GASKET, RUBBER					10	.60	6.0	"

# CONHERENÇIA RELIABILITAT ANALYSIS WARGKINET

**WELSYS**

AC-299F

**SUBSYSTEM:**

**• INDEPENDENT •**

CONFIDENTIAL

11015

**ASSEMBLY:**

**SUBASSEMBLY.**

2 SHEET OF

DATE 11/11/12[illegible]

# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE 11/3/78

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	SHEET	OF
C-3118							1	CF
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE λ	WA	REMARKS	
	NOMENCLATURE	NUMBER (QTY)						
	RESOLVER, ELEC.	26V INPUT 400 HZ 565A 12.6V OUT 0.484 RATIO		1	55.556	55.556	NS	
	SYNCHRO, REC.			1	2.119	2.119	"	
	SYNCHRO, CONTROL TRANSFORMER			1	2.644	2.644	"	
	CAPACITOR, FIXED	2.5mf 50VDC (3) .16mf 10VDC (2) 250mf 15VDC (1) .250mf 25VDC (1) .200mf 15VDC (1)		8	3.8	30.40	" CE CPL, P.C. (4)	
	CAPACITOR, FIXED PAPER	4700pf 300VDC		1	.016	1016	" CP D.F.C. (1)	
	DIODE, GERM.	JAN 1N277		2	2.5	5.0	"	
	DIODE, RECT. GERM.	1N93		2	2.5	5.0	"	
	DIODE, SILICON	SV-202 TRANSISTOR ELECTRONICS CORP GLASS CLOTH EPOXY		1	.91	.91	"	
	P.C. BOARD	6 AMP. 250V (4) 15 AMP. 250V (2) 4 AMP. 250V (4)		1	.0048	.0048	"	
	FUSE, CARTRIDGE			10	.10	1.00	"	
	LAMP, NEON	NE-51		4	.20	.80	"	
	LAMP, INCAN.	328		13	1.00	13.0	"	
	CONNECTOR, COAX.	UG-281/U		1	1.1	1.1	"	
	COIL, RF	47 ± 10% OH 0.122 MAX. 30mh 500V RMS (1)		2	.066	.132	"	



# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM: C-3118	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	DATE: 11/3/78	SHEET 2 OF 2
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	HA	REMARKS
	NOMENCLATURE	NUMBER (QTY)					
	RELAY, THERMAL	SPDT 115VAC @ 265VDC 15AMP MAX.		1	.746	.746	NS
	GEAR	NYLON		1	.236	.236	"
	GEAR, PINION	STAINLESS STEEL		1	.236	.236	"
	GEAR, SPUR	ALUMINUM		1	.236	.236	"
	GEAR, COUPLING	ALUMINUM		1	.236	.236	"
	GEAR, SHAFT ASSY.			1	.236	.236	"
	COUPLING, FLEXIBLE	PHOSPHOR BRONZE		1	.540	.540	"
	PHOTO-DIODE	SILICON IN2175		1	.91	.91	"
	TRANSISTOR, GERM. NPN	2N35		6	9.0	54.0	"
	RESISTOR, FIXED	RC20GF222K (5)		25	.039	.975	"
		RC20GF822K (1)					"
		RC20GF472K (1)					"
		RC20GF102K (4)					"
		RC20GF182K (2)					"
		RC20GF122K (1)					"
		RC20GF332K (1)					"
		RC20GFS62K (1)					"
		RC20GF682K (1)					"
		RC20GF103K (2)					"
		RC20GF221K (1)					"
		RC20GF100K (2)					"
		RC30BF103K (2)					"
		RC30BF104K (1)					"
	RESISTOR, VAR.	3 1/2 25W		1	7.5	7.5	RP
	RESISTOR, VAR.	RV4ATR3103A (1)		9	22.0	198.0	"
	RESISTOR, COMB.	RV4ATSD103A (7)					"

DATE: 11/3/78

DEPT. OF AGRICULTURE  
BUREAU OF PLANT INDUSTRY





# INHERENT RELIABILITY ANALYSIS WORKSHEET

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY: A1	SUBASSEMBLY:	DATE: 11/2/78	SHEET: 1 OF 2
AN-1017B					AMP. - PWR. SUP.			

DEVICE IDENTIFICATION				QUANTITY N	FAILURE RATE λ	WA	REMARKS
INDEX NUMBER	NOMENCLATURE	NUMBER (QTY)					
	DIODE, ZENER SILICON	IN964B		1	.91	.91	Ns
	DIODE, RECTIFIER SILICON	IN560		8	.75	6.00	"
	DIODE, ZENER SILICON	IN3030B		1	.91	.91	"
	CAPACITOR, FIXED ELECTRO.	CL31CH550MP3 (1)		5	1.9	9.50	"
		CL25BF600UP3 (1)					
		CL25B6121UP3 (1)					
		CL25BQ360SP3 (1)					
		CL25BL101TP3 (1)		—	—	—	"
	TRANSISTOR, NPN SILICON	2N2222A		3	1.1	3.3	"
	TRANSISTOR, PNP SILICON	2N2907		1	1.7	1.7	"
	TRANSISTOR, NPN SILICON	2N657		4	1.1	4.4	"
	TRANSISTOR, NPN SILICON	2N3902		2	1.1	2.2	"
	RESISTOR, FIXED COMP.	RCR206F103J (4)		15	.0077	.1155	"
		RCR206F183J (1)					
		RCR206F223J (1)					
		RCR206F332J (1)					
		RCR206F333K (1)		—	—	—	"
		RCR206F122J (3)		—	—	—	"
		RCR206F222K (1)		—	—	—	"
		RCR206F102K (3)		—	—	—	"
	RESISTOR, VAR.	RV6LAYS102A (1)		2	22.0	44.0	"
	RESISTOR, VAR.	RV4LAYS104A (1)		1	8.6	8.6	"
	RESISTOR, FIXED WIRE	RK09VACS102		3	.43	1.29	"
		RW55V682 (1)		3	.43	1.29	"
		RW55V332 (2)					

—

[illegible]

# INTERVIEW RELIABILITY ANALYSIS VARIANTS

[illegible]





DATE: 11/2/93

[illegible]

# IMPROVING RELIABILITY ANALYSIS SOFTWARE

[illegible]



# INHERENT RELIABILITY ANALYSIS WORKSHEET

DATE: 11/2/78  
SHEET 1 OF 2

SYSTEM:	SUBSYSTEM:	EQUIPMENT:	GROUP:	UNIT:	ASSEMBLY:	SUBASSEMBLY:	
AN/WLA-3B				CONTROL - IND.	C-9993/WLA-3B		
INDEX NUMBER	DEVICE IDENTIFICATION			QUANTITY N	FAILURE RATE X	WA	REMARKS
	NOMENCLATURE	NUMBER (QTY)					
	CAPACITOR, ELECTRO.	CE44C550N085	1	3.8	3,80	Ns	
	DIODE	1N1614	4	.75	3,00	"	
	LAMP, INCAND.	WS2S237-327T	22	1.0	22.0	"	
	FUSE	FO3A2SON10AS	1	0.10	.10	"	
	CONNECTOR	MS3102A16S1P (1) MS3102A22-14S (4)	5	.56	2,80	"	
	REFLECTOR	30WH MIN. @ 15V 94HZ 3.5ADC 0.4 A DC RES.	1	.066	.066	"	
	METER	115VAC 2.7W CONT. DUTY 9999.9 HR.	1	10.0	10.0	"	
	TRANSISTOR	2N1485	1	1.1	1.1	"	
	RESISTOR, VAR. COMP.	RV4NAYS0500A	1	22.0	22.0	"	
	RESISTOR, FIXED COMP.	RC42GF471J (1) RC20GF391K (16) RC20GF821K (1)	18	.039	.702	"	
	SWITCH, ROTARY	SINGLE SEC. 3 POS. 3 POLE	4	1.7	6.80	"	
	SWITCH, TOGGLE	WS2S126-8	1	.68	.68	"	
	TRANSFORMER, PWR.	PRI. 115VAC 60HZ SEC. 28VAC 5A	1	.064	.064	"	
						"	
						"	
						"	

# INHERENT RELIABILITY ANALYSIS VARIATION

DATE \_\_\_\_\_

11/2/79

[illegible]





DATE 11/2/02

02130

DATE 11/2/78

[illegible]

DATE 11/2/98[illegible]



PART CLASS: *SWITCH*

DESCRIPTION: *STEPPING*

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per 10 <sup>6</sup> Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
<i>GROUND DORMANT</i>	<i>0.4</i>		
<i>SHIPBOARD NAVAL SHELTERED</i>	<i>3.6</i>		

Multiplicative Application Factors  
for Environment

Environment:      Shipboard      *DORMANT*  
                         *SHELTERED*      *GROUND*  
Factor:              *9.0\**      *1.0*

Failure Definition:

*\* FACTOR BASED ON MIL-HDBK-217B*

PART CLASS: SWITCHES

DESCRIPTION: COAXIAL

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
GROUND	0.247		
SHIPBOARD NAVAL UNSHELTERED	2.717		
SHIPBOARD NAVAL SHELTERED	2.223		

Multiplicative Application Factors  
for Environment

Environment:

Shipboard  
UNSHELTERED SHELTERED

Factor:

11 \* 9 \*

Failure Definition:

\* FACTOR BASED ON MIL-HDBK-217B RELAY ENVIRONMENTAL  
FACTORS

PART CLASS: SYNCHROS + RESOLVERS

DESCRIPTION: SYNCHRO CONTROL TRANSFORMER

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
AIRBORNE	9.032		
SHIPBOARD	2.644 *		

Multiplicative Application Factors  
for Environment

Environment: Shipboard AIRBORNE  
Factor: 1 3.42

Failure Definition: \* FACTOR BASED ON SYNCHRO CONTROL TRANSMITTER  
RATES, RADC-TR-75-22



PART CLASS: SYNCHROS + RESOLVERS

DESCRIPTION: SYNCHRO RECEIVER / TRANSMITTER

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
AIRBORNE	7.246		
SHIPBOARD	2.119 *		

Multiplicative Application Factors  
for Environment

Environment: Shipboard AIRBORNE  
Factor: 1 \* 3.42

Failure Definition: \* FACTOR BASED ON SYNCHRO CONTROL  
TRANSMITTER RATES, RADC - TR - 75-22

PART CLASS: SYNCHROS + RESOLVERS

DESCRIPTION: SYNCHRO RECEIVER / TRANSMITTER

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
AIRBORNE	7.246		
SHIPBOARD	2.119 *		

Multiplicative Application Factors  
for Environment

Environment: Shipboard AIRBORNE

Factor: 1 \* 3.42

Failure Definition: \* FACTOR BASED ON SYNCHRO CONTROL  
TRANSMITTER RATES, RADC - TR - 75-22

PART CLASS:

DESCRIPTION: IC VOLTAGE REGULATOR

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per 10 <sup>6</sup> Part-Hours (A)	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
SHIPBOARD	0.103 *		

Multiplicative Application Factors  
for Environment

Environment: Shipboard

Factor: 1

Failure Definition: BASED ON AN/SLQ-32 FAILURE PREDICTION  
DATA FOR SIMILAR ITEMS

2A1A13-1R1 845688-1 0.103 (V)3 REG, IC SLQ-32



PART CLASS:

DESCRIPTION: **LIMITER**

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
SHIPBOARD	4.999 *		

Multiplicative Application Factors  
for Environment

Environment: Shipboard

Factor: 1

Failure Definition: **BASED ON AN/SLQ-32 FAILURE PREDICTION  
DATA FOR SIMILAR ITEMS**

2A1A13AR1 848471-1 4.999 (v)3 LIMITER, SLQ-32

PART CLASS:

DESCRIPTION: POWER DIVIDER

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
SHIPBOARD	2.089 *		

Multiplicative Application Factors  
for Environment

Environment: Shipboard

Factor: 1

Failure Definition: BASED ON A2/SLQ-32 FAILURE PREDICTION  
DATA FOR SIMILAR ITEMS

1A3A13A1 842368-1 1.788 (v)1,(v)3 } PWR. DIVIDERS  
20A11A6 DC2-3 570935-2 2.389 ALL SUITES } SLQ-32

PART CLASS:

DESCRIPTION: THERMOSTATIC SWITCHES

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours (A)	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
SHIPBOARD, $N_s$	0.40		
SHIPBOARD, $N_u$	2.80		

Multiplicative Application Factors  
for Environment

Environment: Shipboard,  $N_s$  SHIPBOARD,  $N_u$

Factor: 1 7

Failure Definition: BASED ON MECHANICAL DESIGN AND SYSTEMS  
HANDBOOK, TABLE 18.3.  $N_u$ , UPPER EXTREME  
 $N_s$ , LOWER EXTREME.



PART CLASS: MECHANISMS, POWER TRANSMITTAL

DESCRIPTION: PULLEY,

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per 10 <sup>6</sup> Part-Hours (A)	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
GROUND	1.27 *		
SHIPBOARD, Na	1.27 *		
GROUND, MOBILE	39.279		

Multiplicative Application Factors  
for Environment

Environment:	Na	GROUND	GROUND, MOBILE
Factor:	1	1	31.02

Failure Definition: \* BASED ON PADC-TR-75-22 SHAFT DATA

PART CLASS: MECHANISMS, POWER TRANSMITTAL

DESCRIPTION: SHAFT

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours ( $\lambda$ )	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
GROUND	1.237		
SHIPBOARD, $N_m$	1.237 *		

Multiplicative Application Factors  
for Environment

Environment:  $N_m$  Shipboard GROUND

Factor: 1 1

Failure Definition: \* BASED ON PAGE TR-75-22

PART CLASS: MECHANISM, POWER TRANSMITTAL

DESCRIPTION: FAN BELT

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per $10^6$ Part-Hours (A)	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
GROUND	4.007		
SHIPBOARD, $N_m$	4.007 *		

Multiplicative Application Factors  
for Environment

Environment:  $N_m$  SHIPBOARD GROUND

Factor: 1 1

Failure Definition: \* BASED ON PRC - TR-75-22



PART CLASS: HEATERS, ELECTRICAL

DESCRIPTION: GENERAL

FUNCTION:

ENVIRONMENT	FAILURE RATE Failures Per 10 <sup>6</sup> Part-Hours (A)	FAILURE RATE CONFIDENCE LIMITS 90% Interval	
		LOWER LIMIT	UPPER LIMIT
GROUND, MOBILE	4.168		
SHIPBOARD, NM	1.168 *		

Multiplicative Application Factors  
for Environment

Environment: NM Shipboard GROUND, MOBILE

Factor: 1 1

Failure Definition: \* BASED ON RADC-TR-75-22

Unique Component Failure Rate Estimate (cont.)

UNITS 6,7,8,9 A3 MIXER (WLR-16)

STRIPLINE MICROWAVE STRUCTURE CONSISTING OF :

NEGLECTIBLE	2 -	3DB HYBRID COUPLERS
$2 \times 17 = 34$	2 -	MICROWAVE DIODES (BALANCED MIXER CONFIG.)
* $4 \times 13 = 52$	1 -	2 STAGE TRANSISTOR AMP.
NEGLECTIBLE	1 -	10 DB DIRECTIONAL COUPLER
$1 \times 13 = 13$	1 -	DIODE DETECTOR

$89 \times 10^{-6}$

FROM SECTION 3-70 WLR-16 TECH.  
MANUAL

\* ASSUMED 1 TRANSISTOR  $\leq$  2 DIODES

Unique Component Failure Rate Estimate

MT0-101  $\frac{1}{10^2}$  MICROWAVE OSCILLATOR  
MFG. BY TEXSCAN CORPORATION, BANDS 6+7

RELIABILITY MODEL:

\*  $2 \times 13 = 26$  1- Si MICROWAVE DETECTOR TRANSISTOR \*  
 $6 \times .13 = .78$  6- FILM RESISTORS RL  
 $2 \times .066 = .132$  2- RF COILS  
 $2 \times .25 = .50$  2- Feed through caps (assume cy equiv.)  

---

27.412  $\times 10^{-6}$

GT-101 + RCA S476Y1  
MFG TEXSCAN  
BANDS 8+9

RELIABILITY MODEL

.10 1- TUNED VARIABLE CAVITY  
2.0 1- GAs FET \*  

---

2.10  $\times 10^{-6}$

\* ASSUMED 1 TRANSISTOR = 2 DIODES  
\* FROM W-3 780-19 DATA



Unique Component Failure Rate Estimate (cont.)

WJ 5090-7 Amplifier

Obsolete, replaced by Ga As FET  
Estimated Reliability per Watkins Johnson  
Approx. 100,000 hours,  $10 \times 10^{-6} \lambda$

Consists of:

- 8 FETS
- 8 caps
- 4 diodes
- 8 resistors

WJ 780-19 Amp

Equivalent to 4 Ga As FET  
Estimated Reliability per Watkins Johnson  
125,000 hours,  $\lambda = 8 \times 10^{-6}$

MT-3099-99 MICROWAVE SWITCH, ALPHA IND.

CONNECTOR & SWITCH

Estimated Reliability 70,000 hours per  
Alpha Industries,

**APPENDIX C**

**WLR-1G MAINTAINABILITY PREDICTION WORKSHEETS**

# MAINTAINABILITY ANALYSIS

23-599F ANTENNA

Sheet \_\_\_\_\_ of \_\_\_\_\_

Sub-assembly \_\_\_\_\_

Assembly \_\_\_\_\_

Unit \_\_\_\_\_

MAINTAINABLE ITEM	N	A	NA	AVERAGE MAINTENANCE TASK TIMES, HOURS							F <sub>p</sub>	M <sub>a</sub> R <sub>p</sub>
				LOCAL- IZE	ISOLA- TION	DIS- ASSEM	INTER- CHANGE	RE- ASSEM	ALIGN	CHECK- OUT		
MOTOR			71	.106	1.7	.094	2.0	0.134	1.4	.124	5.5	391
SYNCHRO			21	.106	1.7	.094	2.0	0.134	1.4	.124	5.5	11.5
CAPACITOR			.18	.106	1.7	.094	.081	0.134	0.00	.124	2.24	.4
FILTER			.13	.106	1.7	.094	.081	0.134	0.00	.124	2.24	.3
HEATER			8.9	.106	2.0	.094	1.0	0.134	0.00	.124	3.5	31.1
CONN. COAX			31	.106	1.7	.094	.103	0.134	0.00	.124	2.27	70.4
CONN. CIR			6	.106	1.7	.094	.103	0.134	0.00	.124	2.27	13.6
INDUCTOR			.13	.106	1.7	.094	1.75	0.134	0.00	.124	3.91	.51
BEARING			260.8	n/a	n/a	n/a	n/a	n/a	n/a	n/a	6.5	1695
BEARING/PULLEY			21.3	n/a	n/a	n/a	n/a	n/a	n/a	n/a	6.5	138
SLIDE			11.9	n/a	n/a	n/a	n/a	n/a	n/a	n/a	6.5	32
TIMING BELT			4	n/a	n/a	n/a	n/a	n/a	n/a	n/a	6.5	26
PULLEY			2.5	n/a	n/a	n/a	n/a	n/a	n/a	n/a	6.5	16
GEAR			258	n/a	n/a	n/a	n/a	n/a	n/a	n/a	6.5	1677
SWITCH			6.8	.106	1.7	.094	.103	.134	0.00	.124	2.27	15.4
MULTIPLEXER			9.6	.106	1.7	.094	1.75	.134	0.00	.124	3.91	37.5
ANTENNA SPIRAL			9.6	.106	1.7	.094	3.0	.134	0.00	.124	5.2	50
			606.9								ENR	4206
												6.0



ITEM CALIBER I 10.17. A, C-3118 Sheet 1 of       
 METHOD OF REPAIR: Replace Parts X Subassembly Assembly Unit

REPAIRABLE ITEM	N	A	NA	AVERAGE MAINTENANCE TASK TIMES, HOURS							R <sub>p</sub>	NA R <sub>p</sub>
				LOCAL- IZE	ISOLA- TION	DIS- ASSEM	INTER- CHANGE	RE- ASSEM	ALIGN	CHECK- OUT		
CALIBER DE PARTS	1		85.65	.106	1.7	.094	.125	.034	2.0	.124	4.18	399.8
RELAY	1		.746	.106	1.7	.094	.125	.034	0.00	.124	2.18	1.6
GEAR	4		.944	.116	N/A	N/A	N/A	N/A	N/A	N/A	4	4
COUPLING	1		.54	N/A	N/A	N/A	N/A	N/A	N/A	N/A	4	2
RESISTOR, VAR	9		83.5	.106	1.7	.094	.125	.034	2.0	.124	4.18	767.0
SWITCH SENSITIVE	61		67.1	.106	1.7	2.0	1.0	1.5	2.0	.124	8.43	565.6
SWITCH TOGGLE	1		.68	.106	1.7	.094	.125	.034	0.00	.124	2.18	1.5
TRANSFORMER	2		.0723	.106	1.7	.094	.305	.034	0.00	.124	2.36	.17
RESOLVER	1		55.5	.106	2.5	1.0	.5	1.0	2.0	.124	7.23	401.3
SYNCHRO	2		4.7	.106	2.5	1.0	.5	1.0	2.0	.124	7.23	33.9
CAPACITOR	4		15.2	.106	1.7	.094	.125	.034	2.0	.124	4.18	63.9
DIODE	3		8.4	.106	1.7	.094	.125	.034	2.0	.124	4.18	35.1
FUSE	10		1.0	.106	0.00	0.00	.01	0.00	0.00	0.00	.116	.116
LAMP	17		13.8	.106	0.00	0.00	.01	0.00	0.00	0.00	.116	1.6
CONN COAX	1		1.1	.106	1.7	.094	.125	.034	0.00	.124	2.18	2.2
COIL, RF	1		10.66	.106	1.7	.094	.125	.034	2.0	.124	2.18	.14
			449								5.1	2279
			ENA								ENA	2279

# MAINTAINABILITY ANALYSIS

ITEM AMP-2 FLEX, ANI-1017B

Sheet      of     

METHOD OF REPAIR: Replace-parts X

Subassembly     

Assembly     

Unit     

REPLACABLE ITEM	N	λ	NA	AVERAGE MAINTENANCE TASK TIMES, HOURS							F <sub>p</sub>	NA P <sub>p</sub>
				LOCAL- IZE	ISOLA- TION	DIS- ASSEM	INTER- CHANGE	RE- ASSEM	ALIGN	CHECK- OUT		
AMP-2 PWR SUP. 4 PARTS	1		83.1	.106	1.569	0.5	.125	0.5	2.0	.124	4.9	407.19
DIODE ASSEMBLY A2 & 3 PARTS	2		3.2	.106	1.569	0.5	.081	0.5	2.0	.124	4.87	15.55
DIODE ASSEMBLY A4 PARTS	1		27.36	.106	1.569	1.0	.125	1.0	2.0	.124	5.9	161.42
											5.1	
			ENA 113.7									ENA 584.16

44-38861-353

Sheet of \_\_\_\_\_ of \_\_\_\_\_

METHOD OF REPAIR: replacement parts X

Assembly

Unit

[illegible]



# MAXIMUM-LENGTH ANALYSIS

VLA 3F 67th INDC. 68 (0077)

Sheet of 10

MEMO TO MR. T. W. ARNOLD  
FROM: MR. J. H. HARRIS  
SUBJECT: [REDACTED]

Subassembly

Assembly:

Unit

[illegible]

State: Georgia      Replaces: 100-100000

1

Subassembly

Assembly

Sheet of

Unit

[illegible]

1111-38 KFC HMD

WLA-3B, RF HAND ASSEMBLY  
2A1, RF AMP AM-6845

Sheet \_\_\_\_\_ of \_\_\_\_\_

Assembly

Subassembly

4

RECTOR OF THE UNIVERSITY OF CALIFORNIA

[illegible]



ITEM VLA-36, REWARD ASSESSMENT

STAFF-ROBERT M. ADAMS, JR. COLLEGE

# Assembly

Subassembly: X

198

[illegible]

136

1555

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6

CV 162-100

Sheet / of 2

REPAIR: 351-200-1-arts

Subassembly

## Assembly

+

Unit

[illegible]





RECEIVED  
JAN 21 1964

METHOD OF REPAIR: Re-laport-crete

### Subassembly:

## Assembly

[illegible]

Sheet \_\_\_\_\_ of \_\_\_\_\_  
Unit \_\_\_\_\_

321

**ADDRESS:** NIVATI & COMPANY  
POLICE DEPT.

Subassembly

Assembly

Unit

[illegible]



Frequency Distribution

100

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EVALUATION RESEARCH CORP SAN DIEGO CA  
AVAILABILITY STUDY OF THE AN/WLR-1G AND AN/SLQ-32(V)2 ELECTRONI--ETC(U)  
FEB 79 J VALENZUELA, W EICHELBERGER

F/G 17/4

N66001-78-R-0318

UNCLASSIFIED

NOSC-TR-426

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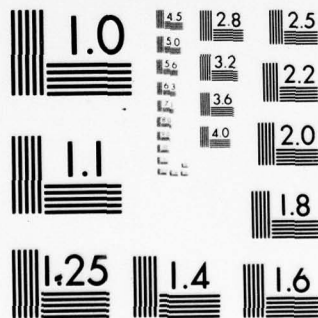
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MICROCOPY RESOLUTION TEST CHART  
NATIONAL BUREAU OF STANDARDS-1963-A



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Assessment:

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FRANK COMPANY CV-742

# METHOD OF REPAIR: Replicate - 3115

x

Sub: assembly

# Assembly

Sheet 1 of 2

2

Unit

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ITEM FBI Collection CV-742

METHOD OF REPAIR: Replugs - Parts

### Subassembly:

Assembly

Unit

Sheet 2 of 2.

[illegible]



with 2 1/2 x 10 1/2 in. 100 lb. 100 lb.

Sheet of

STATE OF NEW YORK

Subsequent to

Assembly

Unit

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22-7-2000

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Assessing

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# MAINTENANCE TASK ANALYSIS

ITEM: ROTARY SWITCH, P1-2156-D

Sheet 1 of 1

METHOD: PRELIMINARY

Subassembly

Assembly

Unit

REPAIRABLE ITEM	N	A	NA	AVERAGE MAINTENANCE TASK TIMES, HOURS							F P	NO P P
				LOCAL- IZE	ICOLA- TION	DIS- ASSEM	INTER- CHANGE	RE- ASSEM	ALIGN	CHECK- OUT		
CAPACITOR (2 COND, 2 SECRETS, 100K)			.12	.089	1.7	.094	.125	.134	.021	.108	2.27	0.13584
FUSE (FRONT PANEL)			0.61	.080	1.7	.094	.01	.134	.021	.108	2.2	1.474
RELAY (2 SECRETS)	4		6.4	.089	1.7	.094	.122	.134	.021	.108	2.2	14.08
CHOKE (4 SECRETS, 2 COND.)			2.64	.089	1.7	.094	.164	.134	.021	.108	2.3	0.6072
METER (15 SECRETS, 2 COND.)			10	.080	1.7	.094	.411	.134	.021	.108	2.6	26.0
RESISTOR FINE (2 COND.)			7.727	.089	1.7	.094	.081	.134	.021	.108	2.2	16.9444
SWITCH, ROTARY			1.7	.089	1.7	.094	.327	.134	.021	.108	2.5	4.25
SWITCH TOGGLE			0.68	.080	1.7	.094	.137	.134	.021	.108	2.3	1.5641
SWITCH P/B			.47	.089	1.7	.094	.137	.134	.021	.108	2.3	1.081
TRANSFORMER	5		.32	.089	1.7	.094	.269	.134	.021	.108	2.4	0.768
TUBE			650	.089	1.7	.094	.615	.134	.021	.108	3.2	1430.0
FAN (BLOWER)			11	.089	1.7	.094	.191	.134	.021	.108	2.3	25.3
CAPACITOR			.032	.089	1.7	.094	.125	.134	.021	.108	2.2	0.0704
RELAY FILTER			.064	.089	1.7	.094	.125	.134	.021	.108	2.3	0.1472
RELAY, THERMAL	1	30	40	.089	1.7	.094	.159	.134	.021	.108	2.3	0.920
RESISTOR, VARIABLE	4		.88	.089	1.7	.094	.445	.134	.021	.108	3.6	2.388
DIODE			16.5	.089	1.7	.094	.125	.134	.021	.108	2.3	37.95
			707.288								2.32	1563.9550

NEW DOV, EK SUPPLY PP2157D

Sheet 1 of 1

REPAIR: 100-100-100 X

Subassembly

Assembly

Unit

PART NAME ITEM	N	A	NA	AVERAGE MAINTENANCE TASK TIMES, HOURS						P P	NA P P	
				LOCAL- IZE	ISOLA- TION	DIS- ASSEM	INTER- CHANGE	RE- ASSEM	ALIGN			CHECK- OUT
CAPACITOR			1.082	.089	1.7	.094	.125	.134	0.021	.108	2.27	2.46
DIODE			27.0	.089	1.7	.094	.125	.134	0.021	.108	2.27	6.29
LAMP			3.0	.089	1.7	.094	.191	.134	0.021	.108	2.3	6.90
SWITCH (P.B.)			0.92	.089	1.7	.094	.137	.134	0.021	.108	2.3	2.116
FUSE			0.6	.089	1.7	.094	.01	.134	0.021	.108	2.2	1.32
RELAY			4.8	.089	1.7	.094	.022	.134	0.021	.108	2.2	10.56
REACTOR (CHOKE)			33	.089	1.7	.094	.169	.134	0.021	.108	2.3	.759
VOLTMETER			10	.089	1.7	.094	.111	.134	0.021	.108	2.6	26
RESISTOR			12.1	.089	1.7	.094	.081	.134	0.021	.108	2.2	26.62
RESISTOR, VARIABLE			132	.089	1.7	.094	.445	.134	0.021	.108	2.6	343
SWITCH, ROTARY			1.7	.089	1.7	.094	.327	.134	0.021	.108	2.5	4.25
SWITCH TOGGLE			1.14	.089	1.7	.094	.137	.134	0.021	.108	2.3	2.6
TRANSFORMER			.38	.089	1.7	.094	.269	.134	0.021	.108	2.4	.91
TUBE			1136	.089	1.7	.094	.015	.134	0.021	.108	2.2	2499
MOTOR			11	.089	1.7	.094	.191	.134	0.021	.108	2.3	25.3
CAPACITOR			128	.089	1.7	.094	.125	.134	0.021	.108	2.27	29
			1342									
		END	1342								END	3013



Sheet 1 of 1  
Unit

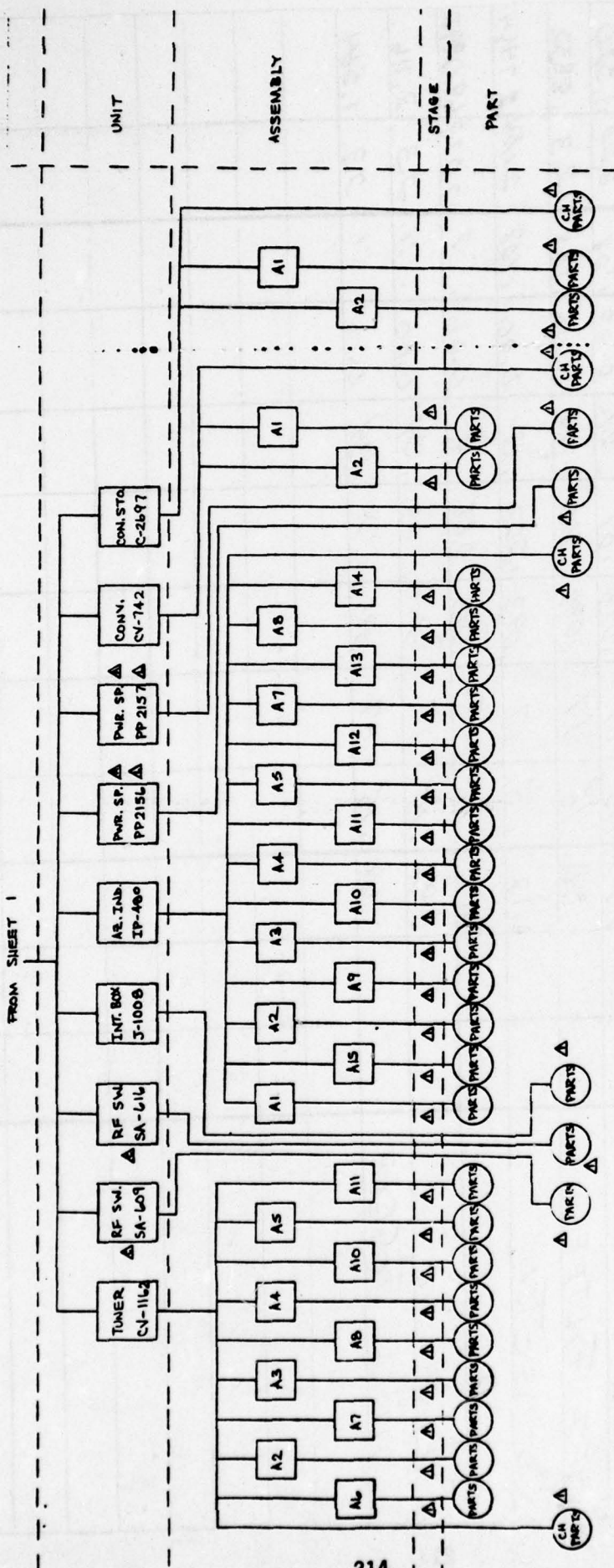
Assembly

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FROM SHEET 1



# LEGEND :

- △ LOCALIZATION PTS.
- △ ISOLATION PTS.
- △ ALIGNMENT PTS.
- △ CHECKOUT PTS.

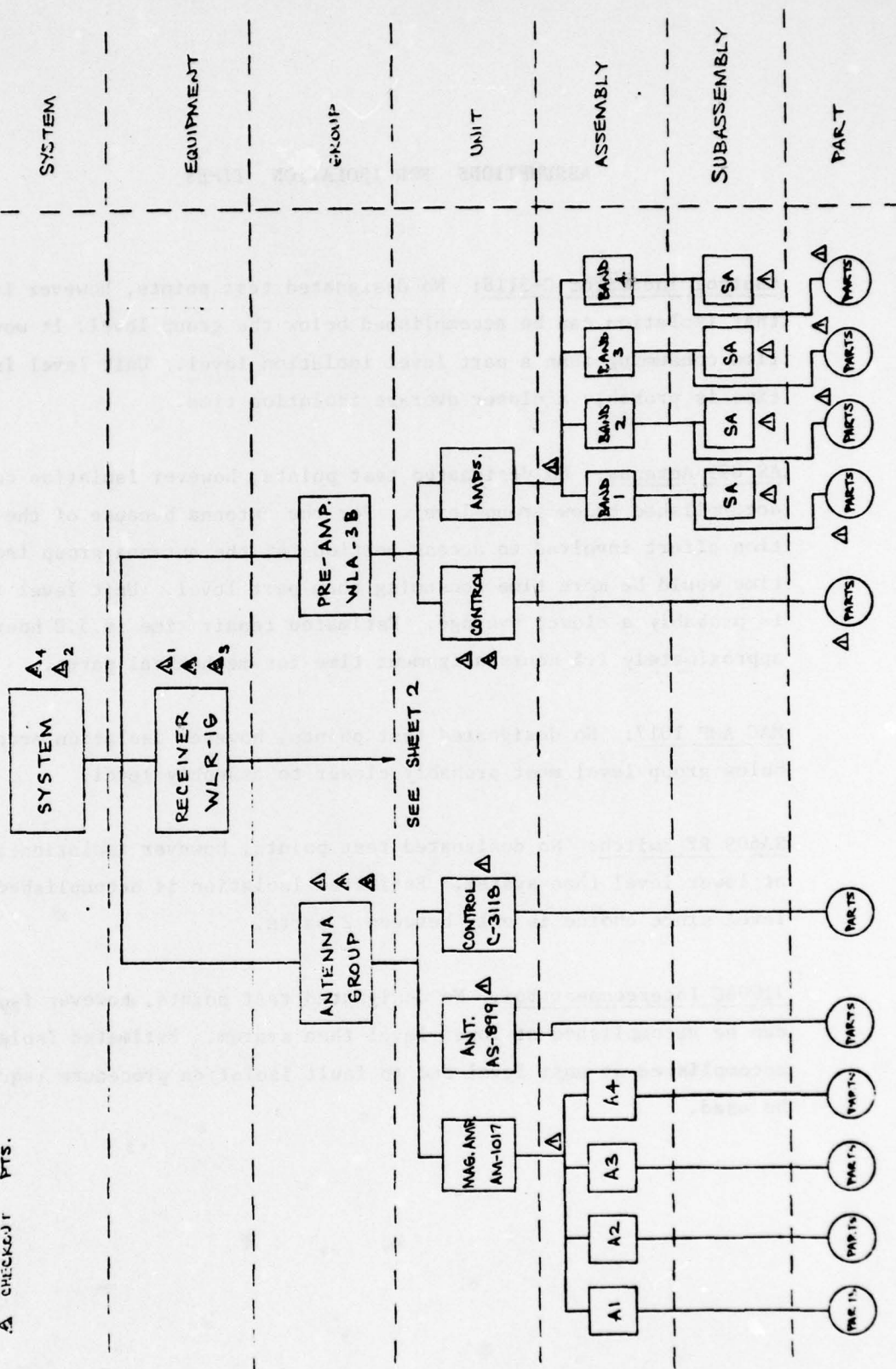
# NOTES :

1. CV-1162, IP-400, CV-742, C-2697 ARE LOCALIZED TO THE EQUIPMENT LEVEL.
2. SA-609, SA-616, J1008 ARE LOCALIZED TO THE SYSTEM LEVEL.
3. J1008, IP-400, PP-215L, PP-2157, CV-742, C-2697 ARE CHECKED OUT AT THE EQUIPMENT LEVEL.
4. CV-1162 IS CHECKED OUT AT THE SYSTEM LEVEL.

## FUNCTIONAL LEVELS

...

- 4 LOCALIZATION PTS.  
 4 ISOLATION PTS.  
 4 ALIGNMENT PTS.  
 4 CHECKOUT PTS.



## ASSUMPTIONS FOR ISOLATION TIMES

Control Indicator C-3118: No designated test points, however it is felt that isolation can be accomplished below the group level. It would be more time consuming than a part level isolation level. Unit level isolation time is probably a closer average isolation time.

AS 899 Antenna: No designated test points, however isolation can be accomplished below group level. For the antenna because of the coordination effort involved to access portions of the antenna group isolation time would be more time consuming than part level. Unit level isolation is probably a closer average. Estimated repair time is 5.0 hours and approximately 1.5 hours alignment time for mechanical parts.

MAG AMP 1017: No designated test points, however isolation accomplished below group level most probably closer to assembly level.

SA609 RF Switch: No designated test points, however isolation accomplished at lower level than system. Estimated isolation is accomplished at part level since choice is only between 2 parts.

J1008C Interconnect Box: No designated test points, however isolation can be accomplished at lower level than system. Estimated isolation is accomplished at unit level due to fault isolation procedure required to be used.



# ESTIMATED INTERCHANGE TIMES

<u>COMPONENT</u>	<u>DETAILED STEP</u>	<u>ELEMENT TIME</u>	<u>TIMES PERFORMED</u>	<u>INTERCHANGE TIME (HRS.)</u>
CONTROL STORER MAGNETIC CLUTCH, PRECISION VARIABLE RESISTOR	Remove A3 assembly		)	
	Remove coupling		)	
	Remove cable clamp		)	
	Unsolder wires		)	
	Remove clutch from pot shaft		)	2.5 est.
	Solder wires		)	
	Fasten coupling		)	
	Fasten cable clamp		)	
	Re-install A3 assembly		)	
CONTROL STORER GEAR COUPLING, bearing	Remove A3 assembly			2.5
	Disassemble gear train			
	Remove gear			
	Instakk gear			
	Ressemble gear train			1.0 hrs. est.
	Re-install A3			

# ESTIMATED INTERCHANGE TIMES (cont.)

<u>COMPONENT</u>	<u>DETAILED STEP</u>	<u>ELEMENT TIME</u>	<u>TIMES PERFORMED</u>	<u>INTERCHANGE TIME (HRS)</u>
RFSWITCH RELAY				
				1.0 total estimated
RACK CONVERTER	Unsoldered wire	.0058	20	.116
	Remove screws	.0093	2	.0186
	Install screws	.0093	2	.0186
	Solder wire	.0058	20	.116
				.2692
ROTARY SWITCH	Unsolder 17 wires	.0058	17	.0986
	Remove 7 screws	.0093	7	.0651
	Solder wires	.0058	17	.0986
	Install screws	.0093	7	.0651
				.3274
TRANSFORMER	Unsolder wires	.0058	12	.0696
	Remove screws	.0093	4	.0651
	Solder wires	.0058	12	.0696
	Replace screws	.0093	4	.0651
CONTROL STORER LAMPS	Remove A4 assembly			.2694
	Disassemble / Re-assemble A4			
				1.0 hrs. est.

# ESTIMATED INTERCHANGE TIMES (cont.)

<u>COMPONENT</u>	<u>DETAILED STEP</u>	<u>ELEMENT TIME</u>	<u>TIMES PERFORMED</u>	<u>INTERCHANGE TIME (HRS.)</u>
CONTROL STORER ROTARY SWITCH	Remove switch	.25 estimated		.25
	Unsolder wires	.10 estimated total		.10
	Solder wires	.20 estimated total		.20
	Re-install switch	.35 estimated		.35
				0.9
CONTROL STORER TOGGLE SWITCH	Remove switch	.5 estimated		.5
	Unsolder wires	.01 estimated total		.01
	Solder wires	.01 estimated total		.01
	Re-install switch	.50 estimated		.50
				1.02
CONTROL STORER	Remove A4		)	
	Disassemble A4		)	
	Unsolder wires		)	2.0 hrs. est.
	Remove switch		)	
	Install switch		)	
	Solder wires		)	
	Reassemble A4		)	
	Re-install A4		)	
				2.0



# ESTIMATED ACCESS TIMES FOR UNIQUE COMPONENTS

AN/WLA-3B

Mast Mounted

Coordinate s/down of equip.=1-2 hrs.=1.5 hr.

Coordinate turn-on= 1.0 hr.

AMPLIFIER SECTION MAST MOUNTED ACCESS 1 hr.

Access, cut potting, pull amp, = 1 hr.

Easy to isolate, very often run out of TWA's

Check out- minimum

Install pannels & pot connector=1.5 hr.

CONTROL INDICATOR In CIC space (below), everything easy to access  
and fault isolate = total 1 hr.

lamps outside.

CONTROL IND. C3118

Micro switch are most difficult to access, time 2.0 hrs.

Total time may be 4 hrs.

Pull front pannel & other parts.

RESOLVERS

Long time to isolate x 1hr.-3hrs. for loose  
conn.

Alignment time= 1.5 to 2.0 hrs.

Front pannel difficult to isolate

XFMR difficult to isolate

MAG AMP

Low knowledge of theory of op.

1A1 faults long time to isolate 2-4 hrs.

Access time for back parts blower &  
coils take long time=1hr.

Other near parts=.5 hr.



## ESTIMATED ALIGNMENT TIMES

### AZIMUTH INDICATOR, IP-480

15min equip. warm-up.

<u>Time</u> <u>min.</u>	A. 0-5 Microsec sweep
5min.	1) Connect pulse Gen.
3min.	2) Adjust intensity, focus, position and sync level.
1	3) Adjust 0-5 trigger A3R16 for stable pulse.
3	4) If required, adjust sync range by adjusting gain, sync range sync level for max noise deflection.
1	5) Adjust A4R11 for base line sweep position
3	6) Adjust A3R20 for 6 pulses.
3	7) Adjust A3R16, 30 for 6 pulses if required.
6	8) Adjust A3R38, 50 for observation @ begin & end of sweep.
2	9) Adjust A3R20 for 6th pulse @ leading edge.
3	10) Adjust R16
3	11) Adjust R20
3	12) Adjust R30
5	13) Repeat Adjusting of R20, 16, 30, 38, 50.
3	14) Adjust R50
3	15) Adjust 38
3	16) Adjust C14
3	17) Adjust R20
<u>3</u>	
53min.	



AZIMUTH INDICATOR, IP-480 (cont.)

Time  
min.

B. 5-400 Microsec Sweep

- 1) Make adjustment A. first
- 2) Approximately 70% complexity of Adjustment A.

37

C. .5 K to 50 K Microsec Sweep

- 1) Make adjustment A.
- 2) Make adjustment B.
- 3) Approximately 50% complexity of Adjustment B.

20

D. Sync Range

3 See step 4 Adj A.

E. Pan Display

30 see adj. A of Swept Oscill, CV742 Adjustments

F. Scan display alignment ⇒ used only when V2 is replaced

60 Approximately same complexity as Adj. A.

F.F. Scan Display align, minor adjustment

40 approximately 70% complexity adj. F

G. DF display alignment

- 1) Adj. sync range first
- 2) 11 scan display first
- 3) Approximately 40% complexity of F Adj.

25

## FREQUENCY CONVERTER CV742

Equ. 15 min. - Equipment warm-up

### 160 MHZ IF

Time  
min.

- |                 |  |
|-----------------|--|
| 15              | 1) Connect Sig Gen, Test Coupler, UOM                              |
| 15              | 2) Adjust Gain control knob for VOM Indication                     |
| 6               | 3) Adjust L9, 18, 76 for max deflection @ 160 MHZ                  |
| 6               | 4) Adjust 5, 15, 12 for max deflection @ 148 MHZ                   |
| 6               | 5) Adjust 3, 2, 19 for max deflection @ 172 MHZ                    |
| 9               | 6) Repeat steps 3, 4, 5 for refinement.                            |
| 10              | 7) Record & plot on graph paper 10 frequency Vs Amp P. data points |
| $\frac{15}{82}$ | 8) Re-adjust L9, 18, 26 to obtain flat response if required        |
| $\frac{10}{92}$ | 9) Disconnect equipment  |

### Isolation Amp

- |                |   |
|----------------|---|
| 15             | 1) Similar to 1 above                       |
| 15             | 2) Similar to 2 above                       |
| $\frac{5}{35}$ | 3) Adjust L2 for lowest dip resonance point |

### 39 MHZ IF - Narrow band

- |                 |                                    |
|-----------------|------------------------------------|
| 15              | 1) Remove tube                     |
| 15              | 2) Similar to 1) above             |
| 15              | 3) Similar to 2) above             |
| 5               | 4) Adjust T1 & T2 for min. reading |
| $\frac{35}{35}$ | 5) Replace tube                    |

### Fix Oscill.

- |                 |                                  |
|-----------------|----------------------------------|
|                 | 1) same as 2) above              |
|                 | 2) same as 2) above              |
| $\frac{35}{35}$ | 3) Adjust L17 for min deflection |

# Swept Oscill.

## A. Align Panoramic Display (unit 12)

Time  
min.

- 15 1) Set switch positions - 5
- 15 2) Remove cover on Unit 10 & 11
- 15 3) Connect scope to Unit 10
- 15 4) Select band with shortest sweep
- 6 5) Adjust R3, R7 for proper pan sweep
- 6 6) Adjust R13, R7, R37, for centered and intensity sweep
- $\frac{3}{45}$  7) Adjust R22/R18 on either unit 10/11 for pan sweep

## B. Oscill. Align.

- 3 1) Connect Sig. Gen., Test Coupler, VOM
- 3 2) Adjust gain
- 3 3) Remove tube
- 3 4) Adjust L5 for min deflection @ 160 MHz
- 3 5) Adjust R25 for max deflection @ 150 MHz
- 3 6) " " " " " " 170 "
- 3 7) " L13, 14, 15 for max deflection @ 170 MHz
- 5 8) Repeat steps 5, 6, 7, for refinement
- 3 9) Adjust R25 for max deflection @ 160 MHz
- 3 10) Adjust R26 " " " " " "
- 11) Replace tube
- 2 12) Adjust gain control for pan display
- 3 13) " R25 " " "
- 3 14) " R33 " " " @ 150 MHz
- 3 15) " L5 " " "  $\leq 150$  "



Time Swept Oscill.  
min.

- 3 16) Adjust R25 for pan display @ 160 MHz
- 3 17) " R33 " " " " 170 "
- 3 18) " R26 " " " " centered
- 3 19) " R29 " " " " left @ 155 MHz
- 3 20) " R26, 29 for pan display " right  $\leq$  165 MHz
- 3 21) Tighten 4 lock nuts, disconnect equipment

$\frac{10}{65}$  DISCONNECT EQUIPMENT

2 min. min - Test equipment access time

to

20 min. max.

CONTROL STORER, C-2697

- 1) Tighten & loosen appropriate gear set screws
  - 2) Align pot rotation
  - 3) Hold pot alignments and mesh gear train at stop
- 1.0 hr.
- 4) Secure gear set screws
  - 5) Index control knob to proper position
  - 6) Check mechanical interlock adjustment

Magnetic Clutches & Pots

- 1) Remove friction busing set screws
  - 2) Adjust manual tune control
- .5 hr.
- 3) Adjust friction drag by adjusting set screws
  - 4) Repeat adjustment until pot shaft responds correctly to associated select P/B.

Tuner Servo Alignment

- 1) Connect Sig. Gen. and Oscilloscope
  - 2) Adjust Servo gain by adjusting R32, 44, 46
  - 3) " Pos. control by adjusting R34, R44
- .75 hr.
- 4) " R32 & R44 to minimize jitter
  - 5) Repeat to achieve max. gain with min. jitter
  - 6) Connect sig. gen. to Unit 8
  - 7) Adjust Unit 8 input controls
  - 8) Adjust gain pot R32 & R44 to obtain correct signal bloom display on panoramic display

CONTROL STORER, C-2697 (cont.)

Scan Gain Adjustment

- 1) Set G pots to CCW position - major align.
- 0.25 hr(mm) 2) Rotate band selector and determine which band has highest noise level - major align.
- 0.45 hr (major) 3) Adjust Gain for optimum noise display
- 4) Adjust scan gain pots to obtain optimum noise display on each band.

CV 1162 ALIGNMENT

PRE-SEL

- 1) Adjust all cam eccentrics to be parallel to plate
- 10 min. 2) Conn. multimeter sig. gen.
- to 3) Disconn. Antenna
- 15 min. 4) Cal. sign. gen for frequency using wavemeter @ Ant. Input
- 5) Adjust each eccentric for proper frequency
- $\frac{3 \text{ min.} \times 9}{40 \text{ min.}}$
- 6) Conn Sweep Gen to Ant. Input
- 7) Conn. Crystal Det.
- 10 min to 8) Conn video out to scope
- 15 min. 9) Set cam eccentric to lowest position
- 10) Set eccentric for symmetric band pass
- $\frac{3 \text{ min.} \times 9}{40 \text{ min}}$
- $\frac{5 \text{ min}}{85 \text{ min}}$  Disconn Test equip.
- $\frac{20 \text{ min}}{105 \text{ min}}$  Test Equipment warm up



### PRE-AMP ALIGNMENT

- 1) Rotate tuning slug fully CCW
- 2) Connect Radio test set AN/TRM-3 (1 cable)
- 3) Calibrate to 20 MHz
- 10 min. 4) Loosen lock screw on Resonator & adjust to Sync  
for 240 MHz marker.
- 5) Adjust tuning slug for min-amplitude
- 6) Connect fixed atten., Detector and dummy load
- 7) Set sig. Gen to 400 MHz
- 8) Adjust C1, 1, 10, 16, L7, L10, L20, Ti, T2, T3 for max. amplitude
- 9) Adjust C17 for center frequency
- 30 min. 10) Adjust C16 for peak @ 40 MHz
- 11) Adjust T3, L20 for peak @ 390 "  
" T2, L20 " " @ 410 "
- 12) " L10 for flat response
- 13) Trim up all adjustments
- 5 min. 15) Discount all equipment
- 20 min. Equipment warm-up

## ESTIMATED ALIGNMENT TIMES FOR ANTENNA GROUP COMPONENTS

### A. SYNCHRO COUPLING

- 5min. (1) Set synchro shaft.
- 5min. (2) Set synchro coupling.
- 10min. (3) Install synchro and align with datum points.
- 20min.

### B. SYNCHRO ALIGNMENT

- 5min. (1) Loosen 6 screws on mounting clamp.
- 2min. (2) Align reflector to bench marks and arrow.
- 5min. (3) Rotate synchro for 0 movement.
- 5min. (4) Secure synchro.
- 17min.

### C. AM-1017B/SLR ALIGNMENT

- 1min. (1) Set gain pot. on magnetic amplifier CCW.
- 1min. (2) Set control indicator selector switches.
- 5min. (3) Energize control indicator and measure voltages at TP2.
- 3min. (4) Adjust mag. amp. R15 for minimum voltage reading.
- 3min. (5) Adjust mag. amp. R15 for minimum voltage reading.
- 5min. (6) Repeat 4) & 5) for balance reading less than 1.0V.
- 5min. (7) Adjust mag. amp. pot. R1 for maximum voltage reading.
- 5min. (8) Adjust Control Ind. error pot for proper antenna rotation overshoot.
- 5min. (9) Repeat 1-8 if required to achieve proper overshoot.
- 33min.

ESTIMATED ALIGNMENT TIMES FOR ANTENNA GROUP COMPONENTS (cont.)

D. BELT TENSION ADJUSTMENT

15min. (1) Increase tension for maximum rotation by moving  
MP1225.



In addition to corrective maintenance, the technician will also perform preventive maintenance (PMS) when such actions are scheduled. A summary of the recommended PMS checks in the technical manual are listed below. Those specified on the maintenance index page (MIP) are shown together with the maintenance time. A summation of the indicated MIP maintenance times over a one year period totals 137.8 hours.

#### PMS

##### DAILY

- WLR - Check power supply voltage using built in meters
- Check oscillator current on all tuners using oscillator inject meter
- Check grass levels on all tuners using IP-480 pan trace
- Check audio output from IP-480
- AM-1017B - Measure maximum antenna speed
- Check antenna response and drift

##### WEEKLY

- WLR-1 - Check power supply voltages
- Check C-2697 storage channels
- Check calibration of IP-480 sweeps
- Measure AC input line voltage

##### MONTHLY

- WLR-1 - Clean air filters (MIP, 1.0 hr.)
- Test CV-741 and CV-742 converters (MIP, 3.5 hr.)
- Test tuners for sensitivity and frequency accuracy (MIP, 6.4 hr.)
- C-3118 - Test operation
- Check antenna alignment
- AM-1017B - Clean filter and inspect
- Measure input and output signal levels
- WLA-3B - Clean and inspect
- Operational check, measure small signal gain for each band

QUARTERLY

WLR-1 - Clean and inspect (MIP, 1.5 hr.)

- Check RF-89, FM discriminator

AS-899 - Test Antenna operation

SEMI-ANNUALLY

WLR-1 - Lubricate tuners and Control Storer. (MIP, 0.5 hr.)

- Check RF switch insertion losses

AS-899 - Lube and inspect

ANNUALLY

AS-899 - VSWR Tests

General Purpose Test Equipment For the WLR-1C

<u>CATEGORY</u>	<u>RECOMMENDED EQUIPMENT</u>
Multimeter	AN/PSM-4
Electronic Multimeter	AN/USM-116
Differential Voltmeter (DC VTVM)	CCUH-825A
Signal Generator	AN/URM-26B
	AN/URM-49A
	AN/URM-62A
	AN/URM-61A
	AN/URM-52A
	CAQI-620A
Sweep Generator	AN/TRM-3
Oscilloscope	AN/USM-140 or
	AN/USM-105A
Test Coupler (Part of MK-442D/ WLR-1) (Unit 30)	30A2
Power Meter	AN/USM-177
Frequency Meter	CAQI-536A
	CAQI-537A
Multimeters	AN/USM-34
	ME-6( )/U
Oscilloscope	AN/USM-24
Signal Generator	AN/USM-27
Radio Test Set	TS-907/ULR
Pulse Generator	HP-214A
X-Y, Recorder	Moseley H01-135C
Sweep Generator	Alfred 650
Sweep Generator Tuning Unit	Alfred 651
Sweep Generator Tuning Unit	Alfred 652
Sweep Generator Tuning Unit	Alfred 653
Sweep Generator Tuning Unit	Alfred 654



## APPENDIX D

### AVAILABILITY MATH MODELS

### Inherent Availability Model

The availability math model used to compute the inherent availability for the AN/WLR-1G is given by,

$$A_i = \frac{\mu_i + [\lambda_i e^{-t(\mu_i + \lambda_i)}]}{\mu_i + \lambda_i}$$

$$A_s = \prod_{i=1}^N A_i \cdot A_{5,6} \quad \text{for } N = 1, 2, 3, 4, 7 - 14$$

where:  $A_i$  = Availability of the  $i$ th block

$A_s$  = System Inherent Availability

$\lambda_i$  = Failures/ $10^6$  hours for  $i$ th block

$\mu_i$  = 1/MTTR of  $i$ th block

$t$  = Time in hours

For the redundant blocks 5, 6

$$\mu_{5,6} = \mu_5 = \mu_6 = \frac{1}{5.0 \text{ hours}}$$

and by use of equations 3-3 and 3-4,

$$\int_0^{\infty} R_{5,6}(t) dt = \int_0^{\infty} [e^{-\lambda_5 t} + e^{-\lambda_6 t} - e^{-(\lambda_5 + \lambda_6)t}] dt \quad [3-3]$$

$$MTBF_{5,6} = \frac{1}{\lambda_5} + \frac{1}{\lambda_6} - \frac{1}{\lambda_5 + \lambda_6} \quad [3-4]$$

the availability of blocks 5,6 is given by,

$$A_{5,6} = \frac{\mu_{5,6} + \frac{1}{MTBF_{5,6}} [e^{-at} + e^{-bt} - e^{-ct}]}{\mu_{5,6} + \frac{1}{MTBF_{5,6}}}$$

where:  $a = \lambda_5 + \mu_5$

$b = \lambda_6 + \mu_6$

$c = \lambda_5 + \lambda_6 + \mu_5 + \mu_6$

### Operational Availability Model

The availability math model used to compute the operational availability for the AN/WLR-1G is given by,

$$A_i = \frac{\mu_i + [\lambda_i e^{-t(\mu_i + \lambda_i)}]}{\mu_i + \lambda_i}$$

$$A_o = \prod_{i=1}^N A_i$$

where:  $A_i$  = Availability of  $i$ th block

$A_o$  = System Operational Availability

$\lambda_i$  = Failures/ $10^6$  hours for  $i$ th block

$\mu_i$  = 1/MDT of  $i$ th block

$t$  = 8760 hours

Operational Availability was computed only for an 8760 hour period since the logistics delay is derived as an average over 1 year. The values of  $\lambda_i$  and  $\mu_i$  are all taken directly from Tables 3-8, 3-9, 3-10 and 3-11 for the respective modes of operation. No redundancy equations are required for blocks 5 and 6 since the model is for total mode required to be in an up condition.



### Inherent Availability Model

The availability math model used to compute the inherent availability for the AN/SLQ-32(V)2 is given by,

$$A_i = \frac{\mu_i + [\lambda_i e^{-t(\mu_i + \lambda_i)}]}{\mu_i + \lambda_i}$$

$$A_s = \prod_{i=1}^N A_i$$

where:  $A_i$  = Availability of the  $i$ th block

$A_s$  = System Inherent Availability

$\lambda_i$  = Failures/ $10^6$  hours for  $i$ th block

$\mu_i$  = 1/MTTR of  $i$ th block

$t$  = Time in hours

For the blocks A, B, C and D,  $\lambda_i$  is determined by the equations,

$$\lambda_i = \frac{1}{\int_0^{\infty} R_i(t) dt} \quad \text{for } i = A, B, C, D$$

$$\text{where: } R_i(t) = \sum_{j=k}^m \binom{m}{k} P(t)^k [k - P(t)]^{m-k}$$

$$P(t) = e^{-\lambda_i t}$$

$k$  out of  $m$  are required

The values for  $\lambda$  and MTTR are taken from Tables 4-9, 10, 11 and 12 for the respective modes of operation.

### Operational Availability Model

The availability math model used to compute the operational availability for the SLQ-32(V)2 is given by,

$$A_i = \frac{\mu_i + [\lambda_i e^{-t(\mu_i + \lambda_i)}]}{\mu_i + \lambda_i}$$

$$A_o = \prod_{i=1}^N A_i$$

where:  $A_i$  = Availability of  $i$ th block

$A_o$  = System Operational Availability

$\lambda_i$  = Failures/ $10^6$  hours for  $i$ th block

$\mu_i$  = 1/MDT of  $i$ th block

$t$  = 8760 hours

Operational Availability was computed only for an 8760 hour period since the logistics delay was assumed to be the same as for the AN/WLR-1G. The values of MTTR and  $\lambda$  are taken directly from Tables 4- , 4- , 4- and 4- . For the blocks A, B, C and D, the value of  $\lambda$  is given by,

$$\lambda_n = (F/10^6 \text{ hours})(\text{total parallel paths})(\text{Qty used})$$

for  $n = A, B, C, D$

The failure rates given in the tables are for one of each parallel path so that, for example, the total failure rate of block A (considering no redundancy) is,

$$\lambda_A = (1.183)(38)(4) = 179.8 \text{ f}/10^6 \text{ hours}$$